

## **Spartan-II 2.5V FPGA Family:** Complete Data Sheet

DS001 September 3, 2003

**Product Specification** 

This document includes all four modules of the Spartan™-II FPGA data sheet.

## Module 1: Introduction and Ordering Information

DS001-1 (v2.4) September 3, 2003 6 pages

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IMPORTANT NOTE: The Spartan-II 2.5V FPGA data sheet is created and published in separate modules. This complete version is provided for easy downloading and searching of the complete document. Page, figure, and table numbers begin at 1 for each module, and each module has its own Revision History at the end. Use the PDF "Bookmarks" for easy navigation in this volume.

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**Spartan-II 2.5V FPGA Family: Introduction and Ordering Information** 

DS001-1 (v2.4) September 3, 2003

**Product Specification** 

### Introduction

The Spartan™-II 2.5V Field-Programmable Gate Array family gives users high performance, abundant logic resources, and a rich feature set, all at an exceptionally low price. The six-member family offers densities ranging from 15,000 to 200,000 system gates, as shown in Table 1. System performance is supported up to 200 MHz.

Spartan-II devices deliver more gates, I/Os, and features per dollar than other FPGAs by combining advanced process technology with a streamlined Virtex-based architecture. Features include block RAM (to 56K bits), distributed RAM (to 75,264 bits), 16 selectable I/O standards, and four DLLs. Fast, predictable interconnect means that successive design iterations continue to meet timing requirements.

The Spartan-II family is a superior alternative to mask-programmed ASICs. The FPGA avoids the initial cost, lengthy development cycles, and inherent risk of conventional ASICs. Also, FPGA programmability permits design upgrades in the field with no hardware replacement necessary (impossible with ASICs).

#### **Features**

- Second generation ASIC replacement technology
  - Densities as high as 5,292 logic cells with up to 200,000 system gates
  - Streamlined features based on Virtex architecture
  - Unlimited reprogrammability
  - Very low cost

- System level features
  - SelectRAM+™ hierarchical memory:
    - 16 bits/LUT distributed RAM
    - Configurable 4K bit block RAM
    - Fast interfaces to external RAM
  - Fully PCI compliant
  - Low-power segmented routing architecture
  - Full readback ability for verification/observability
  - Dedicated carry logic for high-speed arithmetic
  - Dedicated multiplier support
  - Cascade chain for wide-input functions
  - Abundant registers/latches with enable, set, reset
  - Four dedicated DLLs for advanced clock control
  - Four primary low-skew global clock distribution nets
  - IEEE 1149.1 compatible boundary scan logic
- Versatile I/O and packaging
  - Low cost packages available in all densities
  - Family footprint compatibility in common packages
  - 16 high-performance interface standards
  - Hot swap Compact PCI friendly
  - Zero hold time simplifies system timing
- Fully supported by powerful Xilinx development system
  - Foundation ISE Series: Fully integrated software
  - Alliance Series: For use with third-party tools
  - Fully automatic mapping, placement, and routing

Table 1: Spartan-II FPGA Family Members

Device	Logic Cells	System Gates (Logic and RAM)	CLB Array (R x C)	Total CLBs	Maximum Available User I/O <sup>(1)</sup>	Total Distributed RAM Bits	Total Block RAM Bits
XC2S15	432	15,000	8 x 12	96	86	6,144	16K
XC2S30	972	30,000	12 x 18	216	132	13,824	24K
XC2S50	1,728	50,000	16 x 24	384	176	24,576	32K
XC2S100	2,700	100,000	20 x 30	600	196	38,400	40K
XC2S150	3,888	150,000	24 x 36	864	260	55,296	48K
XC2S200	5,292	200,000	28 x 42	1,176	284	75,264	56K

All user I/O counts do not include the four global clock/user input pins. See details in Table 3, page 3.

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#### **General Overview**

The Spartan-II family of FPGAs have a regular, flexible, programmable architecture of Configurable Logic Blocks (CLBs), surrounded by a perimeter of programmable Input/Output Blocks (IOBs). There are four Delay-Locked Loops (DLLs), one at each corner of the die. Two columns of block RAM lie on opposite sides of the die, between the CLBs and the IOB columns. These functional elements are interconnected by a powerful hierarchy of versatile routing channels (see Figure 1).

Spartan-II FPGAs are customized by loading configuration data into internal static memory cells. Unlimited reprogramming cycles are possible with this approach. Stored values in these cells determine logic functions and interconnections implemented in the FPGA. Configuration data can be read from an external serial PROM (master serial mode), or written into the FPGA in slave serial, slave parallel, or Boundary Scan modes.

Spartan-II FPGAs are typically used in high-volume applications where the versatility of a fast programmable solution adds benefits. Spartan-II FPGAs are ideal for shortening product development cycles while offering a cost-effective solution for high volume production.

Spartan-II FPGAs achieve high-performance, low-cost operation through advanced architecture and semiconductor technology. Spartan-II devices provide system clock rates up to 200 MHz. Spartan-II FPGAs offer the most cost-effective solution while maintaining leading edge performance. In addition to the conventional benefits of high-volume programmable logic solutions, Spartan-II FPGAs also offer on-chip synchronous single-port and dual-port RAM (block and distributed form), DLL clock drivers, programmable set and reset on all flip-flops, fast carry logic, and many other features.

The Xilinx XC17S00A PROM family is recommended for serial configuration of Spartan-II FPGAs. The In-System Programmable (ISP) XC18V00 PROM family is recommended for parallel or serial configuration.

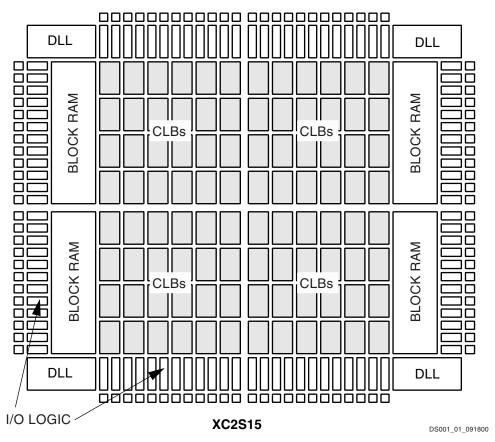


Figure 1: Basic Spartan-II Family FPGA Block Diagram

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## **Spartan-II Product Availability**

Table 2 shows the package and speed grades available for Spartan-II family devices. Table 3 shows the maximum user I/Os available on the device and the number of user I/Os available for each device/package combination. The four

global clock pins are usable as additional user I/Os when not used as a global clock pin. These pins are not included in user I/O counts.

Table 2: Spartan-II Package and Speed Grade Availability

	Pins	100	144	144	208	256	456
	Туре	Plastic VQFP	Plastic TQFP	Chip Scale BGA	Plastic PQFP	Fine Pitch BGA	Fine Pitch BGA
Device	Code	VQ100	TQ144	CS144	PQ208	FG256	FG456
XC2S15	-5	C, I	C, I	C, I	-	-	-
	-6	С	С	С	-	-	-
XC2S30	-5	C, I	C, I	C, I	C, I	-	-
	-6	С	С	С	С	-	-
XC2S50	-5	-	C, I	-	C, I	C, I	-
	-6	-	С	-	С	С	-
XC2S100	-5	-	C, I	-	C, I	C, I	C, I
	-6	-	С	-	С	С	С
XC2S150	-5	-	-	-	C, I	C, I	C, I
	-6	-	-	-	С	С	С
XC2S200	-5	-	-	-	C, I	C, I	C, I
	-6	-	-	-	С	С	С

#### Notes:

Table 3: Spartan-II User I/O Chart(1)

	Maximum	Available User I/O According to Package Type					
Device	User I/O	VQ100	TQ144	CS144	PQ208	FG256	FG456
XC2S15	86	60	86	86	-	-	-
XC2S30	132	60	92	92	132	-	-
XC2S50	176	-	92	-	140	176	-
XC2S100	196	-	92	-	140	176	196
XC2S150	260	-	-	-	140	176	260
XC2S200	284	-	-	-	140	176	284

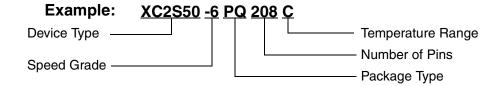
#### Notes:

1. All user I/O counts do not include the four global clock/user input pins.

<sup>1.</sup>  $C = Commercial, T_J = 0^{\circ} to +85^{\circ}C; I = Industrial, T_J = -40^{\circ}C to +100^{\circ}C.$ 



## **Ordering Information**



## **Device Ordering Options**

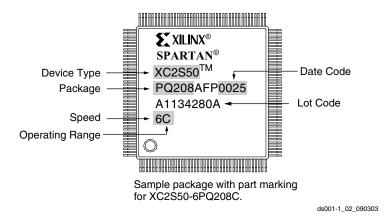
Device		
XC2S15	-5	Ś
XC2S30	-6	ŀ
XC2S50		
XC2S100		
XC2S150		
XC2S200		

	Speed Grade				
-5	Standard Performance				
-6 Higher Performance					

Num	Number of Pins / Package Type					
VQ100	100-pin Plastic Very Thin QFP					
CS144	144-ball Chip-Scale BGA					
TQ144	144-pin Plastic Thin QFP					
PQ208	208-pin Plastic QFP					
FG256	256-ball Fine Pitch BGA					
FG456	456-ball Fine Pitch BGA					

Temperature Range (T <sub>J</sub> )				
C = Commercial	0°C to +85°C			
I = Industrial	-40°C to +100°C			

## **Device Part Marking**



## **Revision History**

Date	Version No.	Description
09/18/00	2.0	Sectioned the Spartan-II Family data sheet into four modules. Added industrial temperature range information.
10/31/00	2.1	Removed Power down feature.
03/05/01	2.2	Added statement on PROMs.
11/01/01	2.3	Updated Product Availability chart. Minor text edits.
09/03/03	2.4	Added device part marking.



## The Spartan-II Family Data Sheet

DS001-1, Spartan-II 2.5V FPGA Family: Introduction and Ordering Information (Module 1)

DS001-2, Spartan-II 2.5V FPGA Family: Functional Description (Module 2)

DS001-3, Spartan-II 2.5V FPGA Family: DC and Switching Characteristics (Module 3)

DS001-4, Spartan-II 2.5V FPGA Family: Pinout Tables (Module 4)





DS001-2 (v2.2) September 3, 2003

# **Spartan-II 2.5V FPGA Family: Functional Description**

#### **Product Specification**

## **Architectural Description**

## **Spartan-II Array**

The Spartan-II user-programmable gate array, shown in Figure 1, is composed of five major configurable elements:

- IOBs provide the interface between the package pins and the internal logic
- CLBs provide the functional elements for constructing most logic
- Dedicated block RAM memories of 4096 bits each
- Clock DLLs for clock-distribution delay compensation and clock domain control
- Versatile multi-level interconnect structure

As can be seen in Figure 1, the CLBs form the central logic structure with easy access to all support and routing structures. The IOBs are located around all the logic and memory elements for easy and quick routing of signals on and off the chip.

Values stored in static memory cells control all the configurable logic elements and interconnect resources. These values load into the memory cells on power-up, and can reload if necessary to change the function of the device.

Each of these elements will be discussed in detail in the following sections.

#### Input/Output Block

The Spartan-II IOB, as seen in Figure 1, features inputs and outputs that support a wide variety of I/O signaling standards. These high-speed inputs and outputs are capable of supporting various state of the art memory and bus interfaces. Table 1 lists several of the standards which are supported along with the required reference, output and termination voltages needed to meet the standard.

The three IOB registers function either as edge-triggered D-type flip-flops or as level-sensitive latches. Each IOB has a clock signal (CLK) shared by the three registers and independent Clock Enable (CE) signals for each register.

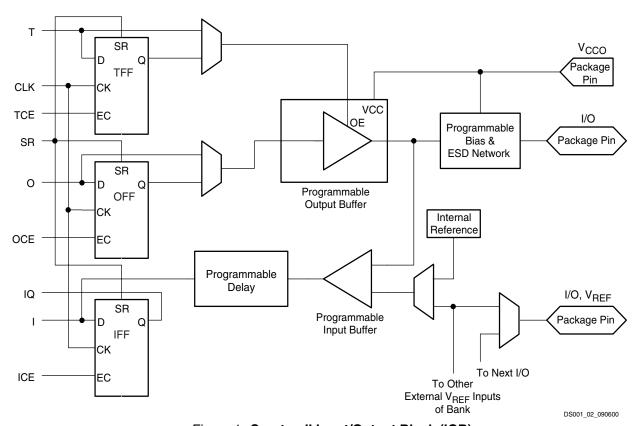


Figure 1: Spartan-II Input/Output Block (IOB)

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In addition to the CLK and CE control signals, the three registers share a Set/Reset (SR). For each register, this signal can be independently configured as a synchronous Set, a synchronous Reset, an asynchronous Preset, or an asynchronous Clear.

A feature not shown in the block diagram, but controlled by the software, is polarity control. The input and output buffers and all of the IOB control signals have independent polarity controls.

Optional pull-up and pull-down resistors and an optional weak-keeper circuit are attached to each pad. Prior to configuration all outputs not involved in configuration are forced into their high-impedance state. The pull-down resistors and the weak-keeper circuits are inactive, but inputs may optionally be pulled up.

Table 1: Standards Supported by I/O (Typical Values)

I/O Standard	Input Reference Voltage (V <sub>REF</sub> )	Output Source Voltage (V <sub>CCO</sub> )	Board Termination Voltage (V <sub>TT</sub> )
LVTTL (2-24 mA)	N/A	3.3	N/A
LVCMOS2	N/A	2.5	N/A
PCI (3V/5V, 33 MHz/66 MHz)	N/A	3.3	N/A
GTL	0.8	N/A	1.2
GTL+	1.0	N/A	1.5
HSTL Class I	0.75	1.5	0.75
HSTL Class III	0.9	1.5	1.5
HSTL Class IV	0.9	1.5	1.5
SSTL3 Class I and II	1.5	3.3	1.5
SSTL2 Class I and II	1.25	2.5	1.25
CTT	1.5	3.3	1.5
AGP-2X	1.32	3.3	N/A

The activation of pull-up resistors prior to configuration is controlled on a global basis by the configuration mode pins. If the pull-up resistors are not activated, all the pins will float. Consequently, external pull-up or pull-down resistors must be provided on pins required to be at a well-defined logic level prior to configuration.

All pads are protected against damage from electrostatic discharge (ESD) and from over-voltage transients. Two forms of over-voltage protection are provided, one that permits 5V compliance, and one that does not. For 5V compliance, a zener-like structure connected to ground turns on when the output rises to approximately 6.5V. When 5V com-

pliance is not required, a conventional clamp diode may be connected to the output supply voltage,  $V_{CCO}$ . The type of over-voltage protection can be selected independently for each pad.

All Spartan-II IOBs support IEEE 1149.1-compatible boundary scan testing.

#### Input Path

A buffer In the Spartan-II IOB input path routes the input signal either directly to internal logic or through an optional input flip-flop.

An optional delay element at the D-input of this flip-flop eliminates pad-to-pad hold time. The delay is matched to the internal clock-distribution delay of the FPGA, and when used, assures that the pad-to-pad hold time is zero.

Each input buffer can be configured to conform to any of the low-voltage signaling standards supported. In some of these standards the input buffer utilizes a user-supplied threshold voltage,  $V_{REF}$  The need to supply  $V_{REF}$  imposes constraints on which standards can used in close proximity to each other. See I/O Banking, page 3.

There are optional pull-up and pull-down resistors at each input for use after configuration.

#### **Output Path**

The output path includes a 3-state output buffer that drives the output signal onto the pad. The output signal can be routed to the buffer directly from the internal logic or through an optional IOB output flip-flop.

The 3-state control of the output can also be routed directly from the internal logic or through a flip-flip that provides synchronous enable and disable.

Each output driver can be individually programmed for a wide range of low-voltage signaling standards. Each output buffer can source up to 24 mA and sink up to 48 mA. Drive strength and slew rate controls minimize bus transients.

In most signaling standards, the output high voltage depends on an externally supplied  $V_{CCO}$  voltage. The need to supply  $V_{CCO}$  imposes constraints on which standards can be used in close proximity to each other. See I/O Banking.

An optional weak-keeper circuit is connected to each output. When selected, the circuit monitors the voltage on the pad and weakly drives the pin High or Low to match the input signal. If the pin is connected to a multiple-source signal, the weak keeper holds the signal in its last state if all drivers are disabled. Maintaining a valid logic level in this way helps eliminate bus chatter.

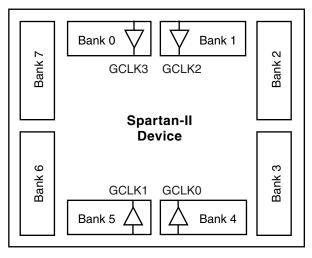
Because the weak-keeper circuit uses the IOB input buffer to monitor the input level, an appropriate  $V_{REF}$  voltage must be provided if the signaling standard requires one. The provision of this voltage must comply with the I/O banking rules.



#### I/O Banking

Some of the I/O standards described above require  $V_{\rm CCO}$  and/or  $V_{\rm REF}$  voltages. These voltages are externally connected to device pins that serve groups of IOBs, called banks. Consequently, restrictions exist about which I/O standards can be combined within a given bank.

Eight I/O banks result from separating each edge of the FPGA into two banks (see Figure 2). Each bank has multiple  $V_{\rm CCO}$  pins which must be connected to the same voltage. Voltage is determined by the output standards in use.



DS001\_03\_060100

Figure 2: Spartan-II I/O Banks

Within a bank, output standards may be mixed only if they use the same  $V_{CCO}$ . Compatible standards are shown in Table 2. GTL and GTL+ appear under all voltages because their open-drain outputs do not depend on  $V_{CCO}$ .

Table 2: Compatible Output Standards

v <sub>cco</sub>	Compatible Standards
3.3V	PCI, LVTTL, SSTL3 I, SSTL3 II, CTT, AGP, GTL, GTL+
2.5V	SSTL2 I, SSTL2 II, LVCMOS2, GTL, GTL+
1.5V	HSTL I, HSTL III, HSTL IV, GTL, GTL+

Some input standards require a user-supplied threshold voltage,  $V_{REF}$  In this case, certain user-I/O pins are automatically configured as inputs for the  $V_{REF}$  voltage. About one in six of the I/O pins in the bank assume this role.

 $V_{\mathsf{REF}}$  pins within a bank are interconnected internally and consequently only one  $V_{\mathsf{REF}}$  voltage can be used within

each bank. All V<sub>REF</sub> pins in the bank, however, must be connected to the external voltage source for correct operation.

In a bank, inputs requiring  $V_{REF}$  can be mixed with those that do not but only one  $V_{REF}$  voltage may be used within a bank. Input buffers that use  $V_{REF}$  are not 5V tolerant. LVTTL, LVCMOS2, and PCI are 5V tolerant. The  $V_{CCO}$  and  $V_{REF}$  pins for each bank appear in the device pinout tables.

Within a given package, the number of  $V_{REF}$  and  $V_{CCO}$  pins can vary depending on the size of device. In larger devices, more I/O pins convert to  $V_{REF}$  pins. Since these are always a superset of the  $V_{REF}$  pins used for smaller devices, it is possible to design a PCB that permits migration to a larger device. All  $V_{REF}$  pins for the largest device anticipated must be connected to the  $V_{REF}$  voltage, and not used for I/O.

Table 3: Independent Banks Available

Package	VQ100	CS144	FG256
	PQ208	TQ144	FG456
Independent Banks	1	4	8

## Configurable Logic Block

The basic building block of the Spartan-II CLB is the logic cell (LC). An LC includes a 4-input function generator, carry logic, and storage element. Output from the function generator in each LC drives the CLB output and the D input of the flip-flop. Each Spartan-II CLB contains four LCs, organized in two similar slices; a single slice is shown in Figure 3.

In addition to the four basic LCs, the Spartan-II CLB contains logic that combines function generators to provide functions of five or six inputs.

#### Look-Up Tables

Spartan-II function generators are implemented as 4-input look-up tables (LUTs). In addition to operating as a function generator, each LUT can provide a 16 x 1-bit synchronous RAM. Furthermore, the two LUTs within a slice can be combined to create a 16 x 2-bit or 32 x 1-bit synchronous RAM, or a 16 x 1-bit dual-port synchronous RAM.

The Spartan-II LUT can also provide a 16-bit shift register that is ideal for capturing high-speed or burst-mode data. This mode can also be used to store data in applications such as Digital Signal Processing.

#### Storage Elements

Storage elements in the Spartan-II slice can be configured either as edge-triggered D-type flip-flops or as level-sensitive latches. The D inputs can be driven either by function generators within the slice or directly from slice inputs, bypassing the function generators.



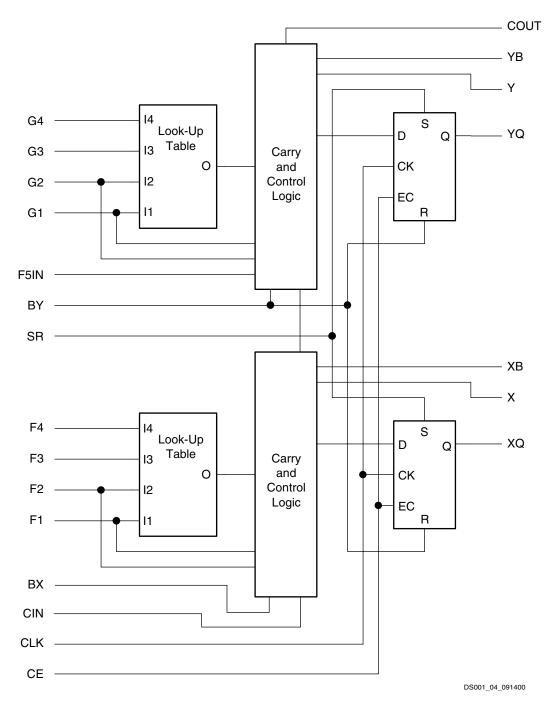


Figure 3: Spartan-II CLB Slice (two identical slices in each CLB)

In addition to Clock and Clock Enable signals, each slice has synchronous set and reset signals (SR and BY). SR forces a storage element into the initialization state specified for it in the configuration. BY forces it into the opposite state. Alternatively, these signals may be configured to operate asynchronously.

All control signals are independently invertible, and are shared by the two flip-flops within the slice.

#### Additional Logic

The F5 multiplexer in each slice combines the function generator outputs. This combination provides either a function generator that can implement any 5-input function, a 4:1 multiplexer, or selected functions of up to nine inputs.

Similarly, the F6 multiplexer combines the outputs of all four function generators in the CLB by selecting one of the F5-multiplexer outputs. This permits the implementation of any 6-input function, an 8:1 multiplexer, or selected functions of up to 19 inputs.



Each CLB has four direct feedthrough paths, one per LC. These paths provide extra data input lines or additional local routing that does not consume logic resources.

#### Arithmetic Logic

Dedicated carry logic provides fast arithmetic carry capability for high-speed arithmetic functions. The Spartan-II CLB supports two separate carry chains, one per slice. The height of the carry chains is two bits per CLB.

The arithmetic logic includes an XOR gate that allows a 1-bit full adder to be implemented within an LC. In addition, a dedicated AND gate improves the efficiency of multiplier implementation.

The dedicated carry path can also be used to cascade function generators for implementing wide logic functions.

#### **BUFTs**

Each Spartan-II CLB contains two 3-state drivers (BUFTs) that can drive on-chip busses. See **Dedicated Routing**, page 6. Each Spartan-II BUFT has an independent 3-state control pin and an independent input pin.

#### Block RAM

Spartan-II FPGAs incorporate several large block RAM memories. These complement the distributed RAM Look-Up Tables (LUTs) that provide shallow memory structures implemented in CLBs.

Block RAM memory blocks are organized in columns. All Spartan-II devices contain two such columns, one along each vertical edge. These columns extend the full height of the chip. Each memory block is four CLBs high, and consequently, a Spartan-II device eight CLBs high will contain two memory blocks per column, and a total of four blocks.

Table 4: Spartan-II Block RAM Amounts

# of Blocks	Total Block RAM Bits
4	16K
6	24K
8	32K
10	40K
12	48K
14	56K
	4 6 8 10 12

Each block RAM cell, as illustrated in Figure 4, is a fully synchronous dual-ported 4096-bit RAM with independent control signals for each port. The data widths of the two ports can be configured independently, providing built-in bus-width conversion.

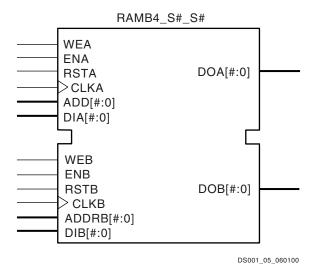


Figure 4: Dual-Port Block RAM

Table 5 shows the depth and width aspect ratios for the block RAM.

Table 5: Block RAM Port Aspect Ratios

Width	Depth	ADDR Bus	Data Bus
1	4096	ADDR<11:0>	DATA<0>
2	2048	ADDR<10:0>	DATA<1:0>
4	1024	ADDR<9:0>	DATA<3:0>
8	512	ADDR<8:0>	DATA<7:0>
16	256	ADDR<7:0>	DATA<15:0>

The Spartan-II block RAM also includes dedicated routing to provide an efficient interface with both CLBs and other block RAMs.

## **Programmable Routing Matrix**

It is the longest delay path that limits the speed of any worst-case design. Consequently, the Spartan-II routing architecture and its place-and-route software were defined in a single optimization process. This joint optimization minimizes long-path delays, and consequently, yields the best system performance.

The joint optimization also reduces design compilation times because the architecture is software-friendly. Design cycles are correspondingly reduced due to shorter design iteration times.

#### Local Routing

The local routing resources, as shown in Figure 5, provide the following three types of connections:

- Interconnections among the LUTs, flip-flops, and General Routing Matrix (GRM)
- Internal CLB feedback paths that provide high-speed connections to LUTs within the same CLB, chaining



them together with minimal routing delay

 Direct paths that provide high-speed connections between horizontally adjacent CLBs, eliminating the delay of the GRM

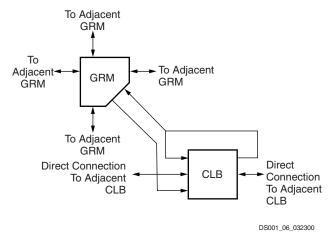


Figure 5: Spartan-II Local Routing

#### General Purpose Routing

Most Spartan-II signals are routed on the general purpose routing, and consequently, the majority of interconnect resources are associated with this level of the routing hierarchy. The general routing resources are located in horizontal and vertical routing channels associated with the rows and columns CLBs. The general-purpose routing resources are listed below.

- Adjacent to each CLB is a General Routing Matrix (GRM). The GRM is the switch matrix through which horizontal and vertical routing resources connect, and is also the means by which the CLB gains access to the general purpose routing.
- 24 single-length lines route GRM signals to adjacent

- GRMs in each of the four directions.
- 96 buffered Hex lines route GRM signals to other GRMs six blocks away in each one of the four directions. Organized in a staggered pattern, Hex lines may be driven only at their endpoints. Hex-line signals can be accessed either at the endpoints or at the midpoint (three blocks from the source). One third of the Hex lines are bidirectional, while the remaining ones are unidirectional.
- 12 Longlines are buffered, bidirectional wires that distribute signals across the device quickly and efficiently. Vertical Longlines span the full height of the device, and horizontal ones span the full width of the device.

#### I/O Routing

Spartan-II devices have additional routing resources around their periphery that form an interface between the CLB array and the IOBs. This additional routing, called the VersaRing, facilitates pin-swapping and pin-locking, such that logic redesigns can adapt to existing PCB layouts. Time-to-market is reduced, since PCBs and other system components can be manufactured while the logic design is still in progress.

#### **Dedicated Routing**

Some classes of signal require dedicated routing resources to maximize performance. In the Spartan-II architecture, dedicated routing resources are provided for two classes of signal.

- Horizontal routing resources are provided for on-chip 3-state busses. Four partitionable bus lines are provided per CLB row, permitting multiple busses within a row, as shown in Figure 6.
- Two dedicated nets per CLB propagate carry signals vertically to the adjacent CLB.

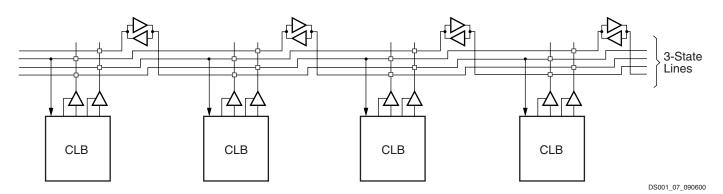


Figure 6: BUFT Connections to Dedicated Horizontal Bus Lines



#### Global Routing

Global Routing resources distribute clocks and other signals with very high fanout throughout the device. Spartan-II devices include two tiers of global routing resources referred to as primary and secondary global routing resources.

- The primary global routing resources are four dedicated global nets with dedicated input pins that are designed to distribute high-fanout clock signals with minimal skew. Each global clock net can drive all CLB, IOB, and block RAM clock pins. The primary global nets may only be driven by global buffers. There are four global buffers, one for each global net.
- The secondary global routing resources consist of 24 backbone lines, 12 across the top of the chip and 12 across bottom. From these lines, up to 12 unique signals per column can be distributed via the 12 longlines in the column. These secondary resources are more flexible than the primary resources since they are not restricted to routing only to clock pins.

#### **Clock Distribution**

The Spartan-II family provides high-speed, low-skew clock distribution through the primary global routing resources described above. A typical clock distribution net is shown in Figure 7.

Four global buffers are provided, two at the top center of the device and two at the bottom center. These drive the four primary global nets that in turn drive any clock pin.

Four dedicated clock pads are provided, one adjacent to each of the global buffers. The input to the global buffer is selected either from these pads or from signals in the general purpose routing. Global clock pins do not have the option for internal, weak pull-up resistors.

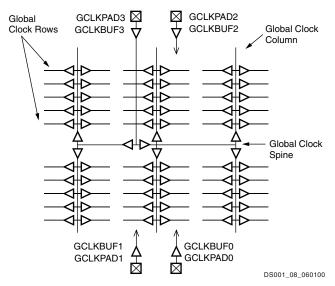


Figure 7: Global Clock Distribution Network

#### Delay-Locked Loop (DLL)

Associated with each global clock input buffer is a fully digital Delay-Locked Loop (DLL) that can eliminate skew between the clock input pad and internal clock-input pins throughout the device. Each DLL can drive two global clock networks. The DLL monitors the input clock and the distributed clock, and automatically adjusts a clock delay element. Additional delay is introduced such that clock edges reach internal flip-flops exactly one clock period after they arrive at the input. This closed-loop system effectively eliminates clock-distribution delay by ensuring that clock edges arriving at internal flip-flops in synchronism with clock edges arriving at the input.

In addition to eliminating clock-distribution delay, the DLL provides advanced control of multiple clock domains. The DLL provides four quadrature phases of the source clock, can double the clock, or divide the clock by 1.5, 2, 2.5, 3, 4, 5, 8, or 16. It has six outputs.

The DLL also operates as a clock mirror. By driving the output from a DLL off-chip and then back on again, the DLL can be used to deskew a board level clock among multiple Spartan-II devices.

In order to guarantee that the system clock is operating correctly prior to the FPGA starting up after configuration, the DLL can delay the completion of the configuration process until after it has achieved lock.

## **Boundary Scan**

Spartan-II devices support all the mandatory boundary-scan instructions specified in the IEEE standard 1149.1. A Test Access Port (TAP) and registers are provided that implement the EXTEST, SAMPLE/PRELOAD, and BYPASS instructions. The TAP also supports two USERCODE instructions and internal scan chains.

The TAP uses dedicated package pins that always operate using LVTTL. For TDO to operate using LVTTL, the  $V_{CCO}$  for Bank 2 must be 3.3V. Otherwise, TDO switches rail-to-rail between ground and  $V_{CCO}$ .

Boundary-scan operation is independent of individual IOB configurations, and unaffected by package type. All IOBs, including unbonded ones, are treated as independent 3-state bidirectional pins in a single scan chain. Retention of the bidirectional test capability after configuration facilitates the testing of external interconnections.

Table 6 lists the boundary-scan instructions supported in Spartan-II FPGAs. Internal signals can be captured during EXTEST by connecting them to unbonded or unused IOBs. They may also be connected to the unused outputs of IOBs defined as unidirectional input pins.



Table 6: Boundary-Scan Instructions

Boundary-Scan	Binary	
Command Command	Code[4:0]	Description
EXTEST	00000	Enables boundary-scan EXTEST operation
SAMPLE	00001	Enables boundary-scan SAMPLE operation
USR1	00010	Access user-defined register 1
USR2	00011	Access user-defined register 2
CFG_OUT	00100	Access the configuration bus for Readback
CFG_IN	00101	Access the configuration bus for Configuration
INTEST	00111	Enables boundary-scan INTEST operation
USRCODE	01000	Enables shifting out USER code
IDCODE	01001	Enables shifting out of ID Code
HIZ	01010	Disables output pins while enabling the Bypass Register
JSTART	01100	Clock the start-up sequence when StartupClk is TCK
BYPASS	11111	Enables BYPASS
RESERVED	All other codes	Xilinx reserved instructions

The public boundary-scan instructions are available prior to configuration. After configuration, the public instructions remain available together with any USERCODE instructions installed during the configuration. While the SAMPLE and BYPASS instructions are available during configuration, it is recommended that boundary-scan operations not be performed during this transitional period.

In addition to the test instructions outlined above, the boundary-scan circuitry can be used to configure the FPGA, and also to read back the configuration data.

To facilitate internal scan chains, the User Register provides three outputs (Reset, Update, and Shift) that represent the corresponding states in the boundary-scan internal state machine.

Figure 8 is a diagram of the Spartan-II family boundary scan logic. It includes three bits of Data Register per IOB, the IEEE 1149.1 Test Access Port controller, and the Instruction Register with decodes.



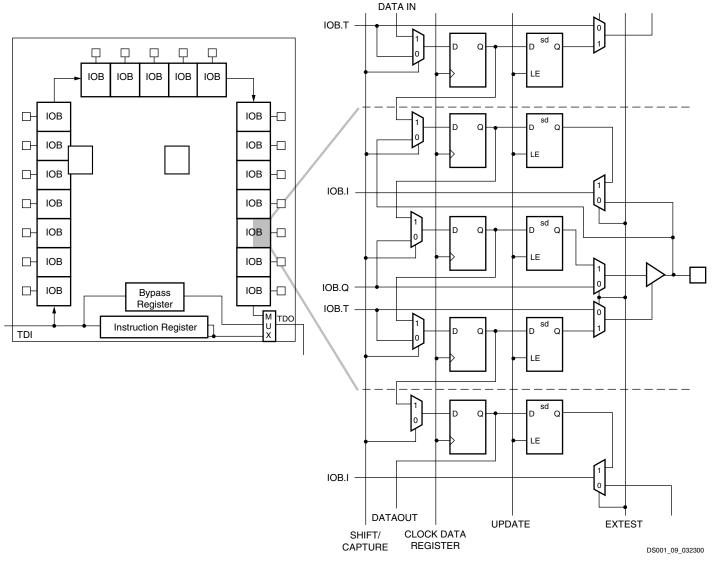


Figure 8: Spartan-II Family Boundary Scan Logic

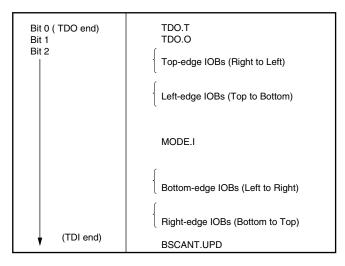
#### Bit Sequence

The bit sequence within each IOB is: In, Out, 3-State. The input-only pins contribute only the In bit to the boundary scan I/O data register, while the output-only pins contributes all three bits.

From a cavity-up view of the chip (as shown in the FPGA Editor), starting in the upper right chip corner, the boundary scan data-register bits are ordered as shown in Figure 9.

BSDL (Boundary Scan Description Language) files for Spartan-II family devices are available on the Xilinx website, in the File Download area.





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Figure 9: Boundary Scan Bit Sequence

## **Development System**

Spartan-II FPGAs are supported by the Xilinx Foundation and Alliance CAE tools. The basic methodology for Spartan-II design consists of three interrelated steps: design entry, implementation, and verification. Industry-standard tools are used for design entry and simulation (for example, Synopsys FPGA Express), while Xilinx provides proprietary architecture-specific tools for implementation.

The Xilinx development system is integrated under the Xilinx Design Manager software, providing designers with a common user interface regardless of their choice of entry and verification tools. The software simplifies the selection of implementation options with pull-down menus and on-line help.

Application programs ranging from schematic capture to Placement and Routing (PAR) can be accessed through the software. The program command sequence is generated prior to execution, and stored for documentation.

Several advanced software features facilitate Spartan-II design. Relationally-Placed Macros (RPMs), for example, are schematic-based macros with relative location constraints to guide their placement. They help ensure optimal implementation of common functions.

For HDL design entry, the Xilinx FPGA development system provides interfaces to several synthesis design environments.

A standard interface-file specification, Electronic Design Interchange Format (EDIF), simplifies file transfers into and out of the development system.

Spartan-II FPGAs supported by a unified library of standard functions. This library contains over 400 primitives and macros, ranging from 2-input AND gates to 16-bit accumulators, and includes arithmetic functions, comparators, counters, data registers, decoders, encoders, I/O functions, latches,

Boolean functions, multiplexers, shift registers, and barrel shifters.

The "soft macro" portion of the library contains detailed descriptions of common logic functions, but does not contain any partitioning or placement information. The performance of these macros depends, therefore, on the partitioning and placement obtained during implementation.

RPMs, on the other hand, do contain predetermined partitioning and placement information that permits optimal implementation of these functions. Users can create their own library of soft macros or RPMs based on the macros and primitives in the standard library.

The design environment supports hierarchical design entry, with high-level schematics that comprise major functional blocks, while lower-level schematics define the logic in these blocks. These hierarchical design elements are automatically combined by the implementation tools. Different design entry tools can be combined within a hierarchical design, thus allowing the most convenient entry method to be used for each portion of the design.

#### **Design Implementation**

The place-and-route tools (PAR) automatically provide the implementation flow described in this section. The partitioner takes the EDIF netlist for the design and maps the logic into the architectural resources of the FPGA (CLBs and IOBs, for example). The placer then determines the best locations for these blocks based on their interconnections and the desired performance. Finally, the router interconnects the blocks.

The PAR algorithms support fully automatic implementation of most designs. For demanding applications, however, the user can exercise various degrees of control over the process. User partitioning, placement, and routing information is optionally specified during the design-entry process. The implementation of highly structured designs can benefit greatly from basic floorplanning.

The implementation software incorporates Timing Wizard® timing-driven placement and routing. Designers specify timing requirements along entire paths during design entry. The timing path analysis routines in PAR then recognize these user-specified requirements and accommodate them.

Timing requirements are entered on a schematic in a form directly relating to the system requirements, such as the targeted clock frequency, or the maximum allowable delay between two registers. In this way, the overall performance of the system along entire signal paths is automatically tailored to user-generated specifications. Specific timing information for individual nets is unnecessary.

### **Design Verification**

In addition to conventional software simulation, FPGA users can use in-circuit debugging techniques. Because Xilinx devices are infinitely reprogrammable, designs can be veri-



fied in real time without the need for extensive sets of software simulation vectors.

The development system supports both software simulation and in-circuit debugging techniques. For simulation, the system extracts the post-layout timing information from the design database, and back-annotates this information into the netlist for use by the simulator. Alternatively, the user can verify timing-critical portions of the design using the static timing analyzer.

For in-circuit debugging, the development system includes a download and readback cable, which connects the FPGA in the target system to a PC or workstation. After downloading the design into the FPGA, the designer can single-step the logic, readback the contents of the flip-flops, and so observe the internal logic state. Simple modifications can be downloaded into the system in a matter of minutes.

## Configuration

Configuration is the process by which the bitstream of a design, as generated by the Xilinx development software, is loaded into the internal configuration memory of the FPGA. Spartan-II devices support both serial configuration, using the master/slave serial and JTAG modes, as well as byte-wide configuration employing the Slave Parallel mode.

### **Configuration File**

Spartan-II devices are configured by sequentially loading frames of data that have been concatenated into a configuration file. Table 7 shows how much nonvolatile storage space is needed for Spartan-II devices.

It is important to note that, while a PROM is commonly used to store configuration data before loading them into the FPGA, it is by no means required. Any of a number of different kinds of under populated nonvolatile storage already available either on or off the board (i.e., hard drives, FLASH

cards, etc.) can be used. For more information on configuration without a PROM, refer to XAPP098, The Low-Cost, Efficient Serial Configuration of Spartan FPGAs.

Table 7: Spartan-II Configuration File Size

Device	Configuration File Size (Bits)
XC2S15	197,696
XC2S30	336,768
XC2S50	559,200
XC2S100	781,216
XC2S150	1,040,096
XC2S200	1,335,840

#### Modes

Spartan-II devices support the following four configuration modes:

- Slave Serial mode
- Master Serial mode
- Slave Parallel mode
- Boundary-scan mode

The Configuration mode pins (M2, M1, M0) select among these configuration modes with the option in each case of having the IOB pins either pulled up or left floating prior to configuration. The selection codes are listed in Table 8.

Configuration through the boundary-scan port is always available, independent of the mode selection. Selecting the boundary-scan mode simply turns off the other modes. The three mode pins have internal pull-up resistors, and default to a logic High if left unconnected.

Table 8: Configuration Modes

Configuration Mode	Preconfiguration Pull-ups	МО	M1	M2	CCLK Direction	Data Width	Serial D <sub>OUT</sub>
Master Serial mode	No	0	0	0	Out	1	Yes
	Yes	0	0	1			
Slave Parallel mode	Yes	0	1	0	ln	8	No
	No	0	1	1			
Boundary-Scan mode	Yes	1	0	0	N/A	1	No
	No	1	0	1			
Slave Serial mode	Yes	1	1	0	ln	1	Yes
	No	1	1	1			

#### Notes:

<sup>1.</sup> After power-on, the I/O drivers will be in a high-impedance state. After configuration, all unused I/Os (those not assigned signals) will remain in a high-impedance state.



#### **Signals**

There are two kinds of pins that are used to configure Spartan-II devices: Dedicated pins perform only specific configuration-related functions; the other pins can serve as general purpose I/Os once user operation has begun.

The dedicated pins comprise the mode pins (M2, M1, M0), the configuration clock pin (CCLK), the PROGRAM pin, the DONE pin and the boundary-scan pins (TDI, TDO, TMS, TCK). Depending on the selected configuration mode, CCLK may be an output generated by the FPGA, or may be generated externally, and provided to the FPGA as an input.

Note that some configuration pins can act as outputs. For correct operation, these pins require a  $V_{CCO}$  of 3.3V to drive an LVTTL signal. All the relevant pins fall in banks 2 or 3.

For a more detailed description than that given below, see DS001-4, *Spartan-II 2.5V FPGA Family: Pinout Tables* and XAPP176, *Spartan-II FPGA Series Configuration and Readback*.

#### The Process

The sequence of steps necessary to configure Spartan-II devices are shown in Figure 10. The overall flow can be divided into three different phases.

- Initiating Configuration
- Configuration memory clear
- Loading data frames
- Start-up

The memory clearing and start-up phases are the same for all configuration modes; however, the steps for the loading of data frames are different. Thus, the details for data frame loading are described separately in the sections devoted to each mode.

#### Initiating Configuration

There are two different ways to initiate the configuration process: applying power to the device or asserting the PROGRAM input.

Configuration on power-up occurs automatically unless it is delayed by the user, as described in a separate section below. The waveform for configuration on power-up is shown in Figure 11, page 13. Before configuration can begin,  $V_{\rm CCO}$  Bank 2 must be greater than 1.0V. Furthermore, all  $V_{\rm CCINT}$  power pins must be connected to a 2.5V supply. For more information on delaying configuration, see Clearing Configuration Memory, page 13.

Once in user operation, the device can be re-configured simply by pulling the PROGRAM pin Low. The device acknowledges the beginning of the configuration process by driving DONE Low, then enters the memory-clearing phase.

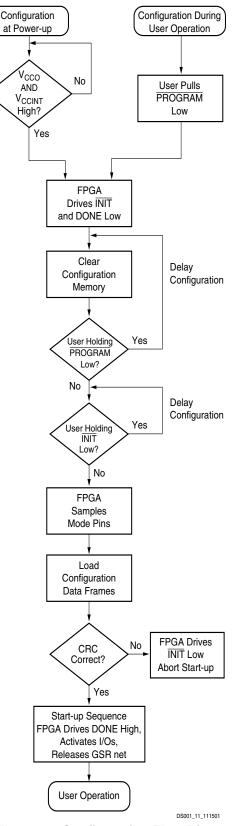
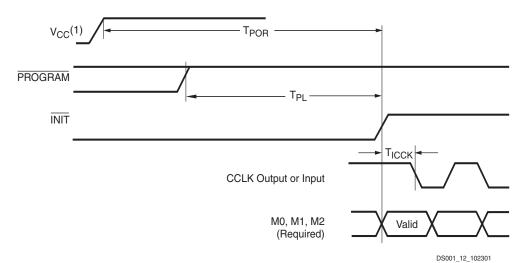


Figure 10: Configuration Flow Diagram





Symbol	Description		Units
T <sub>POR</sub>	Power-on reset	2	ms, max
T <sub>PL</sub>	Program latency	100	μs, max
T <sub>ICCK</sub>	CCLK output delay (Master Serial	0.5	μs, min
	mode only)	4	μs, max
T <sub>PROGRAM</sub>	Program pulse width	300	ns, min

#### Notes: (referring to waveform above:)

Before configuration can begin, V<sub>CCINT</sub> must be greater than 1.6V and V<sub>CCO</sub> Bank 2 must be greater than 1.0V.

Figure 11: Configuration Timing on Power-Up

#### Clearing Configuration Memory

The device indicates that clearing the configuration memory is in progress by driving  $\overline{\text{INIT}}$  Low. At this time, the user can delay configuration by holding either  $\overline{\text{PROGRAM}}$  or  $\overline{\text{INIT}}$  Low, which causes the device to remain in the memory clearing phase. Note that the bidirectional  $\overline{\text{INIT}}$  line is driving a Low logic level during memory clearing. Thus, to avoid contention, use an open-drain driver to keep  $\overline{\text{INIT}}$  Low.

With no delay in force, the device indicates that the memory is completely clear by driving  $\overline{\text{INIT}}$  High. The FPGA samples its mode pins on this Low-to-High transition.

#### Loading Configuration Data

Once INIT is High, the user can begin loading configuration data frames into the device. The details of loading the configuration data are discussed in the sections treating the configuration modes individually. The sequence of operations necessary to load configuration data using the serial modes is shown in Figure 13. Loading data using the Slave Parallel mode is shown in Figure 18, page 18.

#### **CRC Error Checking**

During the loading of configuration data, a CRC value embedded in the configuration file is checked against a CRC value calculated within the FPGA. If the CRC values do not match, the FPGA drives INIT Low to indicate that a frame error has occurred and configuration is aborted.

To reconfigure the device, the PROGRAM pin should be asserted to reset the configuration logic. Recycling power also resets the FPGA for configuration. See Clearing Configuration Memory.

#### Start-up

The start-up sequence oversees the transition of the FPGA from the configuration state to full user operation. A match of CRC values, indicating a successful loading of the configuration data, initiates the sequence.

During start-up, the device performs four operations:

- The assertion of DONE. The failure of DONE to go High may indicate the unsuccessful loading of configuration data.
- 2. The release of the Global Three State net. This activates I/Os to which signals are assigned. The remaining I/Os stay in a high-impedance state with internal weak pull-down resistors present.
- 3. Negates Global Set Reset (GSR). This allows all flip-flops to change state.
- 4. The assertion of Global Write Enable (GWE). This allows all RAMs and flip-flops to change state.

By default, these operations are synchronized to CCLK. The entire start-up sequence lasts eight cycles, called C0-C7, after which the loaded design is fully functional. The default timing for start-up is shown in the top half of Figure 12. The four operations can be selected to switch on any CCLK cycle C1-C6 through settings in the Xilinx Development Software. Heavy lines show default settings.

The bottom half of Figure 12 shows another commonly used version of the start-up timing known as Sync-to-DONE. This version makes the GTS, GSR, and GWE events conditional upon the DONE pin going High. This timing is important for a daisy chain of multiple FPGAs in serial mode, since it ensures that all FPGAs go through start-up together, after all their DONE pins have gone High.

Sync-to-DONE timing is selected by setting the GTS, GSR, and GWE cycles to a value of DONE in the configuration options. This causes these signals to transition one clock cycle after DONE externally transitions High.

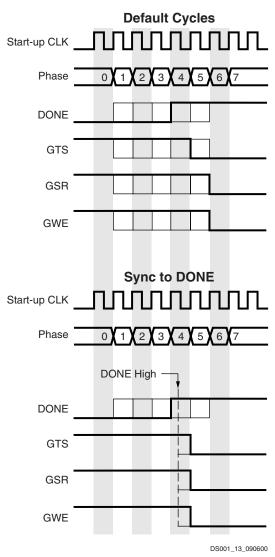


Figure 12: Start-Up Waveforms

#### **Serial Modes**

There are two serial configuration modes: In Master Serial mode, the FPGA controls the configuration process by driving CCLK as an output. In Slave Serial mode, the FPGA passively receives CCLK as an input from an external agent (e.g., a microprocessor, CPLD, or second FPGA in master mode) that is controlling the configuration process. In both modes, the FPGA is configured by loading one bit per CCLK cycle. The MSB of each configuration data byte is always written to the DIN pin first.

See Figure 13 for the sequence for loading data into the Spartan-II FPGA serially. This is an expansion of the "Load Configuration Data Frames" block in Figure 10. Note that  $\overline{\text{CS}}$  and  $\overline{\text{WRITE}}$  normally are not used during serial configuration. To ensure successful loading of the FPGA, do not toggle  $\overline{\text{WRITE}}$  with  $\overline{\text{CS}}$  Low during serial configuration.

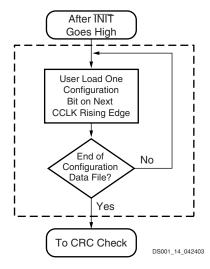


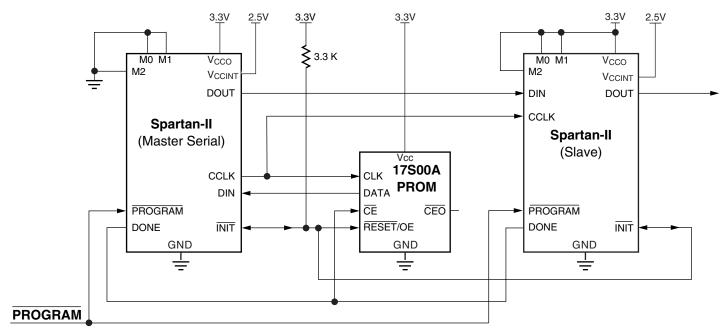
Figure 13: Loading Serial Mode Configuration Data

#### Slave Serial Mode

In Slave Serial mode, the FPGA's CCLK pin is driven by an external source, allowing FPGAs to be configured from other logic devices such as microprocessors or in a daisy-chain configuration. Figure 14 shows connections for a Master Serial FPGA configuring a Slave Serial FPGA from a PROM. A Spartan-II device in slave serial mode should be connected as shown for the third device from the left. Slave Serial mode is selected by a <11x> on the mode pins (M0, M1, M2).

Figure 15 shows the timing for Slave Serial configuration. The serial bitstream must be setup at the DIN input pin a short time before each rising edge of an externally generated CCLK. Multiple FPGAs in Slave Serial mode can be daisy-chained for configuration from a single source. After an FPGA is configured, data for the next device is routed to the DOUT pin. Data on the DOUT pin changes on the rising edge of CCLK. Configuration must be delayed until INIT pins of all daisy-chained FPGAs are High. For more information, see **Start-up**, page 13.



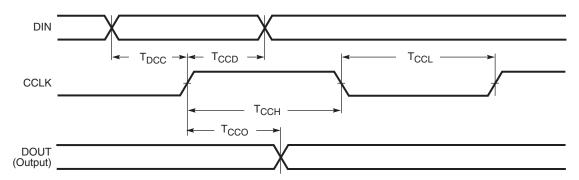


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#### Notes:

1. If the DriveDone configuration option is not active for any of the FPGAs, pull up DONE with a 3.3K  $\Omega$  resistor.

Figure 14: Master/Slave Serial Configuration Circuit Diagram



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Symbol		Description		Units
T <sub>DCC</sub>		DIN setup	5	ns, min
T <sub>CCD</sub>		DIN hold	0	ns, min
T <sub>CCO</sub>	CCLK	DOUT	12	ns, max
T <sub>CCH</sub>	COLK	High time	5	ns, min
T <sub>CCL</sub>		Low time	5	ns, min
F <sub>CC</sub>		Maximum frequency	66	MHz, max

Figure 15: Slave Serial Mode Timing

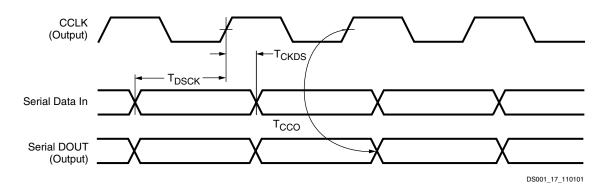


#### Master Serial Mode

In Master Serial mode, the CCLK output of the FPGA drives a Xilinx PROM which feeds a serial stream of configuration data to the FPGA's DIN input. Figure 14 shows a Master Serial FPGA configuring a Slave Serial FPGA from a PROM. A Spartan-II device in Master Serial mode should be connected as shown for the device on the left side. Master Serial mode is selected by a <00x> on the mode pins (M0, M1, M2). The PROM RESET pin is driven by INIT, and CE input is driven by DONE. The interface is identical to the slave serial mode except that an oscillator internal to the FPGA is used to generate the configuration clock (CCLK). Any of a number of different frequencies ranging from 4 to 60 MHz can be set using the ConfigRate option in the Xilinx development software. On power-up, while the first 60 bytes

of the configuration data are being loaded, the CCLK frequency is always 2.5 MHz. This frequency is used until the ConfigRate bits, part of the configuration file, have been loaded into the FPGA, at which point, the frequency changes to the selected ConfigRate. Unless a different frequency is specified in the design, the default ConfigRate is 4 MHz. The period of the CCLK signal created by the internal oscillator has a variance of +45%, -30% from the specified value.

Figure 16 shows the timing for Master Serial configuration. The FPGA accepts one bit of configuration data on each rising CCLK edge. After the FPGA has been loaded, the data for the next device in a daisy-chain is presented on the DOUT pin after the rising CCLK edge.



Symbol		Description		Units
T <sub>DSCK</sub>		DIN setup	5.0	ns, min
T <sub>CKDS</sub>	CCLK	DIN hold	0.0	ns, min
		Frequency tolerance with respect to nominal	+45%, -30%	-

Figure 16: Master Serial Mode Timing

#### Slave Parallel Mode

The Slave Parallel mode is the fastest configuration option. Byte-wide data is written into the FPGA. A BUSY flag is provided for controlling the flow of data at a clock frequency  $F_{\text{CCNH}}$  above 50 MHz.

Figure 17, page 17 shows the connections for two Spartan-II devices using the Slave Parallel mode. Slave Parallel mode is selected by a <011> on the mode pins (M0, M1, M2).

If a configuration file of the format .bit, .rbt, or non-swapped HEX is used for parallel programming, then the most significant bit (i.e. the left-most bit of each configuration byte, as

displayed in a text editor) must be routed to the D0 input on the FPGA.

The agent controlling configuration is not shown. Typically, a processor, a microcontroller, or CPLD controls the Slave Parallel interface. The controlling agent provides byte-wide configuration data, CCLK, a Chip Select ( $\overline{CS}$ ) signal and a Write signal ( $\overline{WRITE}$ ). If BUSY is asserted (High) by the FPGA, the data must be held until BUSY goes Low.

After configuration, the pins of the Slave Parallel port (D0-D7) can be used as additional user I/O. Alternatively, the port may be retained to permit high-speed 8-bit readback. Then data can be read by de-asserting WRITE. See **Readback**, page 18.



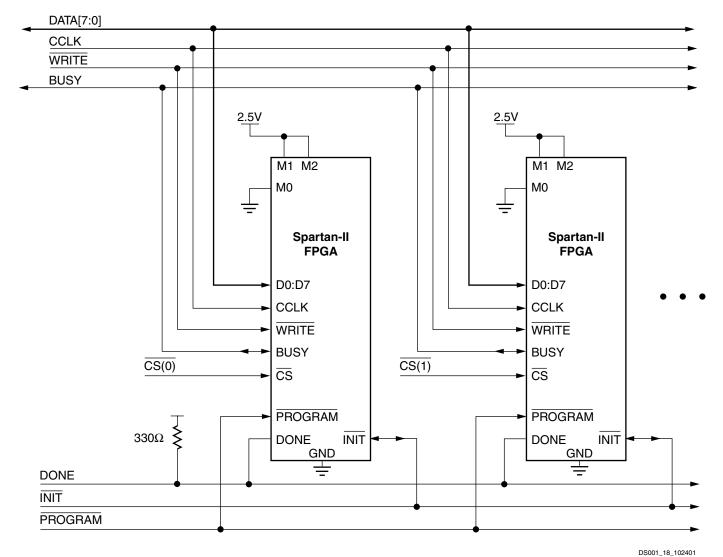


Figure 17: Slave Parallel Configuration Circuit Diagram

Multiple Spartan-II FPGAs can be configured using the Slave Parallel mode, and be made to start-up simultaneously. To configure multiple devices in this way, wire the individual CCLK, Data, WRITE, and BUSY pins of all the devices in parallel. The individual devices are loaded separately by asserting the  $\overline{\text{CS}}$  pin of each device in turn and writing the appropriate data. Sync-to-DONE start-up timing is used to ensure that the start-up sequence does not begin until all the FPGAs have been loaded. See Start-up, page 13.

#### Write

When using the Slave Parallel Mode, write operations send packets of byte-wide configuration data into the FPGA. Figure 18, page 18 shows a flowchart of the write sequence used to load data into the Spartan-II FPGA. This is an expansion of the "Load Configuration Data Frames" block in Figure 10, page 12. The timing for write operations is shown in Figure 19, page 19.

For the present example, the user holds  $\overline{WRITE}$  and  $\overline{CS}$  Low throughout the sequence of write operations. Note that when  $\overline{CS}$  is asserted on successive CCLKs,  $\overline{WRITE}$  must remain either asserted or de-asserted. Otherwise an abort will be initiated, as in the next section.

- Drive data onto D0-D7. Note that to avoid contention, the data source should not be enabled while CS is Low and WRITE is High. Similarly, while WRITE is High, no more than one device's CS should be asserted.
- On the rising edge of CCLK: If BUSY is Low, the data is accepted on this clock. If BUSY is High (from a previous write), the data is not accepted. Acceptance will instead occur on the first clock after BUSY goes Low, and the data must be held until this happens.
- 3. Repeat steps 1 and 2 until all the data has been sent.
- De-assert CS and WRITE.

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If CCLK is slower than  $F_{\text{CCNH}}$ , the FPGA will never assert BUSY. In this case, the above handshake is unnecessary, and data can simply be entered into the FPGA every CCLK cycle.

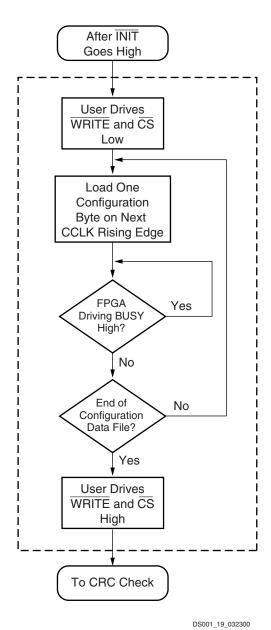


Figure 18: Loading Configuration Data for the Slave
Parallel Mode

A configuration packet does not have to be written in one continuous stretch, rather it can be split into many write sequences. Each sequence would involve assertion of CS.

In applications where multiple clock cycles may be required to access the configuration data before each byte can be loaded into the Slave Parallel interface, a new byte of data may not be ready for each consecutive CCLK edge. In such a case the  $\overline{CS}$  signal may be de-asserted until the next byte is valid on D0-D7. While  $\overline{CS}$  is High, the Slave Parallel interface does not expect any data and ignores all CCLK transitions. However, to avoid aborting configuration,  $\overline{WRITE}$  must continue to be asserted while  $\overline{CS}$  is asserted.

#### **Abort**

To abort configuration during a write sequence, de-assert WRITE while holding  $\overline{\text{CS}}$  Low. The abort operation is initiated at the rising edge of CCLK, as shown in Figure 20, page 19. The device will remain BUSY until the aborted operation is complete. After aborting configuration, data is assumed to be unaligned to word boundaries and the FPGA requires a new synchronization word prior to accepting any new packets.

#### **Boundary-Scan Mode**

In the boundary-scan mode, no nondedicated pins are required, configuration being done entirely through the IEEE 1149.1 Test Access Port.

Configuration through the TAP uses the special CFG\_IN instruction. This instruction allows data input on TDI to be converted into data packets for the internal configuration bus.

The following steps are required to configure the FPGA through the boundary-scan port.

- 1. Load the CFG\_IN instruction into the boundary-scan instruction register (IR)
- 2. Enter the Shift-DR (SDR) state
- 3. Shift a standard configuration bitstream into TDI
- 4. Return to Run-Test-Idle (RTI)
- 5. Load the JSTART instruction into IR
- 6. Enter the SDR state
- 7. Clock TCK through the sequence (the length is programmable)
- 8. Return to RTI

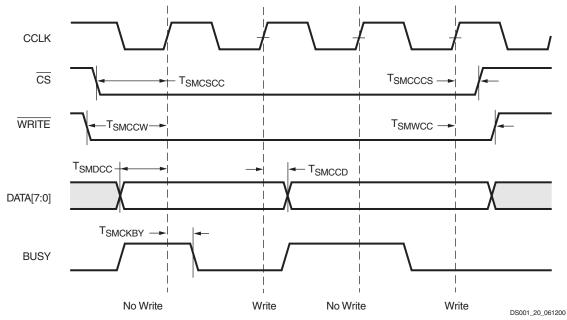
Configuration and readback via the TAP is always available. The boundary-scan mode simply locks out the other modes. The boundary-scan mode is selected by a <10x> on the mode pins (M0, M1, M2).

#### Readback

The configuration data stored in the Spartan-II configuration memory can be readback for verification. Along with the configuration data it is possible to readback the contents of all flip-flops/latches, LUT RAMs, and block RAMs. This capability is used for real-time debugging.

For more detailed information see **XAPP176**, **Spartan-II FPGA Family Configuration and Readback**.





Symbol		Description		Units
T <sub>SMDCC</sub>		D0-D7 setup/hold	5	ns, min
T <sub>SMCCD</sub>		D0-D7 hold	0	ns, min
T <sub>SMCSCC</sub>		CS setup	7	ns, min
T <sub>SMCCCS</sub>		CS hold	0	ns, min
T <sub>SMCCW</sub>	CCLK	WRITE setup	7	ns, min
T <sub>SMWCC</sub>		WRITE hold	0	ns, min
T <sub>SMCKBY</sub>		BUSY propagation delay	12	ns, max
F <sub>CC</sub>		Maximum frequency	66	MHz, max
F <sub>CCNH</sub>		Maximum frequency with no handshake	50	MHz, max

Figure 19: Slave Parallel Write Timing

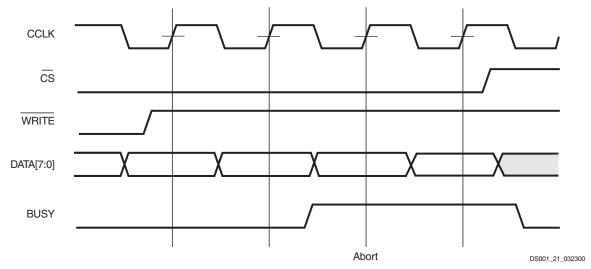


Figure 20: Slave Parallel Write Abort Waveforms



## **Design Considerations**

This section contains more detailed design information on the following features:

- Delay-Locked Loop . . . see page 20
- Block RAM . . . see page 24
- Versatile I/O . . . see page 29

## **Using Delay-Locked Loops**

The Spartan-II FPGA family provides up to four fully digital dedicated on-chip Delay-Locked Loop (DLL) circuits which provide zero propagation delay, low clock skew between output clock signals distributed throughout the device, and advanced clock domain control. These dedicated DLLs can be used to implement several circuits which improve and simplify system level design.

#### Introduction

As FPGAs grow in size, quality on-chip clock distribution becomes increasingly important. Clock skew and clock delay impact device performance and the task of managing clock skew and clock delay with conventional clock trees becomes more difficult in large devices. The Spartan-II family of devices resolve this potential problem by providing up to four fully digital dedicated on-chip Delay-Locked Loop (DLL) circuits which provide zero propagation delay and low clock skew between output clock signals distributed throughout the device.

Each DLL can drive up to two global clock routing networks within the device. The global clock distribution network minimizes clock skews due to loading differences. By monitoring a sample of the DLL output clock, the DLL can compensate for the delay on the routing network, effectively eliminating the delay from the external input port to the individual clock loads within the device.

In addition to providing zero delay with respect to a user source clock, the DLL can provide multiple phases of the source clock. The DLL can also act as a clock doubler or it can divide the user source clock by up to 16.

Clock multiplication gives the designer a number of design alternatives. For instance, a 50 MHz source clock doubled by the DLL can drive an FPGA design operating at 100 MHz. This technique can simplify board design because the clock path on the board no longer distributes such a high-speed signal. A multiplied clock also provides designers the option of time-domain-multiplexing, using one circuit twice per clock cycle, consuming less area than two copies of the same circuit. Two DLLs in can be connected in series to increase the effective clock multiplication factor to four.

The DLL can also act as a clock mirror. By driving the DLL output off-chip and then back in again, the DLL can be used to de-skew a board level clock between multiple devices.

In order to guarantee the system clock establishes prior to the device "waking up," the DLL can delay the completion of the device configuration process until after the DLL achieves lock.

By taking advantage of the DLL to remove on-chip clock delay, the designer can greatly simplify and improve system level design involving high-fanout, high-performance clocks.

#### **Library DLL Symbols**

Figure 21 shows the simplified Xilinx library DLL macro symbol, BUFGDLL. This macro delivers a quick and efficient way to provide a system clock with zero propagation delay throughout the device. Figure 22 and Figure 23 show the two library DLL primitives. These symbols provide access to the complete set of DLL features when implementing more complex applications.

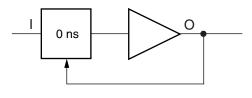
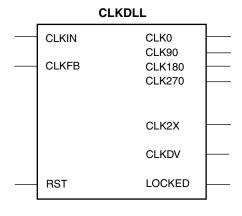


Figure 21: Simplified DLL Macro Symbol BUFGDLL



DS001\_23\_032300

DS001 22 032300

Figure 22: Standard DLL Symbol CLKDLL

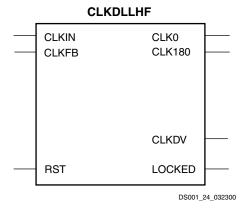


Figure 23: High-Frequency DLL Symbol CLKDLLHF



#### **BUFGDLL Pin Descriptions**

Use the BUFGDLL macro as the simplest way to provide zero propagation delay for a high-fanout on-chip clock from an external input. This macro uses the IBUFG, CLKDLL and BUFG primitives to implement the most basic DLL application as shown in Figure 24.

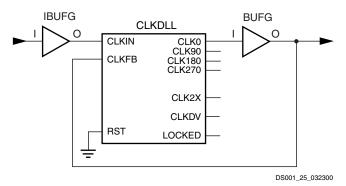


Figure 24: BUFGDLL Schematic

This symbol does not provide access to the advanced clock domain controls or to the clock multiplication or clock division features of the DLL. This symbol also does not provide access to the RST, or LOCKED pins of the DLL. For access to these features, a designer must use the library DLL primitives described in the following sections.

#### Source Clock Input — I

The I pin provides the user source clock, the clock signal on which the DLL operates, to the BUFGDLL. For the BUFGDLL macro the source clock frequency must fall in the low frequency range as specified in the data sheet. The BUFGDLL requires an external signal source clock. Therefore, only an external input port can source the signal that drives the BUFGDLL I pin.

#### Clock Output — O

The clock output pin O represents a delay-compensated version of the source clock (I) signal. This signal, sourced by a global clock buffer BUFG symbol, takes advantage of the dedicated global clock routing resources of the device.

The output clock has a 50/50 duty cycle unless you deactivate the duty cycle correction property.

## **CLKDLL Primitive Pin Descriptions**

The library CLKDLL primitives provide access to the complete set of DLL features needed when implementing more complex applications with the DLL.

#### Source Clock Input — CLKIN

The CLKIN pin provides the user source clock (the clock signal on which the DLL operates) to the DLL. The CLKIN frequency must fall in the ranges specified in the data sheet. A global clock buffer (BUFG) driven from another CLKDLL

or one of the global clock input buffers (IBUFG) must source this clock signal.

#### Feedback Clock Input — CLKFB

The DLL requires a reference or feedback signal to provide the delay-compensated output. Connect only the CLK0 or CLK2X DLL outputs to the feedback clock input (CLKFB) pin to provide the necessary feedback to the DLL. The feedback clock input can also be provided through one of the following pin.

IBUFG - Global Clock Input Pad

If an IBUFG sources the CLKFB pin, the following special rules apply.

- 1. An external input port must source the signal that drives the IBUFG I pin.
- The CLK2X output must feed back to the device if both the CLK0 and CLK2X outputs are driving off chip devices.
- That signal must directly drive only OBUFs and nothing else.

These rules enable the software determine which DLL clock output sources the CLKFB pin.

#### Reset Input — RST

When the reset pin RST activates the LOCKED signal deactivates within four source clock cycles. The RST pin, active High, must either connect to a dynamic signal or tied to ground. As the DLL delay taps reset to zero, glitches can occur on the DLL clock output pins. Activation of the RST pin can also severely affect the duty cycle of the clock output pins. Furthermore, the DLL output clocks no longer deskew with respect to one another. For these reasons, rarely use the reset pin unless re-configuring the device or changing the input frequency.

#### 2x Clock Output — CLK2X

The output pin CLK2X provides a frequency-doubled clock with an automatic 50/50 duty-cycle correction. Until the CLKDLL has achieved lock, the CLK2X output appears as a 1x version of the input clock with a 25/75 duty cycle. This behavior allows the DLL to lock on the correct edge with respect to source clock. This pin is not available on the CLKDLLHF primitive.

#### Clock Divide Output — CLKDV

The clock divide output pin CLKDV provides a lower frequency version of the source clock. The CLKDV\_DIVIDE property controls CLKDV such that the source clock is divided by N where N is either 1.5, 2, 2.5, 3, 4, 5, 8, or 16.

This feature provides automatic duty cycle correction such that the CLKDV output pin always has a 50/50 duty cycle.

#### 1x Clock Outputs — CLK[0|90|180|270]

The 1x clock output pin CLK0 represents a delay-compensated version of the source clock (CLKIN) signal. The



CLKDLL primitive provides three phase-shifted versions of the CLKO signal while CLKDLLHF provides only the 180 phase-shifted version. The relationship between phase shift and the corresponding period shift appears in Table 9.

The timing diagrams in Figure 25 illustrate the DLL clock output characteristics.

Table 9: Relationship of Phase-Shifted Output Clock to Period Shift

Phase (degrees)	Period Shift (percent)
0	0%
90	25%
180	50%
270	75%

The DLL provides duty cycle correction on all 1x clock outputs such that all 1x clock outputs by default have a 50/50 duty cycle. The DUTY\_CYCLE\_CORRECTION property (TRUE by default), controls this feature. In order to deactivate the DLL duty cycle correction, attach the DUTY\_CYCLE\_CORRECTION=FALSE property to the DLL symbol. When duty cycle correction deactivates, the output clock has the same duty cycle as the source clock.

The DLL clock outputs can drive an OBUF, a BUFG, or they can route directly to destination clock pins. The DLL clock outputs can only drive the BUFGs that reside on the same edge (top or bottom).

#### Locked Output — LOCKED

In order to achieve lock, the DLL may need to sample several thousand clock cycles. After the DLL achieves lock the LOCKED signal activates. The DLL timing parameter section of the data sheet provides estimates for locking times.

In order to guarantee that the system clock is established prior to the device "waking up," the DLL can delay the completion of the device configuration process until after the DLL locks. The STARTUP\_WAIT property activates this feature.

Until the LOCKED signal activates, the DLL output clocks are not valid and can exhibit glitches, spikes, or other spurious movement. In particular the CLK2X output will appear as a 1x clock with a 25/75 duty cycle.

### **DLL Properties**

Properties provide access to some of the Spartan-II family DLL features, (for example, clock division and duty cycle correction).

#### **Duty Cycle Correction Property**

The 1x clock outputs, CLK0, CLK90, CLK180, and CLK270, use the duty-cycle corrected default, exhibiting a 50/50 duty cycle. The DUTY\_CYCLE\_CORRECTION property (by default TRUE) controls this feature. To deactivate the DLL

duty-cycle correction for the 1x clock outputs, attach the DUTY\_CYCLE\_CORRECTION=FALSE property to the DLL symbol. When duty-cycle correction deactivates, the output clock has the same duty cycle as the source clock.

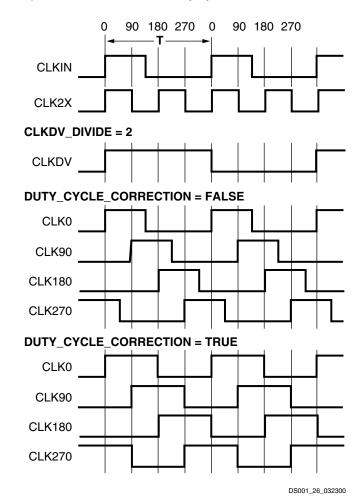


Figure 25: DLL Output Characteristics

#### Clock Divide Property

The CLKDV\_DIVIDE property specifies how the signal on the CLKDV pin is frequency divided with respect to the CLK0 pin. The values allowed for this property are 1.5, 2, 2.5, 3, 4, 5, 8, or 16; the default value is 2.

#### Startup Delay Property

This property, STARTUP\_WAIT, takes on a value of TRUE or FALSE (the default value). When TRUE the device configuration DONE signal waits until the DLL locks before going to High.

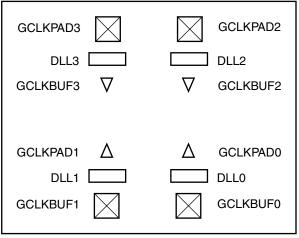
#### **DLL Location Constraints**

The DLLs are distributed such that there is one DLL in each corner of the device. The location constraint LOC, attached to the DLL symbol with the numeric identifier 0, 1, 2, or 3, controls DLL location. The orientation of the four DLLs and their corresponding clock resources appears in Figure 26.



The LOC property uses the following form.

LOC = DLL2



DS001\_27\_032300

Figure 26: Orientation of DLLs

## **Design Factors**

Use the following design considerations to avoid pitfalls and improve success designing with Xilinx devices.

#### Input Clock

The output clock signal of a DLL, essentially a delayed version of the input clock signal, reflects any instability on the input clock in the output waveform. For this reason the quality of the DLL input clock relates directly to the quality of the output clock waveforms generated by the DLL. The DLL input clock requirements are specified in the data sheet.

In most systems a crystal oscillator generates the system clock. The DLL can be used with any commercially available quartz crystal oscillator. For example, most crystal oscillators produce an output waveform with a frequency tolerance of 100 PPM, meaning 0.01 percent change in the clock period. The DLL operates reliably on an input waveform with a frequency drift of up to 1 ns — orders of magnitude in excess of that needed to support any crystal oscillator in the industry. However, the cycle-to-cycle jitter must be kept to less than 300 ps in the low frequencies and 150 ps for the high frequencies.

#### Input Clock Changes

Changing the period of the input clock beyond the maximum drift amount requires a manual reset of the CLKDLL. Failure to reset the DLL will produce an unreliable lock signal and output clock.

It is possible to stop the input clock with little impact to the DLL. Stopping the clock should be limited to less than 100  $\mu s$  to keep device cooling to a minimum. The clock should be stopped during a Low phase, and when restored

the full High period should be seen. During this time LOCKED will stay High and remain High when the clock is restored.

When the clock is stopped, one to four more clocks will still be observed as the delay line is flushed. When the clock is restarted, the output clocks will not be observed for one to four clocks as the delay line is filled. The most common case will be two or three clocks.

In a similar manner, a phase shift of the input clock is also possible. The phase shift will propagate to the output one to four clocks after the original shift, with no disruption to the CLKDLL control.

#### **Output Clocks**

As mentioned earlier in the DLL pin descriptions, some restrictions apply regarding the connectivity of the output pins. The DLL clock outputs can drive an OBUF, a global clock buffer BUFG, or they can route directly to destination clock pins. The only BUFGs that the DLL clock outputs can drive are the two on the same edge of the device (top or bottom).

Do not use the DLL output clock signals until after activation of the LOCKED signal. Prior to the activation of the LOCKED signal, the DLL output clocks are not valid and can exhibit glitches, spikes, or other spurious movement.

#### **Useful Application Examples**

The Spartan-II DLL can be used in a variety of creative and useful applications. The following examples show some of the more common applications.

#### Standard Usage

The circuit shown in Figure 27 resembles the BUFGDLL macro implemented to provide access to the RST and LOCKED pins of the CLKDLL.

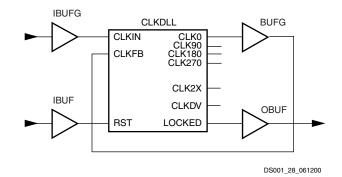


Figure 27: Standard DLL Implementation

#### Deskew of Clock and Its 2x Multiple

The circuit shown in Figure 28 implements a 2x clock multiplier and also uses the CLK0 clock output with zero ns skew between registers on the same chip. A clock divider circuit

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could alternatively be implemented using similar connections.

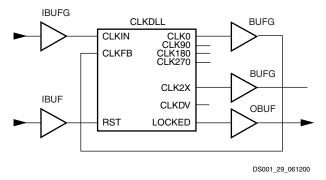


Figure 28: DLL Deskew of Clock and 2x Multiple

Because any single DLL can only access at most two BUFGs, any additional output clock signals must be routed from the DLL in this example on the high speed backbone routing.

#### Generating a 4x Clock

By connecting two DLL circuits each implementing a 2x clock multiplier in series as shown in Figure 29, a 4x clock multiply can be implemented with zero ns skew between registers in the same device.

If other clock output is needed, the clock could access a BUFG only if the DLLs are constrained to exist on opposite edges (Top or Bottom) of the device.

When using this circuit it is vital to use the SRL16 cell to reset the second DLL after the initial chip reset. If this is not done, the second DLL may not recognize the change of frequencies from when the input changes from a 1x (25/75) waveform to a 2x (50/50) waveform.

## **Using Block RAM Features**

The Spartan-II FPGA family provides dedicated blocks of on-chip, true dual-read/write port synchronous RAM, with 4096 memory cells. Each port of the block RAM memory can be independently configured as a read/write port, a read port, a write port, and can be configured to a specific data width. The block RAM memory offers new capabilities allowing the FPGA designer to simplify designs.

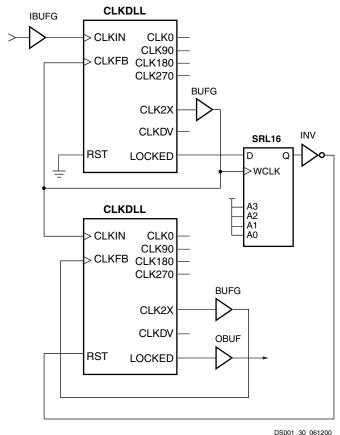
## **Operating Modes**

Block RAM memory supports two operating modes.

- Read Through
- Write Back

#### Read Through (One Clock Edge)

The read address is registered on the read port clock edge and data appears on the output after the RAM access time. Some memories may place the latch/register at the outputs depending on the desire to have a faster clock-to-out versus setup time. This is generally considered to be an inferior solution since it changes the read operation to an asynchronous function with the possibility of missing an address/control line transition during the generation of the read pulse clock.



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Write Back (One Clock Edge)

The write address is registered on the write port clock edge and the data input is written to the memory and mirrored on the write port input.

Figure 29: DLL Generation of 4x Clock

#### **Block RAM Characteristics**

- 1. All inputs are registered with the port clock and have a setup to clock timing specification.
- All outputs have a read through or write back function depending on the state of the port WE pin. The outputs relative to the port clock are available after the clock-to-out timing specification.
- The block RAM are true SRAM memories and do not have a combinatorial path from the address to the output. The LUT cells in the CLBs are still available with this function.
- 4. The ports are completely independent from each other (*i.e.*, clocking, control, address, read/write function, and data width) without arbitration.



- 5. A write operation requires only one clock edge.
- 6. A read operation requires only one clock edge.

The output ports are latched with a self timed circuit to guarantee a glitch free read. The state of the output port will not change until the port executes another read or write operation.

## **Library Primitives**

Figure 30 and Figure 31 show the two generic library block RAM primitives. Table 10 describes all of the available primitives for synthesis and simulation.

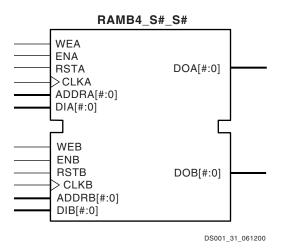


Figure 30: Dual-Port Block RAM Memory

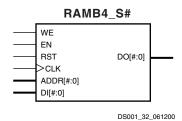


Figure 31: Single-Port Block RAM Memory

Table 10: Available Library Primitives

Primitive	Port A Width	Port B Width
RAMB4_S1	1	N/A
RAMB4_S1_S1		1
RAMB4_S1_S2		2
RAMB4_S1_S4		4
RAMB4_S1_S8		8
RAMB4_S1_S16		16
RAMB4_S2	2	N/A
RAMB4_S2_S2		2
RAMB4_S2_S4		4
RAMB4_S2_S8		8
RAMB4_S2_S16		16
RAMB4_S4	4	N/A
RAMB4_S4_S4		4
RAMB4_S4_S8		8
RAMB4_S4_S16		16
RAMB4_S8	8	N/A
RAMB4_S8_S8		8
RAMB4_S8_S16		16
RAMB4_S16	16	N/A
RAMB4_S16_S16		16



#### **Port Signals**

Each block RAM port operates independently of the others while accessing the same set of 4096 memory cells.

Table 11 describes the depth and width aspect ratios for the block RAM memory.

Table 11: Block RAM Port Aspect Ratios

Width	Depth	ADDR Bus	Data Bus
1	4096	ADDR<11:0>	DATA<0>
2	2048	ADDR<10:0>	DATA<1:0>
4	1024	ADDR<9:0>	DATA<3:0>
8	512	ADDR<8:0>	DATA<7:0>
16	256	ADDR<7:0>	DATA<15:0>

#### Clock—CLK[A|B]

Each port is fully synchronous with independent clock pins. All port input pins have setup time referenced to the port CLK pin. The data output bus has a clock-to-out time referenced to the CLK pin.

#### Enable—EN[A|B]

The enable pin affects the read, write and reset functionality of the port. Ports with an inactive enable pin keep the output pins in the previous state and do not write data to the memory cells.

#### Write Enable—WE[A|B]

Activating the write enable pin allows the port to write to the memory cells. When active, the contents of the data input bus are written to the RAM at the address pointed to by the address bus, and the new data also reflects on the data out bus. When inactive, a read operation occurs and the contents of the memory cells referenced by the address bus reflect on the data out bus.

#### Reset—RST[A|B]

The reset pin forces the data output bus latches to zero synchronously. This does not affect the memory cells of the RAM and does not disturb a write operation on the other port.

### Address Bus—ADDR[A|B]<#:0>

The address bus selects the memory cells for read or write. The width of the port determines the required width of this bus as shown in Table 11.

#### Data In Bus—DI[A|B]<#:0>

The data in bus provides the new data value to be written into the RAM. This bus and the port have the same width, as shown in Table 11.

#### Data Output Bus—DO[A|B]<#:0>

The data out bus reflects the contents of the memory cells referenced by the address bus at the last active clock edge. During a write operation, the data out bus reflects the data in bus. The width of this bus equals the width of the port. The allowed widths appear in Table 11.

### **Inverting Control Pins**

The four control pins (CLK, EN, WE and RST) for each port have independent inversion control as a configuration option.

#### **Address Mapping**

Each port accesses the same set of 4096 memory cells using an addressing scheme dependent on the width of the port. The physical RAM location addressed for a particular width are described in the following formula (of interest only when the two ports use different aspect ratios).

$$Start = ([ADDR_{port} + 1] * Width_{port}) - 1$$

$$End = ADDR_{port} * Width_{port}$$

Table 12 shows low order address mapping for each port width.

Table 12: Port Address Mapping

Port Widt h	Port Addresses																
1	4095	1	1	1	1	1	1	0	0	0	0	0	0	0	0	0	0
		5	4	3	2	1	0	9	8	7	6	5	4	3	2	1	0
2	2047	0	7	0	6	05		04		03		02		01		00	
4	1023		03 02					0	1			0	0				
8	511	01								0	0						
16	255								0	0							

#### **Creating Larger RAM Structures**

The block RAM columns have specialized routing to allow cascading blocks together with minimal routing delays. This achieves wider or deeper RAM structures with a smaller timing penalty than when using normal routing channels.

#### **Location Constraints**

Block RAM instances can have LOC properties attached to them to constrain the placement. The block RAM placement locations are separate from the CLB location naming convention, allowing the LOC properties to transfer easily from array to array.



The LOC properties use the following form:

LOC = RAMB4\_R#C#

RAMB4\_R0C0 is the upper left RAMB4 location on the device.

#### **Conflict Resolution**

The block RAM memory is a true dual-read/write port RAM that allows simultaneous access of the same memory cell from both ports. When one port writes to a given memory cell, the other port must not address that memory cell (for a write or a read) within the clock-to-clock setup window. The following lists specifics of port and memory cell write conflict resolution.

- If both ports write to the same memory cell simultaneously, violating the clock-to-clock setup requirement, consider the data stored as invalid.
- If one port attempts a read of the same memory cell the other simultaneously writes, violating the clock-to-clock setup requirement, the following occurs.
  - The write succeeds
  - The data out on the writing port accurately reflects the data written.
  - The data out on the reading port is invalid.

Conflicts do not cause any physical damage.

#### Single Port Timing

Figure 32 shows a timing diagram for a single port of a block RAM memory. The block RAM AC switching characteristics are specified in the data sheet. The block RAM memory is initially disabled.

At the first rising edge of the CLK pin, the ADDR, DI, EN, WE, and RST pins are sampled. The EN pin is High and the WE pin is Low indicating a read operation. The DO bus contains the contents of the memory location, 0x00, as indicated by the ADDR bus.

At the second rising edge of the CLK pin, the ADDR, DI, EN, WR, and RST pins are sampled again. The EN and WE pins are High indicating a write operation. The DO bus mirrors the DI bus. The DI bus is written to the memory location 0x0F.

At the third rising edge of the CLK pin, the ADDR, DI, EN, WR, and RST pins are sampled again. The EN pin is High and the WE pin is Low indicating a read operation. The DO bus contains the contents of the memory location 0x7E as indicated by the ADDR bus.

At the fourth rising edge of the CLK pin, the ADDR, DI, EN, WR, and RST pins are sampled again. The EN pin is Low indicating that the block RAM memory is now disabled. The DO bus retains the last value.

#### **Dual Port Timing**

Figure 33 shows a timing diagram for a true dual-port read/write block RAM memory. The clock on port A has a longer period than the clock on Port B. The timing parameter T<sub>BCCS</sub>, (clock-to-clock setup) is shown on this diagram. The parameter, T<sub>BCCS</sub> is violated once in the diagram. All other timing parameters are identical to the single port version shown in Figure 32.

T<sub>BCCS</sub> is only of importance when the address of both ports are the same and at least one port is performing a write operation. When the clock-to-clock set-up parameter is violated for a WRITE-WRITE condition, the contents of the memory at that location will be invalid. When the clock-to-clock set-up parameter is violated for a WRITE-READ condition, the contents of the memory will be correct, but the read port will have invalid data. At the first rising edge of the CLKA, memory location 0x00 is to be written with the value 0xAAAA and is mirrored on the DOA bus. The last operation of Port B was a read to the same memory location 0x00. The DOB bus of Port B does not change with the new value on Port A, and retains the last read value. A short time later. Port B executes another read to memory location 0x00, and the DOB bus now reflects the new memory value written by Port A.

At the second rising edge of CLKA, memory location 0x7E is written with the value 0x9999 and is mirrored on the DOA bus. Port B then executes a read operation to the same memory location without violating the  $T_{BCCS}$  parameter and the DOB reflects the new memory values written by Port A.



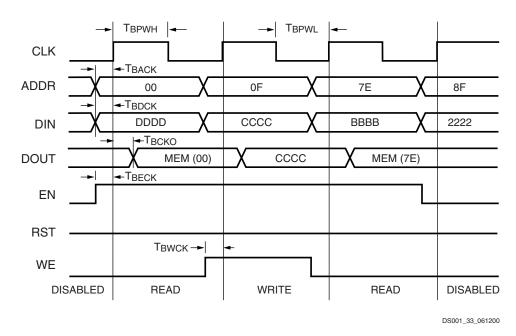


Figure 32: Timing Diagram for Single-Port Block RAM Memory

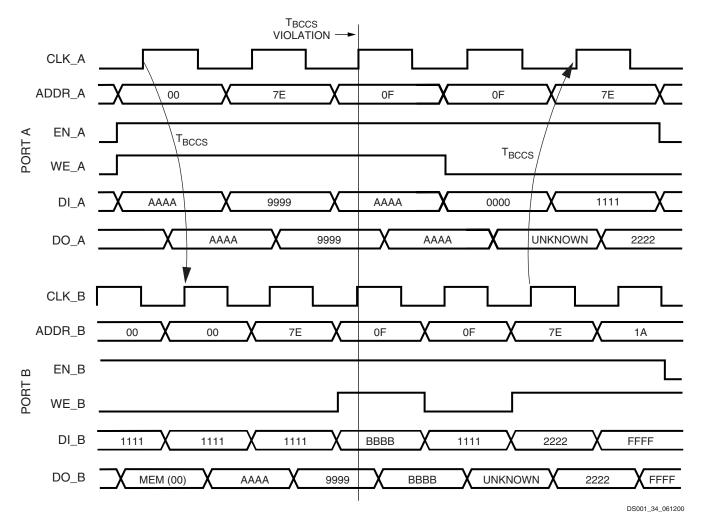


Figure 33: Timing Diagram for a True Dual-Port Read/Write Block RAM Memory



At the third rising edge of CLKA, the T<sub>BCCS</sub> parameter is violated with two writes to memory location 0x0F. The DOA and DOB busses reflect the contents of the DIA and DIB busses, but the stored value at 0x7E is invalid.

At the fourth rising edge of CLKA, a read operation is performed at memory location 0x0F and invalid data is present on the DOA bus. Port B also executes a read operation to memory location 0x0F and also reads invalid data.

At the fifth rising edge of CLKA a read operation is performed that does not violate the  $T_{BCCS}$  parameter to the previous write of 0x7E by Port B. THe DOA bus reflects the recently written value by Port B.

#### Initialization

The block RAM memory can initialize during the device configuration sequence. The 16 initialization properties of 64 hex values each (a total of 4096 bits) set the initialization of each RAM. These properties appear in Table 13. Any initialization properties not explicitly set configure as zeros. Partial initialization strings pad with zeros. Initialization strings greater than 64 hex values generate an error. The RAMs can be simulated with the initialization values using generics in VHDL simulators and parameters in Verilog simulators.

### Initialization in VHDL and Synopsys

The block RAM structures may be initialized in VHDL for both simulation and synthesis for inclusion in the EDIF output file. The simulation of the VHDL code uses a generic to pass the initialization. Synopsys FPGA compiler does not presently support generics. The initialization values instead attach as attributes to the RAM by a built-in Synopsys dc\_script. The translate\_off statement stops synthesis translation of the generic statements. The following code illustrates a module that employs these techniques.

#### Initialization in Verilog and Synopsys

The block RAM structures may be initialized in Verilog for both simulation and synthesis for inclusion in the EDIF output file. The simulation of the Verilog code uses a defparam to pass the initialization. The Synopsys FPGA compiler does not presently support defparam. The initialization values instead attach as attributes to the RAM by a built-in Synopsys dc\_script. The translate\_off statement stops synthesis translation of the defparam statements. The following code illustrates a module that employs these techniques.

#### **Block Memory Generation**

The CoreGen program generates memory structures using the block RAM features. This program outputs VHDL or Verilog simulation code templates and an EDIF file for inclusion in a design.

Table 13: RAM Initialization Properties

Property	Memory Cells
INIT_00	255 to 0
INIT_01	511 to 256
INIT_02	767 to 512
INIT_03	1023 to 768
INIT_04	1279 to 1024
INIT_05	1535 to 1280
INIT_06	1791 to 1536
INIT_07	2047 to 1792
INIT_08	2303 to 2048
INIT_09	2559 to 2304
INIT_0a	2815 to 2560
INIT_0b	3071 to 2816
INIT_0c	3327 to 3072
INIT_0d	3583 to 3328
INIT_0e	3839 to 3584
INIT_0f	4095 to 3840

## **Using Versatile I/O**

The Spartan-II FPGA family includes a highly configurable, high-performance I/O resource called Versatile I/O to provide support for a wide variety of I/O standards. The Versatile I/O resource is a robust set of features including programmable control of output drive strength, slew rate, and input delay and hold time. Taking advantage of the flexibility and Versatile I/O features and the design considerations described in this document can improve and simplify system level design.

#### Introduction

As FPGAs continue to grow in size and capacity, the larger and more complex systems designed for them demand an increased variety of I/O standards. Furthermore, as system clock speeds continue to increase, the need for high-performance I/O becomes more important. While chip-to-chip delays have an increasingly substantial impact on overall system speed, the task of achieving the desired system performance becomes more difficult with the proliferation of low-voltage I/O standards. Versatile I/O, the revolutionary input/output resources of Spartan-II devices, has resolved this potential problem by providing a highly configurable, high-performance alternative to the I/O resources of more conventional programmable devices. The Spartan-II Versatile I/O features combine the flexibility and time-to-market advantages of programmable logic with the high perfor-



mance previously available only with ASICs and custom ICs.

Each Versatile I/O block can support up to 16 I/O standards. Supporting such a variety of I/O standards allows the support of a wide variety of applications, from general purpose standard applications to high-speed low-voltage memory busses.

Versatile I/O blocks also provide selectable output drive strengths and programmable slew rates for the LVTTL output buffers, as well as an optional, programmable weak pull-up, weak pull-down, or weak "keeper" circuit ideal for use in external bussing applications.

Each Input/Output Block (IOB) includes three registers, one each for the input, output, and 3-state signals within the IOB. These registers are optionally configurable as either a D-type flip-flop or as a level sensitive latch.

The input buffer has an optional delay element used to guarantee a zero hold time requirement for input signals registered within the IOB.

The Versatile I/O features also provide dedicated resources for input reference voltage ( $V_{REF}$ ) and output source voltage ( $V_{CCO}$ ), along with a convenient banking system that simplifies board design.

By taking advantage of the built-in features and wide variety of I/O standards supported by the Versatile I/O features, system-level design and board design can be greatly simplified and improved.

### **Fundamentals**

Modern bus applications, pioneered by the largest and most influential companies in the digital electronics industry, are commonly introduced with a new I/O standard tailored specifically to the needs of that application. The bus I/O standards provide specifications to other vendors who create products designed to interface with these applications. Each standard often has its own specifications for current, voltage, I/O buffering, and termination techniques.

The ability to provide the flexibility and time-to-market advantages of programmable logic is increasingly dependent on the capability of the programmable logic device to support an ever increasing variety of I/O standards

The Versatile I/O resources feature highly configurable input and output buffers which provide support for a wide variety of I/O standards. As shown in Table 14, each buffer type can support a variety of voltage requirements.

Table 14: Versatile I/O Supported Standards (Typical Values)

I/O Standard	Input Reference Voltage (V <sub>REF</sub> )	Output Source Voltage (V <sub>CCO</sub> )	Board Termination Voltage (V <sub>TT</sub> )
LVTTL (2-24 mA)	N/A	3.3	N/A
LVCMOS2	N/A	2.5	N/A
PCI (3V/5V, 33 MHz/66 MHz)	N/A	3.3	N/A
GTL	0.8	N/A	1.2
GTL+	1.0	N/A	1.5
HSTL Class I	0.75	1.5	0.75
HSTL Class III	0.9	1.5	1.5
HSTL Class IV	0.9	1.5	1.5
SSTL3 Class I and II	1.5	3.3	1.5
SSTL2 Class I and II	1.25	2.5	1.25
СТТ	1.5	3.3	1.5
AGP-2X	1.32	3.3	N/A

# Overview of Supported I/O Standards

This section provides a brief overview of the I/O standards supported by all Spartan-II devices.

While most I/O standards specify a range of allowed voltages, this document records typical voltage values only. Detailed information on each specification may be found on the Electronic Industry Alliance Jedec website at <a href="http://www.iedec.org">http://www.iedec.org</a>

### LVTTL — Low-Voltage TTL

The Low-Voltage TTL (LVTTL) standard is a general purpose EIA/JESDSA standard for 3.3V applications that uses an LVTTL input buffer and a Push-Pull output buffer. This standard requires a 3.3V output source voltage ( $V_{CCO}$ ), but does not require the use of a reference voltage ( $V_{REF}$ ) or a termination voltage ( $V_{TT}$ ).

# LVCMOS2 — Low-Voltage CMOS for 2.5V

The Low-Voltage CMOS for 2.5V or lower (LVCMOS2) standard is an extension of the LVCMOS standard (JESD 8.5) used for general purpose 2.5V applications. This standard requires a 2.5V output source voltage ( $V_{CCO}$ ), but does not require the use of a reference voltage ( $V_{REF}$ ) or a board termination voltage ( $V_{TT}$ ).



### PCI — Peripheral Component Interface

The Peripheral Component Interface (PCI) standard specifies support for both 33 MHz and 66 MHz PCI bus applications. It uses a LVTTL input buffer and a push-pull output buffer. This standard does not require the use of a reference voltage ( $V_{REF}$ ) or a board termination voltage ( $V_{TT}$ ), however, it does require a 3.3V output source voltage ( $V_{CCO}$ ). I/Os configured for the PCI, 33 MHz, 5V standard are also 5V-tolerant.

### GTL — Gunning Transceiver Logic Terminated

The Gunning Transceiver Logic (GTL) standard is a high-speed bus standard (JESD8.3) invented by Xerox. Xilinx has implemented the terminated variation of this standard. This standard requires a differential amplifier input buffer and an open-drain output buffer.

### GTL+ — Gunning Transceiver Logic Plus

The Gunning Transceiver Logic Plus (GTL+) standard is a high-speed bus standard (JESD8.3) first used by the Pentium Pro processor.

### HSTL — High-Speed Transceiver Logic

The High-Speed Transceiver Logic (HSTL) standard is a general purpose high-speed, 1.5V bus standard sponsored by IBM (EIA/JESD 8-6). This standard has four variations or classes. Versatile I/O devices support Class I, III, and IV. This standard requires a Differential Amplifier input buffer and a Push-Pull output buffer.

### SSTL3 — Stub Series Terminated Logic for 3.3V

The Stub Series Terminated Logic for 3.3V (SSTL3) standard is a general purpose 3.3V memory bus standard also sponsored by Hitachi and IBM (JESD8-8). This standard has two classes, I and II. Versatile I/O devices support both classes for the SSTL3 standard. This standard requires a Differential Amplifier input buffer and an Push-Pull output buffer.

### SSTL2 — Stub Series Terminated Logic for 2.5V

The Stub Series Terminated Logic for 2.5V (SSTL2) standard is a general purpose 2.5V memory bus standard sponsored by Hitachi and IBM (JESD8-9). This standard has two classes, I and II. Versatile I/O devices support both classes for the SSTL2 standard. This standard requires a Differential Amplifier input buffer and an Push-Pull output buffer.

### CTT — Center Tap Terminated

The Center Tap Terminated (CTT) standard is a 3.3V memory bus standard sponsored by Fujitsu (JESD8-4). This standard requires a Differential Amplifier input buffer and a Push-Pull output buffer.

### AGP-2X — Advanced Graphics Port

The Intel AGP standard is a 3.3V Advanced Graphics Port-2X bus standard used with the Pentium II processor for

graphics applications. This standard requires a Push-Pull output buffer and a Differential Amplifier input buffer.

# **Library Symbols**

The Xilinx library includes an extensive list of symbols designed to provide support for the variety of Versatile I/O features. Most of these symbols represent variations of the five generic Versatile I/O symbols:

- IBUF (input buffer)
- IBUFG (global clock input buffer)
- OBUF (output buffer)
- OBUFT (3-state output buffer)
- IOBUF (input/output buffer)

### **IBUF**

Signals used as inputs to the Spartan-II device must source an input buffer (IBUF) via an external input port. The generic IBUF symbol appears in Figure 34. The extension to the base name defines which I/O standard the IBUF uses. The assumed standard is LVTTL when the generic IBUF has no specified extension.

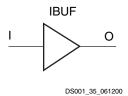


Figure 34: Input Buffer (IBUF) Symbols

The following list details the variations of the IBUF symbol:

- IBUF
- IBUF LVCMOS2
- IBUF PCI33 3
- IBUF\_PCI33\_5
- IBUF PCI66 3
- IBUF\_GTL
- IBUF\_GTLP
- IBUF\_HSTL\_I
- IBUF HSTL III
- IBUF\_HSTL\_IV
- IBUF\_SSTL3\_I
- IBUF SSTL3 II
- IBUF\_SSTL2\_I
- IBUF\_SSTL2\_II
- IBUF\_CTT
- IBUF AGP

When the IBUF symbol supports an I/O standard such as LVTTL, LVCMOS, or PCI33\_5, the IBUF automatically configures as a 5V tolerant input buffer unless the  $V_{\rm CCO}$  for the bank is less than 2V. If the single-ended IBUF is placed in a

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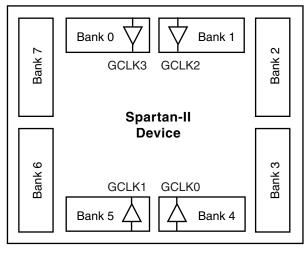
bank with an HSTL standard ( $V_{CCO}$  < 2V), the input buffer is not 5V tolerant.

The voltage reference signal is "banked" within the Spartan-II device on a half-edge basis such that for all packages there are eight independent  $V_{REF}$  banks internally. See Figure 35 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a  $V_{REF}$  input.

IBUF placement restrictions require that any differential amplifier input signals within a bank be of the same standard. How to specify a specific location for the IBUF via the LOC property is described below. Table 15 summarizes the input standards compatibility requirements.

An optional delay element is associated with each IBUF. When the IBUF drives a flip-flop within the IOB, the delay element by default activates to ensure a zero hold-time requirement. The NODELAY=TRUE property overrides this default.

When the IBUF does not drive a flip-flop within the IOB, the delay element de-activates by default to provide higher performance. To delay the input signal, activate the delay element with the DELAY=TRUE property.



DS001\_03\_060100

Figure 35: I/O Banks

**Table 15: Xilinx Input Standards Compatibility Requirements** 

Rule 1	All differential amplifier input signals within a bank are required to be of the same standard.
Rule 2	There are no placement restrictions for inputs with standards that require a single-ended input buffer.

### **IBUFG**

Signals used as high fanout clock inputs to the Spartan-II device should drive a global clock input buffer (IBUFG) via an external input port in order to take advan-

tage of one of the four dedicated global clock distribution networks. The output of the IBUFG symbol can only drive a CLKDLL, CLKDLLHF, or a BUFG symbol. The generic IBUFG symbol appears in Figure 36.

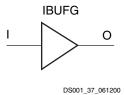


Figure 36: Global Clock Input Buffer (IBUFG) Symbol

The extension to the base name determines which I/O standard is used by the IBUFG. With no extension specified for the generic IBUFG symbol, the assumed standard is LVTTL.

The following list details variations of the IBUFG symbol.

- IBUFG
- IBUFG\_LVCMOS2
- IBUFG PCI33 3
- IBUFG\_PCI33\_5
- IBUFG\_PCI66\_3
- IBUFG GTL
- IBUFG GTLP
- IBUFG\_HSTL\_I
- IBUFG\_HSTL\_III
- IBUFG\_HSTL\_IV
- IBUFG\_SSTL3\_I
- IBUFG\_SSTL3\_II
- IBUFG SSTL2 I
- IBUFG\_SSTL2\_II
- IBUFG\_CTT
- IBUFG AGP

The voltage reference signal is "banked" within the Spartan-II device on a half-edge basis such that for all packages there are eight independent  $V_{REF}$  banks internally. See Figure 35 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a  $V_{REF}$  input.

IBUFG placement restrictions require any differential amplifier input signals within a bank be of the same standard. The LOC property can specify a location for the IBUFG.

As an added convenience, the BUFGP can be used to instantiate a high fanout clock input. The BUFGP symbol represents a combination of the LVTTL IBUFG and BUFG symbols, such that the output of the BUFGP can connect directly to the clock pins throughout the design.

The Spartan-II BUFGP symbol can only be placed in a global clock pad location. The LOC property can specify a location for the BUFGP.



### **OBUF**

An OBUF must drive outputs through an external output port. The generic output buffer (OBUF) symbol appears in Figure 37.

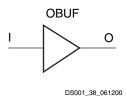


Figure 37: Output Buffer (OBUF) Symbol

The extension to the base name defines which I/O standard the OBUF uses. With no extension specified for the generic OBUF symbol, the assumed standard is slew rate limited LVTTL with 12 mA drive strength.

The LVTTL OBUF additionally can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL output buffers have selectable drive strengths.

The format for LVTTL OBUF symbol names is as follows.

<slew\_rate> is either F (Fast), or S (Slow) and
<drive\_strength> is specified in milliamps (2, 4, 6, 8, 12, 16,
or 24).

The following list details variations of the OBUF symbol.

- OBUF
- OBUF S 2
- OBUF S 4
- OBUF\_S\_6
- OBUF\_S\_8
- OBUF S 12
- OBUF S 16
- OBUF\_S\_24
- OBUF F 2
- OBUF\_F\_4
- OBUF\_F\_6
- OBUF\_F\_8
- OBUF\_F\_12
- OBUF F 24
- 020. \_. \_2 .
- OBUF\_LVCMOS2

OBUF F 16

- OBUF\_PCI33\_3
- OBUF PCI33 5
- OBUF\_PCI66\_3

- OBUF\_GTL
- OBUF GTLP
- OBUF HSTL I
- OBUF\_HSTL\_III
- OBUF\_HSTL\_IV
- OBUF\_SSTL3\_I
- OBUF\_SSTL3\_II
- OBUF\_SSTL2\_I
- OBUF\_SSTL2\_II
- OBUF CTT
- OBUF\_AGP

OBUF placement restrictions require that within a given  $V_{CCO}$  bank each OBUF share the same output source drive voltage. Input buffers of any type and output buffers that do not require  $V_{CCO}$  can be placed within any  $V_{CCO}$  bank. Table 16 summarizes the output compatibility requirements. The LOC property can specify a location for the OBUF.

**Table 16: Output Standards Compatibility Requirements** 

Rule 1	Only outputs with standards which share compatible $V_{\text{CCO}}$ may be used within the same bank.
Rule 2	There are no placement restrictions for outputs with standards that do not require a $V_{\text{CCO}}$ .
V <sub>CCO</sub>	Compatible Standards
3.3	LVTTL, SSTL3_I, SSTL3_II, CTT, AGP, GTL, GTL+, PCl33_3, PCl66_3
2.5	SSTL2_I, SSTL2_II, LVCMOS2, GTL, GTL+
1.5	HSTL_I, HSTL_III, HSTL_IV, GTL, GTL+

### **OBUFT**

The generic 3-state output buffer OBUFT, shown in Figure 38, typically implements 3-state outputs or bidirectional I/O.

The extension to the base name defines which I/O standard OBUFT uses. With no extension specified for the generic OBUFT symbol, the assumed standard is slew rate limited LVTTL with 12 mA drive strength.

The LVTTL OBUFT additionally can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL 3-state output buffers have selectable drive strengths.

The format for LVTTL OBUFT symbol names is as follows.

OBUFT\_<slew\_rate>\_<drive\_strength>

<slew\_rate> can be either F (Fast), or S (Slow) and
<drive\_strength> is specified in milliamps (2, 4, 6, 8, 12, 16,
or 24).

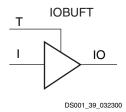


Figure 38: 3-State Output Buffer Symbol (OBUFT

The following list details variations of the OBUFT symbol.

- OBUFT
- OBUFT S 2
- OBUFT S 4
- OBUFT S 6
- OBUFT\_S\_8
- OBUFT S 12
- OBUFT\_S\_16
- OBUFT\_S\_24
- OBUFT\_F\_2
- OBUFT\_F\_4
- OBUFT\_F\_6
- OBUFT\_F\_8
- OBUFT\_F\_12
- OBUFT\_F\_16
- OBUFT F 24
- OBUFT LVCMOS2
- OBUFT PCI33 3
- OBUFT\_PCI33\_5
- OBUFT PCI66 3
- OBUFT\_GTL
- OBUFT GTLP
- OBUFT\_HSTL\_I
- OBUFT\_HSTL\_III
- OBUFT\_HSTL\_IV
- OBUFT\_SSTL3\_I
- OBUFT\_SSTL3\_II
- OBUFT\_SSTL2\_I
- OBUFT\_SSTL2\_II
- OBUFT\_CTT
- OBUFT AGP

The Versatile I/O OBUFT placement restrictions require that within a given  $V_{CCO}$  bank each OBUFT share the same output source drive voltage. Input buffers of any type and output buffers that do not require  $V_{CCO}$  can be placed within the same  $V_{CCO}$  bank.

The LOC property can specify a location for the OBUFT.

3-state output buffers and bidirectional buffers can have either a weak pull-up resistor, a weak pull-down resistor, or a weak "keeper" circuit. Control this feature by adding the appropriate symbol to the output net of the OBUFT (PULLUP, PULLDOWN, or KEEPER).

The weak "keeper" circuit requires the input buffer within the IOB to sample the I/O signal. So, OBUFTs programmed for an I/O standard that requires a  $V_{\text{REF}}$  have automatic placement of a  $V_{\text{REF}}$  in the bank with an OBUFT configured with a weak "keeper" circuit. This restriction does not affect most circuit design as applications using an OBUFT configured with a weak "keeper" typically implement a bidirectional I/O. In this case the IBUF (and the corresponding  $V_{\text{REF}}$ ) are explicitly placed.

The LOC property can specify a location for the OBUFT.

### **IOBUF**

Use the IOBUF symbol for bidirectional signals that require both an input buffer and a 3-state output buffer with an active high 3-state pin. The generic input/output buffer IOBUF appears in Figure 39.

The extension to the base name defines which I/O standard the IOBUF uses. With no extension specified for the generic IOBUF symbol, the assumed standard is LVTTL input buffer and slew rate limited LVTTL with 12 mA drive strength for the output buffer.

The LVTTL IOBUF additionally can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL bidirectional buffers have selectable output drive strengths.

The format for LVTTL IOBUF symbol names is as follows:

<slew\_rate> can be either F (Fast), or S (Slow) and <drive\_strength> is specified in milliamps (2, 4, 6, 8, 12, 16, or 24).

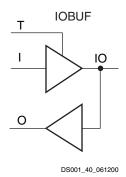


Figure 39: Input/Output Buffer Symbol (IOBUF)



The following list details variations of the IOBUF symbol:

- IOBUF
- IOBUF S 2
- IOBUF\_S\_4
- IOBUF S 6
- IOBUF\_S\_8
- IOBUF S 12
- IOBUF\_S\_16
- IOBUF\_S\_24
- IOBUF F 2
- IOBUF\_F\_4
- IOBUF\_F\_6
- IOBUF F 8
- IOBUF\_F\_12
- IOBUF\_F\_16
- IOBUF F 24
- IOBUF LVCMOS2
- IOBUF\_PCI33\_3
- IOBUF\_PCI33\_5
- IOBUF PCI66 3
- IOBUF\_GTL
- IOBUF GTLP
- IOBUF\_HSTL\_I
- IOBUF\_HSTL\_III
- IOBUF\_HSTL\_IV
- IOBUF SSTL3 I
- IOBUF\_SSTL3\_II
- IOBUF\_SSTL2\_I
- IOBUF SSTL2 II
- IOBUF CTT
- IOBUF AGP

When the IOBUF symbol supports an I/O standard such as LVTTL, LVCMOS, or PCI33\_5, the IBUF automatically configures as a 5V tolerant input buffer unless the  $V_{CCO}$  for the bank is less than 2V. If the single-ended IBUF is placed in a bank with an HSTL standard ( $V_{CCO}$  < 2V), the input buffer is not 5V tolerant.

The voltage reference signal is "banked" within the Spartan-II device on a half-edge basis such that for all packages there are eight independent  $V_{REF}$  banks internally. See Figure 35, page 32 for a representation of the Spartan-II I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a  $V_{REF}$  input.

Additional restrictions on the Versatile I/O IOBUF placement require that within a given  $V_{CCO}$  bank each IOBUF must share the same output source drive voltage. Input buffers of any type and output buffers that do not require  $V_{CCO}$  can be placed within the same  $V_{CCO}$  bank. The LOC property can specify a location for the IOBUF.

An optional delay element is associated with the input path in each IOBUF. When the IOBUF drives an input flip-flop within the IOB, the delay element activates by default to ensure a zero hold-time requirement. Override this default with the NODELAY=TRUE property.

In the case when the IOBUF does not drive an input flip-flop within the IOB, the delay element de-activates by default to provide higher performance. To delay the input signal, activate the delay element with the DELAY=TRUE property.

3-state output buffers and bidirectional buffers can have either a weak pull-up resistor, a weak pull-down resistor, or a weak "keeper" circuit. Control this feature by adding the appropriate symbol to the output net of the IOBUF (PULLUP, PULLDOWN, or KEEPER).

### **Versatile I/O Properties**

Access to some of the Versatile I/O features (for example, location constraints, input delay, output drive strength, and slew rate) is available through properties associated with these features.

### Input Delay Properties

An optional delay element is associated with each IBUF. When the IBUF drives a flip-flop within the IOB, the delay element activates by default to ensure a zero hold-time requirement. Use the NODELAY=TRUE property to override this default.

In the case when the IBUF does not drive a flip-flop within the IOB, the delay element by default de-activates to provide higher performance. To delay the input signal, activate the delay element with the DELAY=TRUE property.

### IOB Flip-Flop/Latch Property

The I/O Block (IOB) includes an optional register on the input path, an optional register on the output path, and an optional register on the 3-state control pin. The design implementation software automatically takes advantage of these registers when the following option for the Map program is specified:

map -pr b <filename>

Alternatively, the IOB = TRUE property can be placed on a register to force the mapper to place the register in an IOB.

### **Location Constraints**

Specify the location of each Versatile I/O symbol with the location constraint LOC attached to the Versatile I/O symbol. The external port identifier indicates the value of the location constrain. The format of the port identifier depends on the package chosen for the specific design.

The LOC properties use the following form:

LOC=A42

LOC=P37



### **Output Slew Rate Property**

As mentioned above, a variety of symbol names provide the option of choosing the desired slew rate for the output buffers. In the case of the LVTTL output buffers (OBUF, OBUFT, and IOBUF), slew rate control can be alternatively programed with the SLEW= property. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals. The SLEW= property has one of the two following values.

SLEW=SLOW SLEW=FAST

### **Output Drive Strength Property**

The desired output drive strength can be additionally specified by choosing the appropriate library symbol. The Xilinx library also provides an alternative method for specifying this feature. For the LVTTL output buffers (OBUF, OBUFT, and IOBUF, the desired drive strength can be specified with the DRIVE= property. This property could have one of the following seven values.

DRIVE=2

DRIVE=4

DRIVE=6

DRIVE=8

DRIVE=12 (Default)

DRIVE=16

DRIVE=24

# **Design Considerations**

# Reference Voltage (V<sub>REF</sub>) Pins

Low-voltage I/O standards with a differential amplifier input buffer require an input reference voltage ( $V_{REF}$ ). Provide the  $V_{REF}$  as an external signal to the device.

The voltage reference signal is "banked" within the device on a half-edge basis such that for all packages there are eight independent  $V_{REF}$  banks internally. See Figure 35, page 32 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a  $V_{REF}$  input.

Within each  $V_{\text{REF}}$  bank, any input buffers that require a  $V_{\text{REF}}$  signal must be of the same type. Output buffers of any

type and input buffers can be placed without requiring a reference voltage within the same  $V_{\mathsf{RFF}}$  bank.

# Output Drive Source Voltage (V<sub>CCO</sub>) Pins

Many of the low voltage I/O standards supported by Versatile I/Os require a different output drive source voltage ( $V_{\rm CCO}$ ). As a result each device can often have to support multiple output drive source voltages.

The  $V_{CCO}$  supplies are internally tied together for some packages. The VQ100 and the PQ208 provide one combined  $V_{CCO}$  supply. The TQ144 and the CS144 packages provide four independent  $V_{CCO}$  supplies. The FG256 and the FG456 provide eight independent  $V_{CCO}$  supplies.

Output buffers within a given  $V_{CCO}$  bank must share the same output drive source voltage. Input buffers for LVTTL, LVCMOS2, PCI33\_3, and PCI 66\_3 use the  $V_{CCO}$  voltage for Input  $V_{CCO}$  voltage.

### Transmission Line Effects

The delay of an electrical signal along a wire is dominated by the rise and fall times when the signal travels a short distance. Transmission line delays vary with inductance and capacitance, but a well-designed board can experience delays of approximately 180 ps per inch.

Transmission line effects, or reflections, typically start at 1.5" for fast (1.5 ns) rise and fall times. Poor (or non-existent) termination or changes in the transmission line impedance cause these reflections and can cause additional delay in longer traces. As system speeds continue to increase, the effect of I/O delays can become a limiting factor and therefore transmission line termination becomes increasingly more important.

### Termination Techniques

A variety of termination techniques reduce the impact of transmission line effects.

The following lists output termination techniques:

None

Series

Parallel (Shunt)

Series and Parallel (Series-Shunt)

Input termination techniques include the following:

None

Parallel (Shunt)



These termination techniques can be applied in any combination. A generic example of each combination of termination methods appears in Figure 40.

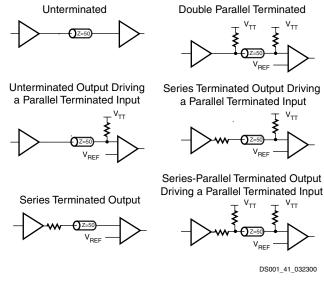


Figure 40: Overview of Standard Input and Output
Termination Methods

### Simultaneous Switching Guidelines

Ground bounce can occur with high-speed digital ICs when multiple outputs change states simultaneously, causing undesired transient behavior on an output, or in the internal logic. This problem is also referred to as the Simultaneous Switching Output (SSO) problem.

Ground bounce is primarily due to current changes in the combined inductance of ground pins, bond wires, and ground metallization. The IC internal ground level deviates from the external system ground level for a short duration (a few nanoseconds) after multiple outputs change state simultaneously.

Ground bounce affects stable Low outputs and all inputs because they interpret the incoming signal by comparing it to the internal ground. If the ground bounce amplitude exceeds the actual instantaneous noise margin, then a non-changing input can be interpreted as a short pulse with a polarity opposite to the ground bounce.

Table 17 provides the guidelines for the maximum number of simultaneously switching outputs allowed per output power/ground pair to avoid the effects of ground bounce. Refer to Table 18 for the number of effective output

power/ground pairs for each Spartan-II device and package combination.

Table 17: Maximum Number of Simultaneously Switching Outputs per Power/Ground Pair

Switching Outputs per Fower/Groun	Package		
Standard	CS, FG	PQ, TQ, VQ	
LVTTL Slow Slew Rate, 2 mA drive	68	36	
LVTTL Slow Slew Rate, 4 mA drive	41	20	
LVTTL Slow Slew Rate, 6 mA drive	29	15	
LVTTL Slow Slew Rate, 8 mA drive	22	12	
LVTTL Slow Slew Rate, 12 mA drive	17	9	
LVTTL Slow Slew Rate, 16 mA drive	14	7	
LVTTL Slow Slew Rate, 24 mA drive	9	5	
LVTTL Fast Slew Rate, 2 mA drive	40	21	
LVTTL Fast Slew Rate, 4 mA drive	24	12	
LVTTL Fast Slew Rate, 6 mA drive	17	9	
LVTTL Fast Slew Rate, 8 mA drive	13	7	
LVTTL Fast Slew Rate, 12 mA drive	10	5	
LVTTL Fast Slew Rate, 16 mA drive	8	4	
LVTTL Fast Slew Rate, 24 mA drive	5	3	
LVCMOS2	10	5	
PCI	8	4	
GTL	4	4	
GTL+	4	4	
HSTL Class I	18	9	
HSTL Class III	9	5	
HSTL Class IV	5	3	
SSTL2 Class I	15	8	
SSTL2 Class II	10	5	
SSTL3 Class I	11	6	
SSTL3 Class II	7	4	
СТТ	14	7	
AGP	9	5	

### Notes:

1. This analysis assumes a 35 pF load for each output.

**Table 18: Effective Output Power/Ground Pairs for Spartan-II Devices** 

	Spartan-II Devices					
Pkg.	XC2S 15	XC2S 30	XC2S 50	XC2S 100	XC2S 150	XC2S 200
VQ100	8	8	-	-	-	-
CS144	12	12	-	-	-	-
TQ144	12	12	12	12	-	-
PQ208	-	16	16	16	16	16
FG256	-	-	16	16	16	16
FG456	-	-	-	48	48	48

# **Termination Examples**

Creating a design with the Versatile I/O features requires the instantiation of the desired library symbol within the design code. At the board level, designers need to know the termination techniques required for each I/O standard.

This section describes some common application examples illustrating the termination techniques recommended by each of the standards supported by the Versatile I/O features. For a full range of accepted values for the DC voltage specifications for each standard, refer to the table associated with each figure.

The resistors used in each termination technique example and the transmission lines depicted represent board level components and are not meant to represent components on the device.

### GTL

A sample circuit illustrating a valid termination technique for GTL is shown in Figure 41. Table 19 lists DC voltage specifications.

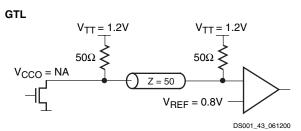


Figure 41: Terminated GTL

Table 19: GTL Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	-	N/A	-
$V_{REF} = N \times V_{TT}^{(1)}$	0.74	0.8	0.86
V <sub>TT</sub>	1.14	1.2	1.26
$V_{IH} \ge V_{REF} + 0.05$	0.79	0.85	-
$V_{IL} \le V_{REF} - 0.05$	-	0.75	0.81
V <sub>OH</sub>	-	-	-
V <sub>OL</sub>	-	0.2	0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA) at 0.4V	32	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA) at 0.2V	-	-	40

### Notes:

 N must be greater than or equal to 0.653 and less than or equal to 0.68.



### GTL+

A sample circuit illustrating a valid termination technique for GTL+ appears in Figure 42. DC voltage specifications appear in Table 20 .

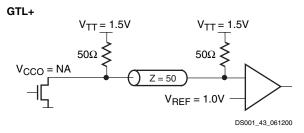


Figure 42: Terminated GTL+

Table 20: GTL+ Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	-	-	-
$V_{REF} = N \times V_{TT}^{(1)}$	0.88	1.0	1.12
V <sub>TT</sub>	1.35	1.5	1.65
V <sub>IH</sub> ≥ V <sub>REF</sub> + 0.1	0.98	1.1	-
V <sub>IL</sub> ≤V <sub>REF</sub> - 0.1	-	0.9	1.02
V <sub>OH</sub>	-	-	-
V <sub>OL</sub>	0.3	0.45	0.6
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA) at 0.6V	36	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA) at 0.3V	-	-	48

### Notes:

 N must be greater than or equal to 0.653 and less than or equal to 0.68.

### **HSTL Class I**

A sample circuit illustrating a valid termination technique for HSTL\_I appears in Figure 43. DC voltage specifications appear in Table 21.

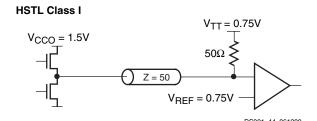


Figure 43: Terminated HSTL Class I

Table 21: HSTL Class I Voltage Specification

Parameter	Min	Тур	Max
V <sub>CCO</sub>	1.40	1.50	1.60
V <sub>REF</sub>	0.68	0.75	0.90
V <sub>TT</sub>	-	$V_{CCO} \times 0.5$	-
V <sub>IH</sub>	V <sub>REF</sub> + 0.1	-	-
V <sub>IL</sub>	-	-	V <sub>REF</sub> – 0.1
V <sub>OH</sub>	V <sub>CCO</sub> – 0.4	-	-
V <sub>OL</sub>			0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-8	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	8	-	-



### **HSTL Class III**

A sample circuit illustrating a valid termination technique for HSTL\_III appears in Figure 44. DC voltage specifications appear in Table 22.

# HSTL Class III $V_{CCO} = 1.5V$ $50\Omega$ $V_{REF} = 0.9V$

Figure 44: Terminated HSTL Class III

DS001 45 061200

### Table 22: HSTL Class III Voltage Specification

Parameter	Min	Тур	Max
V <sub>CCO</sub>	1.40	1.50	1.60
V <sub>REF</sub> (1)	-	0.90	-
V <sub>TT</sub>	-	V <sub>CCO</sub>	-
V <sub>IH</sub>	V <sub>REF</sub> + 0.1	-	-
V <sub>IL</sub>	-	-	V <sub>REF</sub> - 0.1
V <sub>OH</sub>	V <sub>CCO</sub> - 0.4	-	-
V <sub>OL</sub>	-	-	0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-8	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	24	-	-

### Notes:

 Per EIA/JESD8-6, "The value of V<sub>REF</sub> is to be selected by the user to provide optimum noise margin in the use conditions specified by the user."

### **HSTL Class IV**

A sample circuit illustrating a valid termination technique for HSTL\_IV appears in Figure 45.DC voltage specifications appear in Table 22

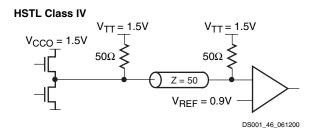


Figure 45: Terminated HSTL Class IV

### Table 23: HSTL Class IV Voltage Specification

Parameter	Min	Тур	Max
V <sub>CCO</sub>	1.40	1.50	1.60
V <sub>REF</sub>	-	0.90	-
V <sub>TT</sub>	-	V <sub>CCO</sub>	-
V <sub>IH</sub>	V <sub>REF</sub> + 0.1	-	-
V <sub>IL</sub>	-	-	V <sub>REF</sub> – 0.1
V <sub>OH</sub>	V <sub>CCO</sub> - 0.4	-	-
V <sub>OL</sub>	-	ı	0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-8	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	48	-	-

### Notes:

 Per EIA/JESD8-6, "The value of V<sub>REF</sub> is to be selected by the user to provide optimum noise margin in the use conditions specified by the user."



### SSTL3 Class I

A sample circuit illustrating a valid termination technique for SSTL3\_I appears in Figure 46. DC voltage specifications appear in Table 24.

### SSTL3 Class I

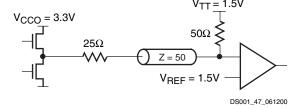


Figure 46: Terminated SSTL3 Class I

Table 24: SSTL3\_I Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
$V_{REF} = 0.45 \times V_{CCO}$	1.3	1.5	1.7
$V_{TT} = V_{REF}$	1.3	1.5	1.7
V <sub>IH</sub> ≥ V <sub>REF</sub> + 0.2	1.5	1.7	3.9(1)
$V_{IL} \le V_{REF} - 0.2$	-0.3 <sup>(2)</sup>	1.3	1.5
$V_{OH} \ge V_{REF} + 0.6$	1.9	-	-
$V_{OL} \le V_{REF} - 0.6$	-	-	1.1
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-8	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	8	-	-

### Notes:

- 1.  $V_{IH}$  maximum is  $V_{CCO} + 0.3$ .
- 2. V<sub>IL</sub> minimum does not conform to the formula.

### SSTL3 Class II

A sample circuit illustrating a valid termination technique for SSTL3\_II appears in Figure 47. DC voltage specifications appear in Table 25.

### SSTL3 Class II

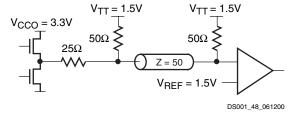


Figure 47: Terminated SSTL3 Class II

Table 25: SSTL3\_II Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
$V_{REF} = 0.45 \times V_{CCO}$	1.3	1.5	1.7
V <sub>TT</sub> = V <sub>REF</sub>	1.3	1.5	1.7
$V_{IH} \ge V_{REF} + 0.2$	1.5	1.7	3.9(1)
$V_{IL} \le V_{REF} - 0.2$	-0.3 <sup>(2)</sup>	1.3	1.5
$V_{OH} \ge V_{REF} + 0.8$	2.1	-	-
$V_{OL} \le V_{REF} - 0.8$	-	-	0.9
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-16	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	16	-	-

- 1.  $V_{IH}$  maximum is  $V_{CCO}$  + 0.3
- 2. V<sub>IL</sub> minimum does not conform to the formula



### SSTL2\_I

A sample circuit illustrating a valid termination technique for SSTL2\_I appears in Figure 48. DC voltage specifications appear in Table 26

### SSTL2 Class I

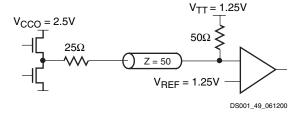


Figure 48: Terminated SSTL2 Class I

Table 26: SSTL2\_I Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	2.3	2.5	2.7
$V_{REF} = 0.5 \times V_{CCO}$	1.15	1.25	1.35
$V_{TT} = V_{REF} + N^{(1)}$	1.11	1.25	1.39
$V_{IH} \ge V_{REF} + 0.18$	1.33	1.43	3.0(2)
$V_{IL} \le V_{REF} - 0.18$	-0.3 <sup>(3)</sup>	1.07	1.17
V <sub>OH</sub> ≥ V <sub>REF</sub> + 0.61	1.76	-	-
V <sub>OL</sub> ≤ V <sub>REF</sub> - 0.61	-	-	0.74
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-7.6	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	7.6	-	-

### Notes:

- N must be greater than or equal to -0.04 and less than or equal to 0.04.
- 2.  $V_{IH}$  maximum is  $V_{CCO} + 0.3$ .
- 3. V<sub>IL</sub> minimum does not conform to the formula.

### SSTL2 Class II

A sample circuit illustrating a valid termination technique for SSTL2\_II appears in Figure 49. DC voltage specifications appear in Table 27.

### SSTL2 Class II

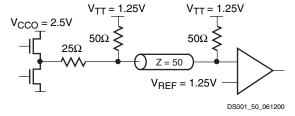


Figure 49: Terminated SSTL2 Class II

Table 27: SSTL2\_II Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	2.3	2.5	2.7
$V_{REF} = 0.5 \times V_{CCO}$	1.15	1.25	1.35
$V_{TT} = V_{REF} + N^{(1)}$	1.11	1.25	1.39
$V_{IH} \ge V_{REF} + 0.18$	1.33	1.43	3.0 <sup>(2)</sup>
$V_{IL} \le V_{REF} - 0.18$	-0.3 <sup>(3)</sup>	1.07	1.17
$V_{OH} \ge V_{REF} + 0.8$	1.95	-	-
V <sub>OL</sub> ≤V <sub>REF</sub> - 0.8	-	-	0.55
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-15.2	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	15.2	-	-

- N must be greater than or equal to -0.04 and less than or equal to 0.04.
- 2.  $V_{IH}$  maximum is  $V_{CCO} + 0.3$ .
- 3. V<sub>IL</sub> minimum does not conform to the formula.



### **CTT**

A sample circuit illustrating a valid termination technique for CTT appear in Figure 50. DC voltage specifications appear in Table 28.

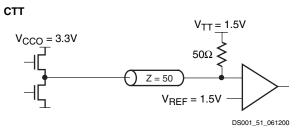


Figure 50: Terminated CTT

Table 28: CTT Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	2.05 <sup>(1)</sup>	3.3	3.6
V <sub>REF</sub>	1.35	1.5	1.65
V <sub>TT</sub>	1.35	1.5	1.65
$V_{IH} \ge V_{REF} + 0.2$	1.55	1.7	-
$V_{IL} \le V_{REF} - 0.2$	-	1.3	1.45
$V_{OH} \ge V_{REF} + 0.4$	1.75	1.9	-
$V_{OL} \le V_{REF} - 0.4$	-	1.1	1.25
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-8	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	8	-	-

### Notes:

1. Timing delays are calculated based on V<sub>CCO</sub> min of 3.0V.

### PCI33\_3 and PCI66\_3

PCI33\_3 or PCI66\_3 require no termination. DC voltage specifications appear in Table 29.

Table 29: PCI33\_3 and PCI66\_3 Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
V <sub>REF</sub>	-	-	-
V <sub>TT</sub>	-	-	-
$V_{IH} = 0.5 \times V_{CCO}$	1.5	1.65	V <sub>CCO</sub> + 0.5
$V_{IL} = 0.3 \times V_{CCO}$	-0.5	0.99	1.08
$V_{OH} = 0.9 \times V_{CCO}$	2.7	-	-
$V_{OL} = 0.1 \times V_{CCO}$	-	-	0.36
I <sub>OH</sub> at V <sub>OH</sub> (mA)	Note 1	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	Note 1	-	-

### Notes:

1. Tested according to the relevant specification.

### PCI33\_5

PCI33\_5 requires no termination. DC voltage specifications appear in Table 30.

Table 30: PCI33\_5 Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
V <sub>REF</sub>	-	-	-
V <sub>TT</sub>	-	-	-
V <sub>IH</sub>	1.425	1.5	5.5
V <sub>IL</sub>	-0.5	1.0	1.05
V <sub>OH</sub>	2.4	-	-
V <sub>OL</sub>	-	-	0.55
I <sub>OH</sub> at V <sub>OH</sub> (mA)	Note 1	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	Note 1	-	-

### Notes:

1. Tested according to the relevant specification.



### LVTTL

LVTTL requires no termination. DC voltage specifications appears in Table 31.

Table 31: LVTTL Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
V <sub>REF</sub>	-	-	-
V <sub>TT</sub>	-	-	-
V <sub>IH</sub>	2.0	-	5.5
V <sub>IL</sub>	-0.5	-	0.8
V <sub>OH</sub>	2.4	-	-
V <sub>OL</sub>	-	-	0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-24	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	24	-	-

### Notes:

### LVCMOS2

LVCMOS2 requires no termination. DC voltage specifications appear in Table 32.

Table 32: LVCMOS2 Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	2.3	2.5	2.7
V <sub>REF</sub>	-	-	-
V <sub>TT</sub>	-	-	-
V <sub>IH</sub>	1.7	-	5.5
V <sub>IL</sub>	-0.5	-	0.7
V <sub>OH</sub>	1.9	-	-
V <sub>OL</sub>	-	-	0.4
I <sub>OH</sub> at V <sub>OH</sub> (mA)	-12	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	12	-	-

### AGP-2X

The specification for the AGP-2X standard does not document a recommended termination technique. DC voltage specifications appear in Table 33.

Table 33: AGP-2X Voltage Specifications

Parameter	Min	Тур	Max
V <sub>CCO</sub>	3.0	3.3	3.6
$V_{REF} = N \times V_{CCO}^{(1)}$	1.17	1.32	1.48
V <sub>TT</sub>	-	-	-
$V_{IH} \ge V_{REF} + 0.2$	1.37	1.52	-
$V_{IL} \le V_{REF} - 0.2$	-	1.12	1.28
$V_{OH} \ge 0.9 \times V_{CCO}$	2.7	3.0	-
$V_{OL} \le 0.1 \times V_{CCO}$	-	0.33	0.36
I <sub>OH</sub> at V <sub>OH</sub> (mA)	Note 2	-	-
I <sub>OL</sub> at V <sub>OL</sub> (mA)	Note 2	-	_

- N must be greater than or equal to 0.39 and less than or equal to 0.41.
- 2. Tested according to the relevant specification.

<sup>1.</sup>  $V_{OL}$  and  $V_{OH}$  for lower drive currents sample tested.



# **Revision History**

Date	Version	Description
09/18/00	2.0	Sectioned the Spartan-II Family data sheet into four modules. Corrected banking description.
03/05/01	2.1	Clarified guidelines for applying power to V <sub>CCINT</sub> and V <sub>CCO</sub>
09/03/03	2.2	The following changes were made:
		Serial Modes, page 14 cautions about toggling WRITE during serial configuration.
		<ul> <li>Maximum V<sub>IH</sub> values in Table 31 and Table 32 changed to 5.5V.</li> </ul>
		• In Boundary Scan, page 7, removed sentence about lack of INTEST support.
		In Table 8, page 11, added note about the state of I/Os after power-on.
		<ul> <li>In Slave Parallel Mode, page 16, explained configuration bit alignment to SelectMap port.</li> </ul>

# The Spartan-II Family Data Sheet

DS001-1, Spartan-II 2.5V FPGA Family: Introduction and Ordering Information (Module 1)

DS001-2, Spartan-II 2.5V FPGA Family: Functional Description (Module 2)

DS001-3, Spartan-II 2.5V FPGA Family: DC and Switching Characteristics (Module 3)

DS001-4, Spartan-II 2.5V FPGA Family: Pinout Tables (Module 4)





# **Spartan-II 2.5V FPGA Family: DC and Switching Characteristics**

DS001-3 (v2.7) September 3, 2003

**Product Specification** 

### **Definition of Terms**

In this document, some specifications may be designated as Advance or Preliminary. These terms are defined as follows:

**Advance:** Initial estimates based on simulation and/or extrapolation from other speed grades, devices, or families. Values are subject to change. Use as estimates, not for production.

Preliminary: Based on preliminary characterization. Further changes are not expected.

Unmarked: Specifications not identified as either Advance or Preliminary are to be considered Final.

Except for pin-to-pin input and output parameters, the AC parameter delay specifications included in this document are derived from measuring internal test patterns. All limits are representative of worst-case supply voltage and junction temperature conditions. Typical numbers are based on measurements taken at a nominal V<sub>CCINT</sub> level of 2.5V and a junction temperature of 25°C. The parameters included are common to popular designs and typical applications. **All specifications are subject to change without notice.** 

# **DC Specifications**

# **Absolute Maximum Ratings**(1)

Symbol	Descriptio	Description		Max	Units
V <sub>CCINT</sub>	Supply voltage relative to GND <sup>(2)</sup>		-0.5	3.0	V
V <sub>CCO</sub>	Supply voltage relative to GND <sup>(2)</sup>		-0.5	4.0	V
V <sub>REF</sub>	Input reference voltage		-0.5	3.6	V
V <sub>IN</sub>	Input voltage relative to GND <sup>(3)</sup>	ge relative to GND <sup>(3)</sup> 5V tolerant I/O <sup>(4)</sup> No 5V tolerance <sup>(5)</sup>		5.5	V
				V <sub>CCO</sub> + 0.5	V
V <sub>TS</sub>	Voltage applied to 3-state output	5V tolerant I/O <sup>(4)</sup>	-0.5	5.5	V
		No 5V tolerance <sup>(5)</sup>		V <sub>CCO</sub> + 0.5	V
T <sub>STG</sub>	Storage temperature (ambient)		-65	+150	°C
T <sub>J</sub>	Junction temperature		-	+125	°C

### Notes:

- 1. Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time may affect device reliability.
- 2. Power supplies may turn on in any order.
- 3. V<sub>IN</sub> should not exceed V<sub>CCO</sub> by more than 3.6V over extended periods of time (e.g., longer than a day).
- 4. Spartan-II I/Os are 5V Tolerant whenever the LVTTL, LVCMOS2, or PCI33\_5 signal standard has been selected. With 5V Tolerant I/Os selected, the Maximum DC overshoot must be limited to either +5.5V or 10 mA, and undershoot must be limited to either -0.5V or 10 mA, whichever is easier to achieve. The Maximum AC conditions are as follows: The device pins may undershoot to -2.0V or overshoot to +7.0V, provided this over/undershoot lasts no more than 11 ns with a forcing current no greater than 100 mA.
- 5. Without 5V Tolerant I/Os selected, the Maximum DC overshoot must be limited to either V<sub>CCO</sub> + 0.5V or 10 mA, and undershoot must be limited to –0.5V or 10 mA, whichever is easier to achieve. The Maximum AC conditions are as follows: The device pins may undershoot to –2.0V or overshoot to V<sub>CCO</sub> + 2.0V, provided this over/undershoot lasts no more than 11 ns with a forcing current no greater than 100 mA.
- For soldering guidelines, see the Packaging Information on the Xilinx web site: http://www.xilinx.com/publications/products/packaging/index.htm

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# **Recommended Operating Conditions**

Symbol	Description		Min	Max	Units
T <sub>J</sub>	Junction temperature <sup>(1)</sup>	Commercial	0	85	°C
		Industrial	-40	100	°C
V <sub>CCINT</sub>	Supply voltage relative to GND <sup>(2,5)</sup>	Commercial	2.5 – 5%	2.5 + 5%	V
		Industrial	2.5 – 5%	2.5 + 5%	V
V <sub>CCO</sub>	Supply voltage relative to GND <sup>(3,5)</sup>	Commercial	1.4	3.6	V
		Industrial	1.4	3.6	V
T <sub>IN</sub>	Input signal transition time <sup>(4)</sup>		-	250	ns

### Notes:

- At junction temperatures above those listed as Operating Conditions, all delay parameters increase by 0.35% per °C. 1.
- Functional operation is guaranteed down to a minimum  $V_{CCINT}$  of 2.25V (Nominal  $V_{CCINT}$  10%). For every 50 mV reduction in  $V_{CCINT}$  below 2.375V (nominal  $V_{CCINT}$  5%), all delay parameters increase by 3%. Minimum and maximum values for  $V_{CCO}$  vary according to the I/O standard selected.
- Input and output measurement threshold is ~50% of V<sub>CCO</sub>.
- Supply voltages may be applied in any order desired.

# **DC Characteristics Over Operating Conditions**

Symbol	Description			Min	Тур	Max	Units
V <sub>DRINT</sub>	Data Retention V <sub>CCINT</sub> voltage (below may be lost)	Data Retention V <sub>CCINT</sub> voltage (below which configuration data may be lost)			-	-	V
V <sub>DRIO</sub>	Data Retention V <sub>CCO</sub> voltage (below be lost)	which configu	uration data may	1.2	-	-	V
I <sub>CCINTQ</sub>	Quiescent V <sub>CCINT</sub> supply current <sup>(1)</sup>	XC2S15	Commercial	-	10	30	mA
			Industrial	-	10	60	mA
		XC2S30	Commercial	-	10	30	mA
			Industrial	-	10	60	mA
		XC2S50 Commercial		-	12	50	mA
			Industrial	-	12	100	mA
		XC2S100 Commercia		-	12	50	mA
			Industrial	-	12	100	mA
		XC2S150	Commercial	-	15	50	mA
			Industrial	-	15	100	mA
		XC2S200	Commercial	-	15	75	mA
			Industrial	-	15	150	mA
Iccoq	Quiescent V <sub>CCO</sub> supply current <sup>(1)</sup>	-1-		-	-	2	mA
I <sub>REF</sub>	V <sub>REF</sub> current per V <sub>REF</sub> pin			-	-	20	μΑ
Ι <sub>L</sub>	Input or output leakage current <sup>(2)</sup>			-10	-	+10	μΑ
C <sub>IN</sub>	Input capacitance (sample tested)	VQ, CS, TQ, PQ, FG packages		-	-	8	pF
I <sub>RPU</sub>	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 3.3V$ (sample tested) $^{(3)}$		-	-	0.25	mA	
I <sub>RPD</sub>	Pad pull-down (when selected) @ V <sub>I</sub>	<sub>N</sub> = 3.6V (sai	mple tested) <sup>(3)</sup>	-	-	0.15	mA

- With no output current loads, no active input pull-up resistors, all I/O pins 3-stated and floating.
- The I/O leakage current specification applies only when the  $V_{CCINT}$  and  $V_{CCO}$  supply voltages have reached their respective minimum Recommended Operating Conditions.
- Internal pull-up and pull-down resistors guarantee valid logic levels at unconnected input pins. These pull-up and pull-down resistors do not provide valid logic levels when input pins are connected to other circuits.



### **Power-On Requirements**

Spartan-II FPGAs require that a minimum supply current  $I_{CCPO}$  be provided to the  $V_{CCINT}$  lines for a successful power-on. If more current is available, the FPGA can consume more than  $I_{CCPO}$  minimum, though this cannot adversely affect reliability.

A maximum limit for  $I_{CCPO}$  is not specified. Therefore the use of foldback/crowbar supplies and fuses deserves special attention. In these cases, limit the  $I_{CCPO}$  current to a level below the trip point for over-current protection in order to avoid inadvertently shutting down the supply.

		F		New Requirements <sup>(1)</sup> For Devices with Date Code 0321 or Later		Old Requirements <sup>(1)</sup> For Devices with Date Code before 0321		
Symbol	Description	Junction Temperature <sup>(2)</sup>	Device Temperature Grade	Min	Max	Min	Max	Units
I <sub>CCPO</sub> (3)	Total V <sub>CCINT</sub> supply	$-40^{\circ}\text{C} \le \text{T}_{\text{J}} < -20^{\circ}\text{C}$	Industrial	1.50	-	2.00	-	Α
	current required	$-20$ °C $\leq$ T <sub>J</sub> $<$ 0°C	Industrial	1.00	-	2.00	-	Α
during power-on	during power-on	$0^{\circ}C \le T_{J} \le 85^{\circ}C$	Commercial	0.25	-	0.50	-	Α
		85°C < T <sub>J</sub> ≤ 100°C	Industrial	0.50	-	0.50	-	Α
T <sub>CCPO</sub> <sup>(4,5)</sup>	V <sub>CCINT</sub> ramp time	$-40^{\circ}\text{C} \le \text{T}_{\text{J}} \le 100^{\circ}\text{C}$	All	-	50	-	50	ms

#### Notes:

- 1. The date code is printed on the top of the device's package. See the Device Part Marking section in Module 1.
- 2. The expected T<sub>J</sub> range for the design determines the I<sub>CCPO</sub> minimum requirement. Use the applicable ranges in the junction temperature column to find the associated current values in the appropriate new or old requirements column according to the date code. Then choose the highest of these current values to serve as the minimum I<sub>CCPO</sub> requirement that must be met. For example, if the junction temperature for a given design is -25°C ≤ T<sub>J</sub> ≤ 75°C, then the new minimum I<sub>CCPO</sub> requirement is 1.5A. If 5°C ≤ T<sub>J</sub> ≤ 90°C, then the new minimum I<sub>CCPO</sub> requirement is 0.5A.
- 3. The I<sub>CCPO</sub> requirement applies for a brief time (commonly only a few milliseconds) when V<sub>CCINT</sub> ramps from 0 to 2.5V.
- The ramp time is measured from GND to V<sub>CCINT</sub> max on a fully loaded board.
- 5. During power-on, the V<sub>CCINT</sub> ramp must increase steadily in voltage with no dips.
- 6. For more information on designing to meet the power-on specifications, refer to the application note <a href="XAPP450">XAPP450 "Power-On Current Requirements for the Spartan-II and Spartan-IIE Families"</a>

# DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $V_{OL}$  and  $V_{OH}$  are guaranteed output voltages over the recommended operating conditions. Only selected standards are tested. These are chosen to ensure that all

standards meet their specifications. The selected standards are tested at minimum  $V_{CCO}$  with the respective  $I_{OL}$  and  $I_{OH}$  currents shown. Other standards are sample tested.

Input/Output		V <sub>IL</sub>	V	IH	V <sub>OL</sub>	V <sub>OH</sub>	I <sub>OL</sub>	I <sub>OH</sub>
Standard	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
LVTTL <sup>(1)</sup>	-0.5	0.8	2.0	5.5	0.4	2.4	24	-24
LVCMOS2	-0.5	0.7	1.7	5.5	0.4	1.9	12	-12
PCI, 3.3V	-0.5	44% V <sub>CCINT</sub>	60% V <sub>CCINT</sub>	V <sub>CCO</sub> + 0.5	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	Note (2)	Note (2)
PCI, 5.0V	-0.5	0.8	2.0	5.5	0.55	2.4	Note (2)	Note (2)
GTL	-0.5	V <sub>REF</sub> – 0.05	V <sub>REF</sub> + 0.05	3.6	0.4	N/A	40	N/A
GTL+	-0.5	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	3.6	0.6	N/A	36	N/A
HSTL I	-0.5	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	3.6	0.4	V <sub>CCO</sub> - 0.4	8	-8
HSTL III	-0.5	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	3.6	0.4	V <sub>CCO</sub> - 0.4	24	-8
HSTL IV	-0.5	V <sub>REF</sub> – 0.1	V <sub>REF</sub> + 0.1	3.6	0.4	V <sub>CCO</sub> - 0.4	48	-8
SSTL3 I	-0.5	V <sub>REF</sub> – 0.2	V <sub>REF</sub> + 0.2	3.6	V <sub>REF</sub> - 0.6	V <sub>REF</sub> + 0.6	8	-8
SSTL3 II	-0.5	V <sub>REF</sub> – 0.2	V <sub>REF</sub> + 0.2	3.6	V <sub>REF</sub> - 0.8	V <sub>REF</sub> + 0.8	16	-16
SSTL2 I	-0.5	V <sub>REF</sub> – 0.2	V <sub>REF</sub> + 0.2	3.6	V <sub>REF</sub> - 0.6	V <sub>REF</sub> + 0.6	7.6	-7.6
SSTL2 II	-0.5	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	3.6	V <sub>REF</sub> - 0.8	V <sub>REF</sub> + 0.8	15.2	-15.2



Input/Output		V <sub>IL</sub>	V <sub>IH</sub>		V <sub>OL</sub>	V <sub>OH</sub>	I <sub>OL</sub>	I <sub>OH</sub>
Standard	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
CTT	-0.5	V <sub>REF</sub> – 0.2	V <sub>REF</sub> + 0.2	3.6	V <sub>REF</sub> - 0.4	V <sub>REF</sub> + 0.4	8	-8
AGP	-0.5	V <sub>REF</sub> – 0.2	V <sub>REF</sub> + 0.2	3.6	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	Note (2)	Note (2)

### Notes:

- 1. V<sub>OL</sub> and V<sub>OH</sub> for lower drive currents are sample tested.
- 2. Tested according to the relevant specifications.

# **Switching Characteristics**

Testing of switching parameters is modeled after testing methods specified by MIL-M-38510/605. All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values. For more specific, more precise, and worst-case guaranteed data, use the values reported

by the static timing analyzer (TRCE in the Xilinx Development System) and back-annotated to the simulation netlist. All timing parameters assume worst-case operating conditions (supply voltage and junction temperature). Values apply to all Spartan-II devices unless otherwise noted.

# Global Clock Input to Output Delay for LVTTL, with DLL (Pin-to-Pin)(1)

			Speed Grade			
			All	-6	-5	
Symbol	Description	Device	Min	Max	Max	Units
TICKOFDLL	Global clock input to output delay using output flip-flop for LVTTL, 12 mA, fast slew rate, with DLL.	All		2.9	3.3	ns

### Notes:

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
- Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values.
   For other I/O standards and different loads, see the tables Constants for Calculating T<sub>IOOP</sub> and Delay Measurement
   Methodology, page 10.
- 3. DLL output jitter is already included in the timing calculation.
- 4. For data output with different standards, adjust delays with the values shown in IOB Output Delay Adjustments for Different Standards, page 9. For a global clock input with standards other than LVTTL, adjust delays with values from the I/O Standard Global Clock Input Adjustments, page 11.

# Global Clock Input to Output Delay for LVTTL, without DLL (Pin-to-Pin)(1)

			Speed Grade			
			All	-6	-5	
Symbol	Description	Device	Min	Max	Max	Units
T <sub>ICKOF</sub>	Global clock input to output delay	XC2S15		4.5	5.4	ns
	using output flip-flop for LVTTL,	XC2S30		4.5	5.4	ns
	12 mA, fast slew rate, without DLL.	XC2S50		4.5	5.4	ns
		XC2S100		4.6	5.5	ns
		XC2S150		4.6	5.5	ns
		XC2S200		4.7	5.6	ns

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
- Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values. For other I/O standards and different loads, see the tables Constants for Calculating T<sub>IOOP</sub> and Delay Measurement Methodology, page 10.
- For data output with different standards, adjust delays with the values shown in IOB Output Delay Adjustments for Different Standards, page 9. For a global clock input with standards other than LVTTL, adjust delays with values from the I/O Standard Global Clock Input Adjustments, page 11.



### Global Clock Setup and Hold for LVTTL Standard, with DLL (Pin-to-Pin)

			Speed Grade			
			-6	-5		
Symbol	Description	Device	Min	Min	Units	
T <sub>PSDLL</sub> / T <sub>PHDLL</sub>	Input setup and hold time relative to global clock input signal for LVTTL standard, no delay, IFF, <sup>(1)</sup> with DLL	All	1.7 / 0	1.9 / 0	ns	

### Notes:

- 1. IFF = Input Flip-Flop or Latch
- 2. Setup time is measured relative to the Global Clock input signal with the fastest route and the lightest load. Hold time is measured relative to the Global Clock input signal with the slowest route and heaviest load.
- 3. DLL output jitter is already included in the timing calculation.
- 4. A zero hold time listing indicates no hold time or a negative hold time.
- For data input with different standards, adjust the setup time delay by the values shown in IOB Input Delay Adjustments for Different Standards, page 7. For a global clock input with standards other than LVTTL, adjust delays with values from the I/O Standard Global Clock Input Adjustments, page 11.

### Global Clock Setup and Hold for LVTTL Standard, without DLL (Pin-to-Pin)

			Speed Grade		
			-6	-5	
Symbol	Description	Device	Min	Min	Units
T <sub>PSFD</sub> / T <sub>PHFD</sub>	Input setup and hold time relative	XC2S15	2.2 / 0	2.7 / 0	ns
	to global clock input signal for	XC2S30	2.2 / 0	2.7 / 0	ns
	LVTTL standard, no delay, IFF, <sup>(1)</sup> without DLL	XC2S50	2.2 / 0	2.7 / 0	ns
	Williout DEL	XC2S100	2.3 / 0	2.8 / 0	ns
		XC2S150	2.4 / 0	2.9 / 0	ns
		XC2S200	2.4 / 0	3.0 / 0	ns

- 1. IFF = Input Flip-Flop or Latch
- 2. Setup time is measured relative to the Global Clock input signal with the fastest route and the lightest load. Hold time is measured relative to the Global Clock input signal with the slowest route and heaviest load.
- 3. A zero hold time listing indicates no hold time or a negative hold time.
- For data input with different standards, adjust the setup time delay by the values shown in IOB Input Delay Adjustments for Different Standards, page 7. For a global clock input with standards other than LVTTL, adjust delays with values from the I/O Standard Global Clock Input Adjustments, page 11.



# IOB Input Switching Characteristics(1)

Input delays associated with the pad are specified for LVTTL levels. For other standards, adjust the delays with the values shown in **IOB Input Delay Adjustments for Different Standards**, page 7.

				Speed	d Grade		
			-6		-5		
Symbol	Description	Device	Min	Max	Min	Max	Units
<b>Propagation Delays</b>		·				•	
T <sub>IOPI</sub>	Pad to I output, no delay	All	-	0.8	-	1.0	ns
T <sub>IOPID</sub>	Pad to I output, with delay	All	-	1.5	-	1.8	ns
T <sub>IOPLI</sub>	Pad to output IQ via transparent latch, no delay	All	-	1.7	-	2.0	ns
T <sub>IOPLID</sub>	Pad to output IQ via transparent latch,	XC2S15	-	3.8	-	4.5	ns
	with delay	XC2S30	-	3.8	-	4.5	ns
		XC2S50	-	3.8	-	4.5	ns
		XC2S100	-	3.8	-	4.5	ns
		XC2S150	-	4.0	-	4.7	ns
		XC2S200	-	4.0	-	4.7	ns
Sequential Delays	1	1	II.		II.		1
T <sub>IOCKIQ</sub>	Clock CLK to output IQ	All	-	0.7	-	8.0	ns
Setup/Hold Times w	rith Respect to Clock CLK <sup>(2)</sup>	1	II.		II.		1
T <sub>IOPICK</sub> / T <sub>IOICKP</sub>	Pad, no delay	All	1.7 / 0	-	1.9 / 0	-	ns
T <sub>IOPICKD</sub> / T <sub>IOICKPD</sub>	Pad, with delay <sup>(1)</sup>	XC2S15	3.8 / 0		4.4 / 0	-	ns
		XC2S30	3.8 / 0		4.4 / 0	-	ns
		XC2S50	3.8 / 0		4.4 / 0	-	ns
		XC2S100	3.8 / 0	-	4.4 / 0	-	ns
		XC2S150	3.9 / 0	-	4.6 / 0	-	ns
		XC2S200	3.9 / 0	-	4.6 / 0	-	ns
T <sub>IOICECK</sub> / T <sub>IOCKICE</sub>	ICE input	All	0.9 / 0.01	-	0.9 / 0.01	-	ns
Set/Reset Delays	,	1	1		1	1	1
T <sub>IOSRCKI</sub>	SR input (IFF, synchronous)	All	-	1.1	-	1.2	ns
T <sub>IOSRIQ</sub>	SR input to IQ (asynchronous)	All	-	1.5	-	1.7	ns
T <sub>GSRQ</sub>	GSR to output IQ	All	-	9.9	-	11.7	ns

<sup>1.</sup> Input timing for LVTTL is measured at 1.4V. For other I/O standards, see the table **Delay Measurement Methodology**, page 10.

<sup>2.</sup> A zero hold time listing indicates no hold time or a negative hold time.



# IOB Input Delay Adjustments for Different Standards (1)

Input delays associated with the pad are specified for LVTTL. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

			Speed	Grade	
Symbol	Description	Standard	-6	-5	Units
Data Input D	Delay Adjustments				
T <sub>ILVTTL</sub>	Standard-specific data input delay	LVTTL	0	0	ns
T <sub>ILVCMOS2</sub>	adjustments	LVCMOS2	-0.04	-0.05	ns
T <sub>IPCI33_3</sub>		PCI, 33 MHz, 3.3V	-0.11	-0.13	ns
T <sub>IPCI33_5</sub>		PCI, 33 MHz, 5.0V	0.26	0.30	ns
T <sub>IPCI66_3</sub>		PCI, 66 MHz, 3.3V	-0.11	-0.13	ns
T <sub>IGTL</sub>		GTL	0.20	0.24	ns
T <sub>IGTLP</sub>		GTL+	0.11	0.13	ns
T <sub>IHSTL</sub>		HSTL	0.03	0.04	ns
T <sub>ISSTL2</sub>		SSTL2	-0.08	-0.09	ns
T <sub>ISSTL3</sub>		SSTL3	-0.04	-0.05	ns
T <sub>ICTT</sub>		CTT	0.02	0.02	ns
T <sub>IAGP</sub>		AGP	-0.06	-0.07	ns

<sup>1.</sup> Input timing for LVTTL is measured at 1.4V. For other I/O standards, see the table Delay Measurement Methodology, page 10.



# **IOB Output Switching Characteristics**

Output delays terminating at a pad are specified for LVTTL with 12 mA drive and fast slew rate. For other standards, adjust the delays with the values shown in **IOB Output Delay Adjustments for Different Standards**, page 9.

			Speed	Grade		
		-6		-5		
Symbol	Description	Min	Max	Min	Max	Units
Propagation Delays	s			<u>'</u>	Į.	
T <sub>IOOP</sub>	O input to pad	-	2.9	-	3.4	ns
T <sub>IOOLP</sub>	O input to pad via transparent latch	-	3.4	-	4.0	ns
3-state Delays						
T <sub>IOTHZ</sub>	T input to pad high-impedance <sup>(1)</sup>	-	2.0	-	2.3	ns
T <sub>IOTON</sub>	T input to valid data on pad	-	3.0	-	3.6	ns
T <sub>IOTLPHZ</sub>	T input to pad high impedance via transparent latch <sup>(1)</sup>	-	2.5	-	2.9	ns
T <sub>IOTLPON</sub>	T input to valid data on pad via transparent latch	-	3.5	-	4.2	ns
T <sub>GTS</sub>	GTS to pad high impedance <sup>(1)</sup>	-	5.0	-	5.9	ns
Sequential Delays	1					
T <sub>IOCKP</sub>	Clock CLK to pad	-	2.9	-	3.4	ns
T <sub>IOCKHZ</sub>	Clock CLK to pad high impedance (synchronous) <sup>(1)</sup>	-	2.3	-	2.7	ns
T <sub>IOCKON</sub>	Clock CLK to valid data on pad (synchronous)	-	3.3	-	4.0	ns
Setup/Hold Times	with Respect to Clock CLK <sup>(2)</sup>					1
T <sub>IOOCK</sub> / T <sub>IOCKO</sub>	O input	1.1 / 0	-	1.3 / 0	-	ns
T <sub>IOOCECK</sub> / T <sub>IOCKOCE</sub>	OCE input	0.9 / 0.01	-	0.9 / 0.01	-	ns
T <sub>IOSRCKO</sub> / T <sub>IOCKOSR</sub>	SR input (OFF)	1.2 / 0	-	1.3 / 0	-	ns
T <sub>IOTCK</sub> / T <sub>IOCKT</sub>	3-state setup times, T input	0.8/0	-	0.9 / 0	-	ns
T <sub>IOTCECK</sub> / T <sub>IOCKTCE</sub>	3-state setup times, TCE input	1.0 / 0	-	1.0 / 0	-	ns
T <sub>IOSRCKT</sub> / T <sub>IOCKTSR</sub>	3-state setup times, SR input (TFF)	1.1 / 0	-	1.2 / 0	-	ns
Set/Reset Delays				<u>'</u>		
T <sub>IOSRP</sub>	SR input to pad (asynchronous)	-	3.7	-	4.4	ns
T <sub>IOSRHZ</sub>	SR input to pad high impedance (asynchronous) <sup>(1)</sup>	-	3.1	-	3.7	ns
T <sub>IOSRON</sub>	SR input to valid data on pad (asynchronous)	-	4.1	-	4.9	ns
T <sub>IOGSRQ</sub>	GSR to pad	-	9.9	-	11.7	ns

- 1. Three-state turn-off delays should not be adjusted.
- 2. A zero hold time listing indicates no hold time or a negative hold time.



# IOB Output Delay Adjustments for Different Standards<sup>(1)</sup>

Output delays terminating at a pad are specified for LVTTL with 12 mA drive and fast slew rate. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

			Speed	d Grade	
Symbol	Description	Standard	-6	-5	Units
Output Delay Adj	ustments (Adj)				
T <sub>OLVTTL_S2</sub>	Standard-specific adjustments for	LVTTL, Slow, 2 mA	14.2	16.9	ns
T <sub>OLVTTL_S4</sub>	output delays terminating at pads (based on standard capacitive	4 mA	7.2	8.6	ns
T <sub>OLVTTL_S6</sub>	load, C <sub>SL</sub> )	6 mA	4.7	5.5	ns
T <sub>OLVTTL_S8</sub>		8 mA	2.9	3.5	ns
T <sub>OLVTTL_S12</sub>		12 mA	1.9	2.2	ns
T <sub>OLVTTL_S16</sub>		16 mA	1.7	2.0	ns
T <sub>OLVTTL_S24</sub>		24 mA	1.3	1.5	ns
T <sub>OLVTTL_F2</sub>		LVTTL, Fast, 2 mA	12.6	15.0	ns
T <sub>OLVTTL_F4</sub>		4 mA	5.1	6.1	ns
T <sub>OLVTTL_F6</sub>		6 mA	3.0	3.6	ns
T <sub>OLVTTL_F8</sub>		8 mA	1.0	1.2	ns
T <sub>OLVTTL_F12</sub>		12 mA	0	0	ns
T <sub>OLVTTL_F16</sub>		16 mA	-0.1	-0.1	ns
T <sub>OLVTTL_F24</sub>		24 mA	-0.1	-0.2	ns
T <sub>OLVCMOS2</sub>		LVCMOS2	0.2	0.2	ns
T <sub>OPCl33_3</sub>		PCI, 33 MHz, 3.3V	2.4	2.9	ns
T <sub>OPCl33_5</sub>		PCI, 33 MHz, 5.0V	2.9	3.5	ns
T <sub>OPCl66_3</sub>		PCI, 66 MHz, 3.3V	-0.3	-0.4	ns
T <sub>OGTL</sub>		GTL	0.6	0.7	ns
T <sub>OGTLP</sub>		GTL+	0.9	1.1	ns
T <sub>OHSTL_I</sub>		HSTL I	-0.4	-0.5	ns
T <sub>OHSTL_III</sub>		HSTL III	-0.8	-1.0	ns
T <sub>OHSTL_IV</sub>		HSTL IV	-0.9	-1.1	ns
T <sub>OSSTL2_I</sub>		SSTL2 I	-0.4	-0.5	ns
T <sub>OSSLT2_II</sub>		SSTL2 II	-0.8	-1.0	ns
T <sub>OSSTL3_I</sub>		SSTL3 I	-0.4	-0.5	ns
T <sub>OSSTL3_II</sub>		SSTL3 II	-0.9	-1.1	ns
T <sub>OCTT</sub>		CTT	-0.5	-0.6	ns
T <sub>OAGP</sub>		AGP	-0.8	-1.0	ns

Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. For other I/O standards and different loads, see the tables Constants for Calculating T<sub>IOOP</sub> and Delay Measurement Methodology, page 10.



# Calculation of T<sub>IOOP</sub> as a Function of Capacitance

 $T_{IOOP}$  is the propagation delay from the O Input of the IOB to the pad. The values for  $T_{IOOP}$  are based on the standard capacitive load ( $C_{SL}$ ) for each I/O standard as listed in the table **Constants for Calculating T<sub>IOOP</sub>**, below.

For other capacitive loads, use the formulas below to calculate an adjusted propagation delay, T<sub>IOOP1</sub>.

$$T_{IOOP1} = T_{IOOP} + Adj + (C_{LOAD} - C_{SL}) * F_{L}$$

Where:

Adj is selected from IOB Output Delay

Adjustments for Different Standards,

page 9, according to the I/O standard used

C<sub>LOAD</sub> is the capacitive load for the design

F<sub>L</sub> is the capacitance scaling factor

# **Delay Measurement Methodology**

Standard	V <sub>L</sub> <sup>(1)</sup>	V <sub>H</sub> <sup>(1)</sup>	Meas. Point	V <sub>REF</sub> Typ <sup>(2)</sup>
LVTTL	0	3	1.4	-
LVCMOS2	0	2.5	1.125	-
PCI33_5	Pe	r PCI Spec		-
PCI33_3	Pe	r PCI Spec		-
PCI66_3	Pe	-		
GTL	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	$V_{REF}$	0.80
GTL+	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	$V_{REF}$	1.0
HSTL Class I	V <sub>REF</sub> - 0.5	V <sub>REF</sub> + 0.5	$V_{REF}$	0.75
HSTL Class III	V <sub>REF</sub> - 0.5	V <sub>REF</sub> + 0.5	$V_{REF}$	0.90
HSTL Class IV	V <sub>REF</sub> - 0.5	V <sub>REF</sub> + 0.5	$V_{REF}$	0.90
SSTL3 I and II	V <sub>REF</sub> – 1.0	V <sub>REF</sub> + 1.0	$V_{REF}$	1.5
SSTL2 I and II	V <sub>REF</sub> - 0.75	V <sub>REF</sub> + 0.75	$V_{REF}$	1.25
CTT	V <sub>REF</sub> - 0.2	V <sub>REF</sub> + 0.2	$V_{REF}$	1.5
AGP	V <sub>REF</sub> – (0.2xV <sub>CCO</sub> )	V <sub>REF</sub> + (0.2xV <sub>CCO</sub> )	V <sub>REF</sub>	Per AGP Spec

### Notes:

- Input waveform switches between V<sub>L</sub> and V<sub>H</sub>.
- Measurements are made at V<sub>REF</sub> Typ, Maximum, and Minimum. Worst-case values are reported.
- I/O parameter measurements are made with the capacitance values shown in the table, Constants for Calculating T<sub>IOOP</sub>. See Xilinx application note <u>XAPP179</u> for the appropriate terminations.
- 4. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

# Constants for Calculating T<sub>IOOP</sub>

Standard	C <sub>SL</sub> <sup>(1)</sup> (pF)	F <sub>L</sub> (ns/pF)
LVTTL Fast Slew Rate, 2 mA drive	35	0.41
LVTTL Fast Slew Rate, 4 mA drive	35	0.20
LVTTL Fast Slew Rate, 6 mA drive	35	0.13
LVTTL Fast Slew Rate, 8 mA drive	35	0.079
LVTTL Fast Slew Rate, 12 mA drive	35	0.044
LVTTL Fast Slew Rate, 16 mA drive	35	0.043
LVTTL Fast Slew Rate, 24 mA drive	35	0.033
LVTTL Slow Slew Rate, 2 mA drive	35	0.41
LVTTL Slow Slew Rate, 4 mA drive	35	0.20
LVTTL Slow Slew Rate, 6 mA drive	35	0.100
LVTTL Slow Slew Rate, 8 mA drive	35	0.086
LVTTL Slow Slew Rate, 12 mA drive	35	0.058
LVTTL Slow Slew Rate, 16 mA drive	35	0.050
LVTTL Slow Slew Rate, 24 mA drive	35	0.048
LVCMOS2	35	0.041
PCI 33 MHz 5V	50	0.050
PCI 33 MHZ 3.3V	10	0.050
PCI 66 MHz 3.3V	10	0.033
GTL	0	0.014
GTL+	0	0.017
HSTL Class I	20	0.022
HSTL Class III	20	0.016
HSTL Class IV	20	0.014
SSTL2 Class I	30	0.028
SSTL2 Class II	30	0.016
SSTL3 Class I	30	0.029
SSTL3 Class II	30	0.016
СТТ	20	0.035
AGP	10	0.037

- I/O parameter measurements are made with the capacitance values shown above. See Xilinx application note <u>XAPP179</u> for the appropriate terminations.
- I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.



# **Clock Distribution Guidelines**(1)

		Speed	Speed Grade		
		-6	-5		
Symbol	Description	Max	Max	Units	
GCLK Clock Skew					
T <sub>GSKEWIOB</sub>	Global clock skew between IOB flip-flops	0.13	0.14	ns	

### Notes:

# **Clock Distribution Switching Characteristics**

 $T_{GPIO}$  is specified for LVTTL levels. For other standards, adjust  $T_{GPIO}$  with the values shown in I/O Standard Global Clock Input Adjustments.

		Speed Grade -6 -5 Max Max		
Symbol	Description			Units
GCLK IOB and But	ffer			
T <sub>GPIO</sub>	Global clock pad to output	0.7	0.8	ns
T <sub>GIO</sub>	Global clock buffer I input to O output	0.7	0.8	ns

# I/O Standard Global Clock Input Adjustments

Delays associated with a global clock input pad are specified for LVTTL levels. For other standards, adjust the delays by the values shown. A delay adjusted in the way constitutes a worst-case limit.

			Speed	Grade					
Symbol	Description	Standard	-6	-5	Units				
Data Input Delay Adjustments									
T <sub>GPLVTTL</sub>	Standard-specific global clock	LVTTL	0	0	ns				
T <sub>GPLVCMOS2</sub>	input delay adjustments	LVCMOS2	-0.04	-0.05	ns				
T <sub>GPPCl33_3</sub>		PCI, 33 MHz, 3.3V	-0.11	-0.13	ns				
T <sub>GPPCl33_5</sub>		PCI, 33 MHz, 5.0V	0.26	0.30	ns				
T <sub>GPPCI66_3</sub>		PCI, 66 MHz, 3.3V	-0.11	-0.13	ns				
T <sub>GPGTL</sub>		GTL	0.80	0.84	ns				
T <sub>GPGTLP</sub>		GTL+	0.71	0.73	ns				
T <sub>GPHSTL</sub>		HSTL	0.63	0.64	ns				
T <sub>GPSSTL2</sub>		SSTL2	0.52	0.51	ns				
T <sub>GPSSTL3</sub>		SSTL3	0.56	0.55	ns				
T <sub>GPCTT</sub>		CTT	0.62	0.62	ns				
T <sub>GPAGP</sub>		AGP	0.54	0.53	ns				

### Notes:

Input timing for GPLVTTL is measured at 1.4V. For other I/O standards, see the table Delay Measurement Methodology, page 10.

These clock distribution delays are provided for guidance only. They reflect the delays encountered in a typical design under worst-case conditions. Precise values for a particular design are provided by the timing analyzer.



# **DLL Timing Parameters**

Switching parameters testing is modeled after testing methods specified by MIL-M-38510/605; all devices are 100 percent functionally tested. Because of the difficulty in directly measuring many internal timing parameters, those parame-

ters are derived from benchmark timing patterns. The following guidelines reflect worst-case values across the recommended operating conditions.

		•	·6	-	5	
Symbol	Description	Min	Max	Min	Max	Units
F <sub>CLKINHF</sub>	Input clock frequency (CLKDLLHF)	60	200	60	180	MHz
F <sub>CLKINLF</sub>	Input clock frequency (CLKDLL)	25	100	25	90	MHz
T <sub>DLLPWHF</sub>	Input clock pulse width (CLKDLLHF)	2.0	-	2.4	-	ns
T <sub>DLLPWLF</sub>	Input clock pulse width (CLKDLL)	2.5	-	3.0	-	ns

### **DLL Clock Tolerance, Jitter, and Phase Information**

All DLL output jitter and phase specifications were determined through statistical measurement at the package pins using a clock mirror configuration and matched drivers.

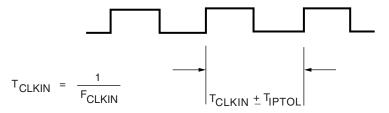
Figure 1, page 13, provides definitions for various parameters in the table below.

			CLK	LLHF	CLK	DLL	
Symbol	Description	F <sub>CLKIN</sub>	Min	Max	Min	Max	Units
T <sub>IPTOL</sub>	Input clock period tolerance		-	1.0	-	1.0	ns
T <sub>IJITCC</sub>	Input clock jitter tolerance (cycle-to-cycle)		-	±150	-	±300	ps
T <sub>LOCK</sub>	Time required for DLL to acquire lock	> 60 MHz	-	20	-	20	μs
		50-60 MHz	-	-	-	25	μs
		40-50 MHz	-	-	-	50	μs
		30-40 MHz	-	-	-	90	μs
		25-30 MHz	-	-	-	120	μs
T <sub>OJITCC</sub>	Output jitter (cycle-to-cycle) for any DLL clock of	utput <sup>(1)</sup>	-	±60	-	±60	ps
T <sub>PHIO</sub>	Phase offset between CLKIN and CLKO <sup>(2)</sup>		-	±100	-	±100	ps
T <sub>PHOO</sub>	Phase offset between clock outputs on the DLL(3)		-	±140	-	±140	ps
T <sub>PHIOM</sub>	Maximum phase difference between CLKIN and CLKO <sup>(4)</sup>		-	±160	-	±160	ps
T <sub>PHOOM</sub>	Maximum phase difference between clock outp	uts on the DLL <sup>(5)</sup>	-	±200	-	±200	ps

- 1. Output Jitter is cycle-to-cycle jitter measured on the DLL output clock, excluding input clock jitter.
- 2. **Phase Offset between CLKIN and CLKO** is the worst-case fixed time difference between rising edges of CLKIN and CLKO, *excluding* output jitter and input clock jitter.
- 3. **Phase Offset between Clock Outputs on the DLL** is the worst-case fixed time difference between rising edges of any two DLL outputs, *excluding* Output Jitter and input clock jitter.
- 4. **Maximum Phase Difference between CLKIN an CLKO** is the sum of Output Jitter and Phase Offset between CLKIN and CLKO, or the greatest difference between CLKIN and CLKO rising edges due to DLL alone (*excluding* input clock jitter).
- 5. **Maximum Phase Difference between Clock Outputs on the DLL** is the sum of Output Jltter and Phase Offset between any DLL clock outputs, or the greatest difference between any two DLL output rising edges due to DLL alone (*excluding* input clock jitter).



Period Tolerance: the allowed input clock period change in nanoseconds.



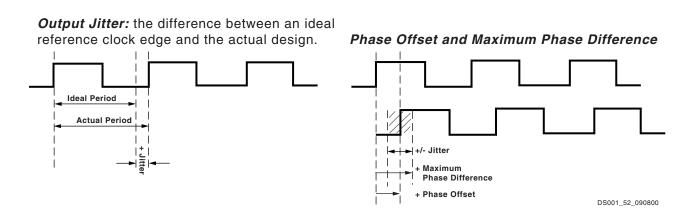


Figure 1: Period Tolerance and Clock Jitter



# **CLB Switching Characteristics**

Delays originating at F/G inputs vary slightly according to the input used. The values listed below are worst-case. Precise values are provided by the timing analyzer.

			Spee	d Grade		
		-6	6		5	<del>-</del>
Symbol	Description	Min	Max	Min	Max	Units
Combinatorial Dela	ays			'		•
T <sub>ILO</sub>	4-input function: F/G inputs to X/Y outputs	-	0.6	-	0.7	ns
T <sub>IF5</sub>	5-input function: F/G inputs to F5 output	-	0.7	-	0.9	ns
T <sub>IF5X</sub>	5-input function: F/G inputs to X output	-	0.9	-	1.1	ns
T <sub>IF6Y</sub>	6-input function: F/G inputs to Y output via F6 MUX	-	1.0	-	1.1	ns
T <sub>F5INY</sub>	6-input function: F5IN input to Y output	-	0.4	-	0.4	ns
T <sub>IFNCTL</sub>	Incremental delay routing through transparent latch to XQ/YQ outputs	-	0.7	-	0.9	ns
T <sub>BYYB</sub>	BY input to YB output	-	0.6	-	0.7	ns
Sequential Delays						
T <sub>CKO</sub>	FF clock CLK to XQ/YQ outputs	-	1.1	-	1.3	ns
T <sub>CKLO</sub>	Latch clock CLK to XQ/YQ outputs	-	1.2	-	1.5	ns
Setup/Hold Times	with Respect to Clock CLK <sup>(1)</sup>	1				
T <sub>ICK</sub> / T <sub>CKI</sub>	4-input function: F/G inputs	1.3 / 0	-	1.4 / 0	-	ns
T <sub>IF5CK</sub> / T <sub>CKIF5</sub>	5-input function: F/G inputs	1.6 / 0	-	1.8 / 0	-	ns
T <sub>F5INCK</sub> / T <sub>CKF5IN</sub>	6-input function: F5IN input	1.0 / 0	-	1.1 / 0	-	ns
T <sub>IF6CK</sub> / T <sub>CKIF6</sub>	6-input function: F/G inputs via F6 MUX	1.6 / 0	-	1.8 / 0	-	ns
T <sub>DICK</sub> / T <sub>CKDI</sub>	BX/BY inputs	0.8 / 0	-	0.8 / 0	-	ns
T <sub>CECK</sub> / T <sub>CKCE</sub>	CE input	0.9 / 0	-	0.9 / 0	-	ns
T <sub>RCK</sub> / T <sub>CKR</sub>	SR/BY inputs (synchronous)	0.8 / 0	-	0.8 / 0	-	ns
Clock CLK						
T <sub>CH</sub>	Minimum pulse width, High	-	1.9	-	1.9	ns
T <sub>CL</sub>	Minimum pulse width, Low	-	1.9	-	1.9	ns
Set/Reset						
T <sub>RPW</sub>	Minimum pulse width, SR/BY inputs	3.1	-	3.1	-	ns
T <sub>RQ</sub>	Delay from SR/BY inputs to XQ/YQ outputs (asynchronous)	-	1.1	-	1.3	ns
T <sub>IOGSRQ</sub>	Delay from GSR to XQ/YQ outputs	-	9.9	-	11.7	ns
F <sub>TOG</sub>	Toggle frequency (for export control)	-	263	-	263	MHz

### Notes:

1. A zero hold time listing indicates no hold time or a negative hold time.



# **CLB Arithmetic Switching Characteristics**

Setup times not listed explicitly can be approximated by decreasing the combinatorial delays by the setup time adjustment listed. Precise values are provided by the timing analyzer.

		Speed Grade				
		-(	6		5	
Symbol	Description	Min	Max	Min	Max	Units
Combinatorial Del	ays	"		"		
T <sub>OPX</sub>	F operand inputs to X via XOR	-	8.0	-	0.9	ns
T <sub>OPXB</sub>	F operand input to XB output	-	1.3	-	1.5	ns
T <sub>OPY</sub>	F operand input to Y via XOR	-	1.7	-	2.0	ns
T <sub>OPYB</sub>	F operand input to YB output	-	1.7	-	2.0	ns
T <sub>OPCYF</sub>	F operand input to COUT output	-	1.3	-	1.5	ns
T <sub>OPGY</sub>	G operand inputs to Y via XOR	-	0.9	-	1.1	ns
T <sub>OPGYB</sub>	G operand input to YB output	-	1.6	-	2.0	ns
T <sub>OPCYG</sub>	G operand input to COUT output	-	1.2	-	1.4	ns
T <sub>BXCY</sub>	BX initialization input to COUT	-	0.9	-	1.0	ns
T <sub>CINX</sub>	CIN input to X output via XOR	-	0.4	-	0.5	ns
T <sub>CINXB</sub>	CIN input to XB	-	0.1	-	0.1	ns
T <sub>CINY</sub>	CIN input to Y via XOR	-	0.5	-	0.6	ns
T <sub>CINYB</sub>	CIN input to YB	-	0.6	-	0.7	ns
T <sub>BYP</sub>	CIN input to COUT output	-	0.1	-	0.1	ns
Multiplier Operation	on			1		
T <sub>FANDXB</sub>	F1/2 operand inputs to XB output via AND	-	0.5	-	0.5	ns
T <sub>FANDYB</sub>	F1/2 operand inputs to YB output via AND	-	0.9	-	1.1	ns
T <sub>FANDCY</sub>	F1/2 operand inputs to COUT output via AND	-	0.5	-	0.6	ns
T <sub>GANDYB</sub>	G1/2 operand inputs to YB output via AND	-	0.6	-	0.7	ns
T <sub>GANDCY</sub>	G1/2 operand inputs to COUT output via AND	-	0.2	-	0.2	ns
Setup/Hold Times	with Respect to Clock CLK <sup>(1)</sup>			1		
T <sub>CCKX</sub> / T <sub>CKCX</sub>	CIN input to FFX	1.1 / 0	-	1.2 / 0	-	ns
T <sub>CCKY</sub> / T <sub>CKCY</sub>	CIN input to FFY	1.2 / 0	-	1.3 / 0	-	ns

<sup>1.</sup> A zero hold time listing indicates no hold time or a negative hold time.



# **CLB Distributed RAM Switching Characteristics**

		Speed Grade				
		-(	6		5	
Symbol	Description	Min	Max	Min	Max	Units
Sequential Delay	ys					
T <sub>SHCKO16</sub>	Clock CLK to X/Y outputs (WE active, 16 x 1 mode)	-	2.2	-	2.6	ns
T <sub>SHCKO32</sub>	Clock CLK to X/Y outputs (WE active, 32 x 1 mode)	-	2.5	-	3.0	ns
Setup/Hold Time	es with Respect to Clock CLK <sup>(1)</sup>	,				
T <sub>AS</sub> / T <sub>AH</sub>	F/G address inputs	0.7 / 0	-	0.7 / 0	-	ns
T <sub>DS</sub> / T <sub>DH</sub>	BX/BY data inputs (DIN)	0.8 / 0	-	0.9 / 0	-	ns
T <sub>WS</sub> / T <sub>WH</sub>	CE input (WS)	0.9 / 0	-	1.0 / 0	-	ns
Clock CLK		,				
T <sub>WPH</sub>	Minimum pulse width, High	-	2.9	-	2.9	ns
T <sub>WPL</sub>	Minimum pulse width, Low	-	2.9	-	2.9	ns
T <sub>WC</sub>	Minimum clock period to meet address write cycle time	-	5.8	-	5.8	ns

### Notes:

# **CLB Shift Register Switching Characteristics**

			Speed			
		-	-6		5	
Symbol	Description	Min	Max	Min	Max	Units
Sequential Del	ays					
T <sub>REG</sub>	Clock CLK to X/Y outputs	-	3.47	-	3.88	ns
Setup Times w	rith Respect to Clock CLK	<u>"</u>	•	'	1	
T <sub>SHDICK</sub>	BX/BY data inputs (DIN)	0.8	-	0.9	-	ns
T <sub>SHCECK</sub>	CE input (WS)	0.9	-	1.0	-	ns
Clock CLK		<u>"</u>	•	'	1	
T <sub>SRPH</sub>	Minimum pulse width, High	-	2.9	-	2.9	ns
T <sub>SRPL</sub>	Minimum pulse width, Low	-	2.9	-	2.9	ns

<sup>1.</sup> A zero hold time listing indicates no hold time or a negative hold time.



# **Block RAM Switching Characteristics**

			Speed	l Grade		
		-6	6	-5		
Symbol	Description	Min	Max	Min	Max	Units
Sequential Delays				'		
T <sub>BCKO</sub>	Clock CLK to DOUT output	-	3.4	-	4.0	ns
Setup/Hold Times	with Respect to Clock CLK <sup>(1)</sup>	1		1		1
T <sub>BACK</sub> / T <sub>BCKA</sub>	ADDR inputs	1.4 / 0	-	1.4 / 0	-	ns
T <sub>BDCK</sub> / T <sub>BCKD</sub>	DIN inputs	1.4 / 0	-	1.4 / 0	-	ns
T <sub>BECK</sub> / T <sub>BCKE</sub>	EN inputs	2.9 / 0	-	3.2 / 0	-	ns
T <sub>BRCK</sub> / T <sub>BCKR</sub>	RST input	2.7 / 0	-	2.9 / 0	-	ns
T <sub>BWCK</sub> / T <sub>BCKW</sub>	WEN input	2.6 / 0	-	2.8 / 0	-	ns
Clock CLK		1		1		1
T <sub>BPWH</sub>	Minimum pulse width, High	-	1.9	-	1.9	ns
T <sub>BPWL</sub>	Minimum pulse width, Low	-	1.9	-	1.9	ns
T <sub>BCCS</sub>	CLKA -> CLKB setup time for different ports	-	3.0	-	4.0	ns

### Notes:

# **TBUF Switching Characteristics**

		Speed	Speed Grade		
		-6	-5		
Symbol	Description	Max	Max	Units	
Combinatorial Dela	ys				
T <sub>IO</sub>	IN input to OUT output	0	0	ns	
T <sub>OFF</sub>	TRI input to OUT output high impedance	0.1	0.2	ns	
T <sub>ON</sub>	TRI input to valid data on OUT output	0.1	0.2	ns	

# **JTAG Test Access Port Switching Characteristics**

		Speed Grade							
	-6		-1	5	1				
Symbol	Description	Min	Max	Min	Max	Units			
Setup and Hold Times with Respect to TCK									
T <sub>TAPTCK /</sub> T <sub>TCKTAP</sub>	TMS and TDI setup and hold times	4.0 / 2.0	-	4.0 / 2.0	-	ns			
Sequential Delays									
T <sub>TCKTDO</sub> Output delay from clock TCK to outp		-	11.0	-	11.0	ns			
F <sub>TCK</sub>	-	33	-	33	MHz				

<sup>1.</sup> A zero hold time listing indicates no hold time or a negative hold time.



# **Revision History**

Date	Version No.	Description		
09/18/00	2.0	Sectioned the Spartan-II Family data sheet into four modules. Updated timing to reflect the latest speed files. Added current supply numbers and XC2S200 -5 timing numbers. Approved -5 timing numbers as preliminary information with exceptions as noted.		
11/02/00	2.1	Removed Power Down feature.		
01/19/01	2.2	DC and timing numbers updated to Preliminary for the XC2S50 and XC2S100. Industrial power-on current specifications and -6 DLL timing numbers added. Power-on specification clarified.		
03/09/01	2.3	Added note on power sequencing. Clarified power-on current requirement.		
08/28/01	2.4	Added -6 preliminary timing. Added typical and industrial standby current numbers. Specific min. power-on current by junction temperature instead of by device type (Commercial vs. Industrial). Eliminated minimum V <sub>CCINT</sub> ramp time requirement. Removed footnote limiting DLL operation to the Commercial temperature range.		
07/26/02	2.5	Clarified that I/O leakage current is specified over the Recommended Operating Conditions fo $V_{\text{CCINT}}$ and $V_{\text{CCO}}$ .		
08/26/02	2.6	Added references for XAPP450 to Power-On Current Specification.		
09/03/03	2.7	Added relaxed minimum power-on current ( $I_{CCPO}$ ) requirements to page 3. On page 14, moved $T_{RPW}$ values from maximum to minimum column.		

# The Spartan-II Family Data Sheet

DS001-1, Spartan-II 2.5V FPGA Family: Introduction and Ordering Information (Module 1)

DS001-2, Spartan-II 2.5V FPGA Family: Functional Description (Module 2)

DS001-3, Spartan-II 2.5V FPGA Family: DC and Switching Characteristics (Module 3)

DS001-4, Spartan-II 2.5V FPGA Family: Pinout Tables (Module 4)



# **Spartan-II 2.5V FPGA Family: Pinout Tables**

DS001-4 (v2.5) September 3, 2003

**Product Specification** 

# **Pin Definitions**

Pin Name	Dedicated Pin	Direction	Description	
GCK0, GCK1, GCK2, GCK3	No	Input	Clock input pins that connect to Global Clock Buffers. These pins become user inputs when not needed for clocks.	
M0, M1, M2	Yes	Input	Mode pins are used to specify the configuration mode.	
CCLK	Yes	Input or Output	The configuration Clock I/O pin. It is an input for slave-parallel and slave-serial modes, and output in master-serial mode.	
PROGRAM	Yes	Input	Initiates a configuration sequence when asserted Low.	
DONE	Yes	Bidirectional	Indicates that configuration loading is complete, and that the start-up sequence is in progress. The output may be open drain.	
INIT	No	Bidirectional (Open-drain)	When Low, indicates that the configuration memory is being cleared. This pin becomes a user I/O after configuration.	
BUSY/DOUT	No	Output	In Slave Parallel mode, BUSY controls the rate at which configuration data is loaded. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained.	
			In serial modes, DOUT provides configuration data to downstream devices in a daisy-chain. This pin becomes a user I/O after configuration.	
D0/DIN, D1, D2, D3, D4, D5, D6, D7	No	Input or Output	In Slave Parallel mode, D0-D7 are configuration data input pins. During readback, D0-D7 are output pins. These pins become user I/Os after configuration unless the Slave Parallel port is retained.	
			In serial modes, DIN is the single data input. This pin becomes a user I/O after configuration.	
WRITE	No	Input	In Slave Parallel mode, the active-low Write Enable signal. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained.	
CS	No	Input	In Slave Parallel mode, the active-low Chip Select signal. This pin becomes a user I/O after configuration unless the Slave Parallel port is retained.	
TDI, TDO, TMS, TCK	Yes	Mixed	Boundary Scan Test Access Port pins (IEEE 1149.1).	
V <sub>CCINT</sub>	Yes	Input	Power supply pins for the internal core logic.	
V <sub>CCO</sub>	Yes	Input	Power supply pins for output drivers (subject to banking rules)	
V <sub>REF</sub>	No	Input	Input threshold voltage pins. Become user I/Os when an external threshold voltage is not needed (subject to banking rules).	
GND	Yes	Input	Ground.	
IRDY, TRDY	No	See PCI core documentation	These signals can only be accessed when using Xilinx PCI cores. If the cores are not used, these pins are available as user I/Os.	

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### **Pinout Tables**

The following device-specific pinout tables include all packages available for each Spartan-II device. They follow the pad locations around the die, and include Boundary Scan register locations.

### **XC2S15 Device Pinouts**

XC2S15 Pac	l Name				Bndry
Function	Bank	VQ100	TQ144	CS144	Scan
GND	-	P1	P143	A1	-
TMS	-	P2	P142	B1	-
I/O	7	P3	P141	C2	77
I/O	7	-	P140	C1	80
I/O, V <sub>REF</sub>	7	P4	P139	D4	83
I/O	7	P5	P137	D2	86
I/O	7	P6	P136	D1	89
GND	-	-	P135	E4	-
I/O	7	P7	P134	E3	92
I/O	7	-	P133	E2	95
I/O, V <sub>REF</sub>	7	P8	P132	E1	98
I/O	7	P9	P131	F4	101
I/O	7	-	P130	F3	104
I/O, IRDY <sup>(1)</sup>	7	P10	P129	F2	107
GND	-	P11	P128	F1	-
V <sub>CCO</sub>	7	P12	P127	G2	-
V <sub>CCO</sub>	6	P12	P127	G2	-
I/O, TRDY <sup>(1)</sup>	6	P13	P126	G1	110
V <sub>CCINT</sub>	-	P14	P125	G3	-
I/O	6	-	P124	G4	113
I/O	6	P15	P123	H1	116
I/O, V <sub>REF</sub>	6	P16	P122	H2	119
I/O	6	-	P121	НЗ	122
I/O	6	P17	P120	H4	125
GND	-	-	P119	J1	-
I/O	6	P18	P118	J2	128
I/O	6	P19	P117	J3	131
I/O, V <sub>REF</sub>	6	P20	P115	K1	134
I/O	6	-	P114	K2	137
I/O	6	P21	P113	K3	140
I/O	6	P22	P112	L1	143
M1	-	P23	P111	L2	146
GND	-	P24	P110	L3	-
MO	-	P25	P109	M1	147
V <sub>CCO</sub>	6	P26	P108	M2	1
V <sub>CCO</sub>	5	P26	P107	N1	1
M2	-	P27	P106	N2	148
I/O	5	-	P103	K4	155

XC2S15 Pad	Name			-	Bndry
Function	Bank	VQ100	TQ144	CS144	Scan
I/O, V <sub>REF</sub>	5	P30	P102	L4	158
I/O	5	P31	P100	N4	161
I/O	5	P32	P99	K5	164
GND	-	-	P98	L5	-
V <sub>CCINT</sub>	-	P33	P97	M5	-
I/O	5	-	P96	N5	167
I/O	5	-	P95	K6	170
I/O, V <sub>REF</sub>	5	P34	P94	L6	173
I/O	5	-	P93	M6	176
V <sub>CCINT</sub>	-	P35	P92	N6	-
I, GCK1	5	P36	P91	M7	185
V <sub>CCO</sub>	5	P37	P90	N7	-
V <sub>CCO</sub>	4	P37	P90	N7	ı
GND	ı	P38	P89	L7	ı
I, GCK0	4	P39	P88	K7	186
I/O	4	P40	P87	N8	190
I/O	4	-	P86	M8	193
I/O, V <sub>REF</sub>	4	P41	P85	L8	196
I/O	4	-	P84	K8	199
I/O	4	-	P83	N9	202
V <sub>CCINT</sub>	1	P42	P82	M9	1
GND	ı	-	P81	L9	1
I/O	4	P43	P80	K9	205
I/O	4	P44	P79	N10	208
I/O, V <sub>REF</sub>	4	P45	P77	L10	211
I/O	4	-	P76	N11	214
I/O	4	P46	P75	M11	217
I/O	4	P47	P74	L11	220
GND	-	P48	P73	N12	-
DONE	3	P49	P72	M12	223
V <sub>CCO</sub>	4	P50	P71	N13	1
V <sub>CCO</sub>	3	P50	P70	M13	-
PROGRAM	-	P51	P69	L12	226
I/O (ĪNIT)	3	P52	P68	L13	227
I/O (D7)	3	P53	P67	K10	230
I/O	3	-	P66	K11	233
I/O, V <sub>REF</sub>	3	P54	P65	K12	236
I/O	3	P55	P63	J10	239



XC2S15 Pad	Name				Bndry
Function	Bank	VQ100	TQ144	CS144	Scan
I/O (D6)	3	P56	P62	J11	242
GND	-	-	P61	J12	-
I/O (D5)	3	P57	P60	J13	245
I/O	3	P58	P59	H10	248
I/O, V <sub>REF</sub>	3	P59	P58	H11	251
I/O (D4)	3	P60	P57	H12	254
I/O	3	-	P56	H13	257
V <sub>CCINT</sub>	-	P61	P55	G12	-
I/O, TRDY <sup>(1)</sup>	3	P62	P54	G13	260
V <sub>CCO</sub>	3	P63	P53	G11	-
V <sub>CCO</sub>	2	P63	P53	G11	-
GND	-	P64	P52	G10	-
I/O, IRDY <sup>(1)</sup>	2	P65	P51	F13	263
I/O	2	-	P50	F12	266
I/O (D3)	2	P66	P49	F11	269
I/O, V <sub>REF</sub>	2	P67	P48	F10	272
I/O	2	P68	P47	E13	275
I/O (D2)	2	P69	P46	E12	278
GND	-	-	P45	E11	-
I/O (D1)	2	P70	P44	E10	281
I/O	2	P71	P43	D13	284
I/O, V <sub>REF</sub>	2	P72	P41	D11	287
I/O	2	-	P40	C13	290
I/O (DIN, D0)	2	P73	P39	C12	293
I/O (DOUT, BUSY)	2	P74	P38	C11	296
CCLK	2	P75	P37	B13	299
V <sub>CCO</sub>	2	P76	P36	B12	-
V <sub>CCO</sub>	1	P76	P35	A13	-
TDO	2	P77	P34	A12	-
GND	-	P78	P33	B11	-
TDI	-	P79	P32	A11	-
I/O (CS)	1	P80	P31	D10	0
I/O (WRITE)	1	P81	P30	C10	3
I/O	1	-	P29	B10	6
I/O, V <sub>REF</sub>	1	P82	P28	A10	9
I/O	1	P83	P27	D9	12
I/O	1	P84	P26	C9	15
GND	-	-	P25	В9	-
V <sub>CCINT</sub>	-	P85	P24	A9	-
I/O	1	-	P23	D8	18

### XC2S15 Device Pinouts (Continued)

XC2S15 Pad	XC2S15 Pad Name				Bndry
Function	Bank	VQ100	TQ144	CS144	Scan
I/O	1	-	P22	C8	21
I/O, V <sub>REF</sub>	1	P86	P21	B8	24
I/O	1	-	P20	A8	27
I/O	1	P87	P19	B7	30
I, GCK2	1	P88	P18	A7	36
GND	-	P89	P17	C7	-
V <sub>CCO</sub>	1	P90	P16	D7	-
V <sub>CCO</sub>	0	P90	P16	D7	-
I, GCK3	0	P91	P15	A6	37
V <sub>CCINT</sub>	-	P92	P14	B6	-
I/O	0	-	P13	C6	44
I/O, V <sub>REF</sub>	0	P93	P12	D6	47
I/O	0	-	P11	A5	50
I/O	0	-	P10	B5	53
V <sub>CCINT</sub>	-	P94	P9	C5	-
GND	-	-	P8	D5	-
I/O	0	P95	P7	A4	56
I/O	0	P96	P6	B4	59
I/O, V <sub>REF</sub>	0	P97	P5	C4	62
I/O	0	-	P4	A3	65
I/O	0	P98	P3	В3	68
TCK	-	P99	P2	C3	-
V <sub>CCO</sub>	0	P100	P1	A2	-
V <sub>CCO</sub>	7	P100	P144	B2	-

04/18/01

#### Notes:

IRDY and TRDY can only be accessed when using Xilinx PCI cores.

# **Additional XC2S15 Package Pins**

### **VQ100**

Not Connected Pins									
P28	P28 P29								
11/02/00		1			1				

#### TQ144

	Not Connected Pins								
P42	P64	P78	P101	P104	P105				
P116	P138	-	-	-	-				
11/02/00		1		1					

#### CS144

Not Connected Pins									
D3	D12	J4	K13	М3	M4				
M10	N3								
11/02/00									



### **XC2S30 Device Pinouts**

XC2S30 Pad Name		IIIOU				
Function	Bank	VQ100	TQ144	CS144	PQ208	Bndry Scan
GND	-	P1	P143	A1	P1	-
TMS	-	P2	P142	B1	P2	-
I/O	7	P3	P141	C2	P3	113
I/O	7	-	P140	C1	P4	116
I/O	7	-	-	-	P5	119
I/O, V <sub>REF</sub>	7	P4	P139	D4	P6	122
I/O	7	-	P138	D3	P8	125
I/O	7	P5	P137	D2	P9	128
I/O	7	P6	P136	D1	P10	131
GND	-	-	P135	E4	P11	-
V <sub>CCO</sub>	7	-	-	-	P12	-
I/O	7	P7	P134	E3	P14	134
I/O	7	-	P133	E2	P15	137
I/O	7	-	-	-	P16	140
I/O	7	-	-	-	P17	143
I/O	7	-	-	-	P18	146
GND	-	-	-	-	P19	-
I/O, V <sub>REF</sub>	7	P8	P132	E1	P20	149
I/O	7	P9	P131	F4	P21	152
I/O	7	-	P130	F3	P22	155
I/O	7	-	-	-	P23	158
I/O, IRDY <sup>(1)</sup>	7	P10	P129	F2	P24	161
GND	-	P11	P128	F1	P25	-
V <sub>CCO</sub>	7	P12	P127	G2	P26	-
V <sub>CCO</sub>	6	P12	P127	G2	P26	-
I/O, TRDY <sup>(1)</sup>	6	P13	P126	G1	P27	164
V <sub>CCINT</sub>	-	P14	P125	G3	P28	-
I/O	6	-	P124	G4	P29	170
I/O	6	P15	P123	H1	P30	173
I/O, V <sub>REF</sub>	6	P16	P122	H2	P31	176
GND	-	-	-	-	P32	-
I/O	6	-	-	-	P33	179
I/O	6	-	-	-	P34	182
I/O	6	-	-	-	P35	185
I/O	6	-	P121	НЗ	P36	188
I/O	6	P17	P120	H4	P37	191
$V_{CCO}$	6	-	-	-	P39	-
GND	-	-	P119	J1	P40	-
I/O	6	P18	P118	J2	P41	194
I/O	6	P19	P117	J3	P42	197
I/O	6	-	P116	J4	P43	200

XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
I/O, V <sub>REF</sub>	6	P20	P115	K1	P45	203
I/O	6	-	-	-	P46	206
I/O	6	-	P114	K2	P47	209
I/O	6	P21	P113	K3	P48	212
I/O	6	P22	P112	L1	P49	215
M1	-	P23	P111	L2	P50	218
GND	-	P24	P110	L3	P51	-
MO	-	P25	P109	M1	P52	219
$V_{CCO}$	6	P26	P108	M2	P53	-
V <sub>CCO</sub>	5	P26	P107	N1	P53	-
M2	-	P27	P106	N2	P54	220
I/O	5	-	P103	K4	P57	227
I/O	5	-	-	-	P58	230
I/O, V <sub>REF</sub>	5	P30	P102	L4	P59	233
I/O	5	-	P101	M4	P61	236
I/O	5	P31	P100	N4	P62	239
I/O	5	P32	P99	K5	P63	242
GND	-	-	P98	L5	P64	-
V <sub>CCO</sub>	5	-	-	-	P65	-
V <sub>CCINT</sub>	-	P33	P97	M5	P66	-
I/O	5	-	P96	N5	P67	245
I/O	5	-	P95	K6	P68	248
I/O	5	-	-	-	P69	251
I/O	5	-	-	-	P70	254
I/O	5	-	-	-	P71	257
GND	-	-	-	-	P72	-
I/O, V <sub>REF</sub>	5	P34	P94	L6	P73	260
I/O	5	-	-	-	P74	263
I/O	5	-	P93	M6	P75	266
V <sub>CCINT</sub>	-	P35	P92	N6	P76	-
I, GCK1	5	P36	P91	M7	P77	275
V <sub>CCO</sub>	5	P37	P90	N7	P78	-
V <sub>CCO</sub>	4	P37	P90	N7	P78	-
GND	-	P38	P89	L7	P79	-
I, GCK0	4	P39	P88	K7	P80	276
I/O	4	P40	P87	N8	P81	280
I/O	4	-	P86	M8	P82	283
I/O	4	-	-	-	P83	286
I/O, V <sub>REF</sub>	4	P41	P85	L8	P84	289
GND	-	-	-	-	P85	-
I/O	4	-	-	-	P86	292
	<u> </u>	<u> </u>	<u> </u>	<u> </u>		



XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
I/O	4	-	-	-	P87	295
I/O	4	-	-	-	P88	298
I/O	4	-	P84	K8	P89	301
I/O	4	-	P83	N9	P90	304
V <sub>CCINT</sub>	-	P42	P82	M9	P91	-
$V_{CCO}$	4	-	-	-	P92	-
GND	-	-	P81	L9	P93	-
I/O	4	P43	P80	K9	P94	307
I/O	4	P44	P79	N10	P95	310
I/O	4	-	P78	M10	P96	313
I/O, V <sub>REF</sub>	4	P45	P77	L10	P98	316
I/O	4	-	-	-	P99	319
I/O	4	-	P76	N11	P100	322
I/O	4	P46	P75	M11	P101	325
I/O	4	P47	P74	L11	P102	328
GND	-	P48	P73	N12	P103	-
DONE	3	P49	P72	M12	P104	331
V <sub>CCO</sub>	4	P50	P71	N13	P105	-
$V_{CCO}$	3	P50	P70	M13	P105	-
PROGRAM	-	P51	P69	L12	P106	334
I/O (ĪNĪT)	3	P52	P68	L13	P107	335
I/O (D7)	3	P53	P67	K10	P108	338
I/O	3	-	P66	K11	P109	341
I/O	3	-	-	-	P110	344
I/O, V <sub>REF</sub>	3	P54	P65	K12	P111	347
I/O	3	-	P64	K13	P113	350
I/O	3	P55	P63	J10	P114	353
I/O (D6)	3	P56	P62	J11	P115	356
GND	-	-	P61	J12	P116	-
V <sub>CCO</sub>	3	-	-	-	P117	-
I/O (D5)	3	P57	P60	J13	P119	359
I/O	3	P58	P59	H10	P120	362
I/O	3	-	-	-	P121	365
I/O	3	-	-	-	P122	368
I/O	3	-	-	-	P123	371
GND	-	-	-	-	P124	-
I/O, V <sub>REF</sub>	3	P59	P58	H11	P125	374
I/O (D4)	3	P60	P57	H12	P126	377
I/O	3	-	P56	H13	P127	380
V <sub>CCINT</sub>	-	P61	P55	G12	P128	-
I/O, TRDY <sup>(1)</sup>	3	P62	P54	G13	P129	386

XC2S30 Pad	Name					Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
V <sub>CCO</sub>	3	P63	P53	G11	P130	-
V <sub>CCO</sub>	2	P63	P53	G11	P130	-
GND	-	P64	P52	G10	P131	-
I/O, IRDY <sup>(1)</sup>	2	P65	P51	F13	P132	389
I/O	2	-	1	-	P133	392
I/O	2	-	P50	F12	P134	395
I/O (D3)	2	P66	P49	F11	P135	398
I/O, V <sub>REF</sub>	2	P67	P48	F10	P136	401
GND	-	-	-	-	P137	-
I/O	2	-	-	-	P138	404
I/O	2	-	-	-	P139	407
I/O	2	-	-	-	P140	410
I/O	2	P68	P47	E13	P141	413
I/O (D2)	2	P69	P46	E12	P142	416
V <sub>CCO</sub>	2	-	-	-	P144	-
GND	-	-	P45	E11	P145	-
I/O (D1)	2	P70	P44	E10	P146	419
I/O	2	P71	P43	D13	P147	422
I/O	2	-	P42	D12	P148	425
I/O, V <sub>REF</sub>	2	P72	P41	D11	P150	428
I/O	2	-	-	-	P151	431
I/O	2	-	P40	C13	P152	434
I/O (DIN, D0)	2	P73	P39	C12	P153	437
I/O (DOUT, BUSY)	2	P74	P38	C11	P154	440
CCLK	2	P75	P37	B13	P155	443
V <sub>CCO</sub>	2	P76	P36	B12	P156	-
V <sub>CCO</sub>	1	P76	P35	A13	P156	-
TDO	2	P77	P34	A12	P157	-
GND	-	P78	P33	B11	P158	-
TDI	-	P79	P32	A11	P159	-
I/O (CS)	1	P80	P31	D10	P160	0
I/O (WRITE)	1	P81	P30	C10	P161	3
I/O	1	-	P29	B10	P162	6
I/O	1	-	-	-	P163	9
I/O, V <sub>REF</sub>	1	P82	P28	A10	P164	12
I/O	1	-	-	-	P166	15
I/O	1	P83	P27	D9	P167	18
I/O	1	P84	P26	C9	P168	21
GND	-	-	P25	В9	P169	-
V <sub>CCO</sub>	1	-	-	-	P170	-



XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
V <sub>CCINT</sub>	-	P85	P24	A9	P171	-
I/O	1	-	P23	D8	P172	24
I/O	1	-	P22	C8	P173	27
I/O	1	-	-	-	P174	30
I/O	1	-	-	-	P175	33
I/O	1	-	-	-	P176	36
GND	-	-	-	-	P177	-
I/O, V <sub>REF</sub>	1	P86	P21	B8	P178	39
I/O	1	-	-	-	P179	42
I/O	1	-	P20	A8	P180	45
I/O	1	P87	P19	B7	P181	48
I, GCK2	1	P88	P18	A7	P182	54
GND	-	P89	P17	C7	P183	-
V <sub>CCO</sub>	1	P90	P16	D7	P184	-
V <sub>CCO</sub>	0	P90	P16	D7	P184	
I, GCK3	0	P91	P15	A6	P185	55
V <sub>CCINT</sub>	-	P92	P14	B6	P186	1
I/O	0	-	P13	C6	P187	62
I/O	0	-	-	-	P188	65
I/O, V <sub>REF</sub>	0	P93	P12	D6	P189	68
GND	-	-	-	-	P190	-
I/O	0	-	-	-	P191	71
I/O	0	-	-	-	P192	74
I/O	0	-	-	-	P193	77
I/O	0	-	P11	A5	P194	80
I/O	0	-	P10	B5	P195	83
V <sub>CCINT</sub>	-	P94	P9	C5	P196	
V <sub>CCO</sub>	0	-	-	-	P197	
GND	-	-	P8	D5	P198	
I/O	0	P95	P7	A4	P199	86
I/O	0	P96	P6	B4	P200	89

### XC2S30 Device Pinouts (Continued)

XC2S30 Pad Name						Bndry
Function	Bank	VQ100	TQ144	CS144	PQ208	Scan
I/O	0	-	-	-	P201	92
I/O, V <sub>REF</sub>	0	P97	P5	C4	P203	95
I/O	0	-	-	-	P204	98
I/O	0	-	P4	А3	P205	101
I/O	0	P98	P3	В3	P206	104
TCK	-	P99	P2	С3	P207	-
V <sub>CCO</sub>	0	P100	P1	A2	P208	-
$V_{CCO}$	7	P100	P144	B2	P208	-
0.4/4.0/0.4						

04/18/01

#### Notes:

IRDY and TRDY can only be accessed when using Xilinx PCI cores.

### **Additional XC2S30 Package Pins**

#### **VQ100**

Not Connected Pins									
P28	P29	-	-	-	-				
11/02/00		Į.	Į.	Į.	Į.				

#### **TQ144**

Not Connected Pins									
P104	P104 P105								
11/02/00									

#### CS144

		Not Conn	ected Pins		
М3	N3	-	-	-	-
11/02/00					

#### PQ208

Not Connected Pins										
P7 P13 P38 P44 P55 P56										
P60	P97	P112	P118	P143	P149					
P165	P202	-	-	-	-					
11/02/00										

#### Notes:

1. For the PQ208 package, P13, P38, P118, and P143, which are Not Connected Pins on the XC2S30, are assigned to  $V_{\text{CCINT}}$  on larger devices.

### **XC2S50 Device Pinouts**

XC2S50 Pad Name					Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
GND	-	P143	P1	GND*	-
TMS	-	P142	P2	D3	-
I/O	7	P141	P3	C2	149

XC2S50 Pad Name					Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
I/O	7	-	-	A2	152
I/O	7	P140	P4	B1	155
I/O	7	-	-	E3	158



XC2S50 Pad			Bodry		
Function	Bank	TQ144	PQ208	FG256	Bndry Scan
I/O	7	-	P5	D2	161
GND	-	-	-	GND*	-
I/O, V <sub>REF</sub>	7	P139	P6	C1	164
I/O	7	-	P7	F3	167
I/O	7	-	-	E2	170
I/O	7	P138	P8	E4	173
I/O	7	P137	P9	D1	176
I/O	7	P136	P10	E1	179
GND	-	P135	P11	GND*	ı
V <sub>CCO</sub>	7	-	P12	V <sub>CCO</sub> Bank 7*	-
V <sub>CCINT</sub>	-	-	P13	V <sub>CCINT</sub> *	-
I/O	7	P134	P14	F2	182
I/O	7	P133	P15	G3	185
I/O	7	-	-	F1	188
I/O	7	-	P16	F4	191
I/O	7	-	P17	F5	194
I/O	7	-	P18	G2	197
GND	-	-	P19	GND*	-
I/O, V <sub>REF</sub>	7	P132	P20	НЗ	200
I/O	7	P131	P21	G4	203
I/O	7	-	-	H2	206
I/O	7	P130	P22	G5	209
I/O	7	-	P23	H4	212
I/O, IRDY <sup>(1)</sup>	7	P129	P24	G1	215
GND	ı	P128	P25	GND*	ı
V <sub>CCO</sub>	7	P127	P26	V <sub>CCO</sub> Bank 7*	-
V <sub>CCO</sub>	6	P127	P26	V <sub>CCO</sub> Bank 6*	-
I/O, TRDY <sup>(1)</sup>	6	P126	P27	J2	218
V <sub>CCINT</sub>	-	P125	P28	V <sub>CCINT</sub> *	-
I/O	6	P124	P29	H1	224
I/O	6	-	-	J4	227
I/O	6	P123	P30	J1	230
I/O, V <sub>REF</sub>	6	P122	P31	J3	233
GND	-	-	P32	GND*	-
I/O	6	-	P33	K5	236
I/O	6	-	P34	K2	239
I/O	6	-	P35	K1	242
I/O	6	-	-	K3	245
I/O	6	P121	P36	L1	248

XC2S50 Pad N	Name				Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
I/O	6	P120	P37	L2	251
V <sub>CCINT</sub>	-	1	P38	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	6	-	P39	V <sub>CCO</sub> Bank 6*	-
GND	-	P119	P40	GND*	-
I/O	6	P118	P41	K4	254
I/O	6	P117	P42	M1	257
I/O	6	P116	P43	L4	260
I/O	6	ı	-	M2	263
I/O	6	-	P44	L3	266
I/O, V <sub>REF</sub>	6	P115	P45	N1	269
GND	-	-	-	GND*	-
I/O	6	-	P46	P1	272
I/O	6	-	-	L5	275
I/O	6	P114	P47	N2	278
I/O	6	-	-	M4	281
I/O	6	P113	P48	R1	284
I/O	6	P112	P49	М3	287
M1	-	P111	P50	P2	290
GND	-	P110	P51	GND*	-
MO	-	P109	P52	N3	291
V <sub>CCO</sub>	6	P108	P53	V <sub>CCO</sub> Bank 6*	-
V <sub>CCO</sub>	5	P107	P53	V <sub>CCO</sub> Bank 5*	-
M2	-	P106	P54	R3	292
I/O	5	-	-	N5	299
I/O	5	P103	P57	T2	302
I/O	5	-	-	P5	305
I/O	5	-	P58	Т3	308
GND	-	-	-	GND*	-
I/O, V <sub>REF</sub>	5	P102	P59	T4	311
I/O	5	-	P60	M6	314
I/O	5	-	-	T5	317
I/O	5	P101	P61	N6	320
I/O	5	P100	P62	R5	323
I/O	5	P99	P63	P6	326
GND	-	P98	P64	GND*	-
V <sub>CCO</sub>	5	-	P65	V <sub>CCO</sub> Bank 5*	-
V <sub>CCINT</sub>	-	P97	P66	V <sub>CCINT</sub> *	-
I/O	5	P96	P67	R6	329



XC2S50 Pad Name			•	,	Dua aluma
Function	Bank	TQ144	PQ208	FG256	Bndry Scan
I/O	5	P95	P68	M7	332
I/O	5	-	P69	N7	338
I/O	5	-	P70	T6	341
I/O	5	-	P71	P7	344
GND	-	-	P72	GND*	-
I/O, V <sub>REF</sub>	5	P94	P73	P8	347
I/O	5	-	P74	R7	350
I/O	5	-	-	T7	353
I/O	5	P93	P75	T8	356
V <sub>CCINT</sub>	-	P92	P76	V <sub>CCINT</sub> *	-
I, GCK1	5	P91	P77	R8	365
V <sub>CCO</sub>	5	P90	P78	V <sub>CCO</sub> Bank 5*	-
V <sub>CCO</sub>	4	P90	P78	V <sub>CCO</sub> Bank 4*	-
GND	-	P89	P79	GND*	-
I, GCK0	4	P88	P80	N8	366
I/O	4	P87	P81	N9	370
I/O	4	P86	P82	R9	373
I/O	4	-	-	N10	376
I/O	4	-	P83	Т9	379
I/O, V <sub>REF</sub>	4	P85	P84	P9	382
GND	-	-	P85	GND*	-
I/O	4	-	P86	M10	385
I/O	4	-	P87	R10	388
I/O	4	-	P88	P10	391
I/O	4	P84	P89	T10	397
I/O	4	P83	P90	R11	400
V <sub>CCINT</sub>	-	P82	P91	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	4	-	P92	V <sub>CCO</sub> Bank 4*	-
GND	-	P81	P93	GND*	-
I/O	4	P80	P94	M11	403
I/O	4	P79	P95	T11	406
I/O	4	P78	P96	N11	409
I/O	4	-	-	R12	412
I/O	4	-	P97	P11	415
I/O, V <sub>REF</sub>	4	P77	P98	T12	418
GND	-	-	-	GND*	
I/O	4	-	P99	T13	421
I/O	4		-	N12	424
I/O	4	P76	P100	R13	427

XC2S50 Pad Name					Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
I/O	4	-	-	P12	430
I/O	4	P75	P101	P13	433
I/O	4	P74	P102	T14	436
GND	-	P73	P103	GND*	-
DONE	3	P72	P104	R14	439
V <sub>cco</sub>	4	P71	P105	V <sub>CCO</sub> Bank 4*	-
V <sub>CCO</sub>	3	P70	P105	V <sub>CCO</sub> Bank 3*	-
PROGRAM	-	P69	P106	P15	442
I/O (INIT)	3	P68	P107	N15	443
I/O (D7)	3	P67	P108	N14	446
I/O	3	-	-	T15	449
I/O	3	P66	P109	M13	452
I/O	3	ı	-	R16	455
I/O	3	-	P110	M14	458
GND	-	-	-	GND*	-
I/O, V <sub>REF</sub>	3	P65	P111	L14	461
I/O	3	-	P112	M15	464
I/O	3	-	-	L12	467
I/O	3	P64	P113	P16	470
I/O	3	P63	P114	L13	473
I/O (D6)	3	P62	P115	N16	476
GND	-	P61	P116	GND*	-
V <sub>cco</sub>	3	-	P117	V <sub>CCO</sub> Bank 3*	-
V <sub>CCINT</sub>	-	-	P118	V <sub>CCINT</sub> *	-
I/O (D5)	3	P60	P119	M16	479
I/O	3	P59	P120	K14	482
I/O	3	-	-	L16	485
I/O	3	-	P121	K13	488
I/O	3	-	P122	L15	491
I/O	3	-	P123	K12	494
GND	-	-	P124	GND*	-
I/O, V <sub>REF</sub>	3	P58	P125	K16	497
I/O (D4)	3	P57	P126	J16	500
I/O	3	-	-	J14	503
I/O	3	P56	P127	K15	506
V <sub>CCINT</sub>	-	P55	P128	V <sub>CCINT</sub> *	-
I/O, TRDY <sup>(1)</sup>	3	P54	P129	J15	512
V <sub>CCO</sub>	3	P53	P130	V <sub>CCO</sub> Bank 3*	-



XC2S50 Pad N	Name				Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
V <sub>CCO</sub>	2	P53	P130	V <sub>CCO</sub> Bank 2*	-
GND	-	P52	P131	GND*	-
I/O, IRDY <sup>(1)</sup>	2	P51	P132	H16	515
I/O	2	-	P133	H14	518
I/O	2	P50	P134	H15	521
I/O	2	-	-	J13	524
I/O (D3)	2	P49	P135	G16	527
I/O, V <sub>REF</sub>	2	P48	P136	H13	530
GND	-	-	P137	GND*	-
I/O	2	-	P138	G14	533
I/O	2	-	P139	G15	536
I/O	2	-	P140	G12	539
I/O	2	-	-	F16	542
I/O	2	P47	P141	G13	545
I/O (D2)	2	P46	P142	F15	548
V <sub>CCINT</sub>	-	-	P143	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	2	-	P144	V <sub>CCO</sub> Bank 2*	-
GND	-	P45	P145	GND*	-
I/O (D1)	2	P44	P146	E16	551
I/O	2	P43	P147	F14	554
I/O	2	P42	P148	D16	557
I/O	2	-	-	F12	560
I/O	2	-	P149	E15	563
I/O, V <sub>REF</sub>	2	P41	P150	F13	566
GND	-	-	-	GND*	-
I/O	2	-	P151	E14	569
I/O	2	-	-	C16	572
I/O	2	P40	P152	E13	575
I/O	2	-	-	B16	578
I/O (DIN, D0)	2	P39	P153	D14	581
I/O (DOUT, BUSY)	2	P38	P154	C15	584
CCLK	2	P37	P155	D15	587
V <sub>CCO</sub>	2	P36	P156	V <sub>CCO</sub> Bank 2*	-
V <sub>CCO</sub>	1	P35	P156	V <sub>CCO</sub> Bank 1*	-
TDO	2	P34	P157	B14	-
GND	-	P33	P158	GND*	-
TDI	-	P32	P159	A15	-
I/O (CS)	1	P31	P160	B13	0

XC2S50 Pad N	Name				Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
I/O (WRITE)	1	P30	P161	C13	3
I/O	1	-	-	C12	6
I/O	1	P29	P162	A14	9
I/O	1	-	-	D12	12
I/O	1	-	P163	B12	15
GND	-	-	-	GND*	-
I/O, V <sub>REF</sub>	1	P28	P164	C11	18
I/O	1	-	P165	A13	21
I/O	1	-	-	D11	24
I/O	1	-	P166	A12	27
I/O	1	P27	P167	E11	30
I/O	1	P26	P168	B11	33
GND	-	P25	P169	GND*	-
V <sub>cco</sub>	1	-	P170	V <sub>CCO</sub> Bank 1*	-
V <sub>CCINT</sub>	-	P24	P171	V <sub>CCINT</sub> *	-
I/O	1	P23	P172	A11	36
I/O	1	P22	P173	C10	39
I/O	1	-	P174	B10	45
I/O	1	-	P175	D10	48
I/O	1	-	P176	A10	51
GND	-	-	P177	GND*	-
I/O, V <sub>REF</sub>	1	P21	P178	В9	54
I/O	1	-	P179	E10	57
I/O	1	-	-	A9	60
I/O	1	P20	P180	D9	63
I/O	1	P19	P181	A8	66
I, GCK2	1	P18	P182	C9	72
GND	-	P17	P183	GND*	-
V <sub>cco</sub>	1	P16	P184	V <sub>CCO</sub> Bank 1*	-
V <sub>cco</sub>	0	P16	P184	V <sub>CCO</sub> Bank 0*	-
I, GCK3	0	P15	P185	B8	73
V <sub>CCINT</sub>	-	P14	P186	V <sub>CCINT</sub> *	-
I/O	0	P13	P187	A7	80
I/O	0	-	-	D8	83
I/O	0	-	P188	A6	86
I/O, V <sub>REF</sub>	0	P12	P189	B7	89
GND	-	-	P190	GND*	-
I/O	0	-	P191	C8	92
I/O	0	-	P192	D7	95
	1		1	1	



XC2S50 Pad	Name				Bndry
Function	Bank	TQ144	PQ208	FG256	Scan
I/O	0	-	P193	E7	98
I/O	0	P11	P194	C7	104
I/O	0	P10	P195	В6	107
V <sub>CCINT</sub>	-	P9	P196	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	0	-	P197	V <sub>CCO</sub> Bank 0*	-
GND	-	P8	P198	GND*	-
I/O	0	P7	P199	A5	110
I/O	0	P6	P200	C6	113
I/O	0	-	P201	B5	116
I/O	0	-	-	D6	119
I/O	0	-	P202	A4	122
I/O, V <sub>REF</sub>	0	P5	P203	B4	125
GND	-	-	-	GND*	-
I/O	0	-	P204	E6	128
I/O	0	-	-	D5	131
I/O	0	P4	P205	A3	134
I/O	0	-	-	C5	137
I/O	0	P3	P206	В3	140
TCK	-	P2	P207	C4	-
V <sub>CCO</sub>	0	P1	P208	V <sub>CCO</sub> Bank 0*	-
V <sub>CCO</sub>	7	P144	P208	V <sub>CCO</sub> Bank 7*	-

04/18/01

### Notes:

- IRDY and TRDY can only be accessed when using Xilinx PCI cores.
- 2. Pads labelled GND\*,  $V_{CCINT}^*$ ,  $V_{CCO}$  Bank 0\*,  $V_{CCO}$  Bank 1\*,  $V_{CCO}$  Bank 2\*,  $V_{CCO}$  Bank 3\*,  $V_{CCO}$  Bank 4\*,  $V_{CCO}$  Bank 5\*,  $V_{CCO}$  Bank 6\*,  $V_{CCO}$  Bank 7\* are internally bonded to independent ground or power planes within the package.

### **Additional XC2S50 Package Pins**

#### **TQ144**

Not Connected Pins							
P104	P105	-	-	-	-		
11/02/00							

#### PQ208

Not Connected Pins								
P55	P56	-	-	-	-			
11/02/00	•		•					

#### FG256

FG256									
V <sub>CCINT</sub> Pins									
C3	C14	D4	D13	E5	E12				
M5	M12	N4	N13	P3	P14				
V <sub>CCO</sub> Bank 0 Pins									
E8	F8	-	-	-	-				
V <sub>CCO</sub> Bank 1 Pins									
E9	F9	-	-	-	-				
		V <sub>CCO</sub> Ba	nk 2 Pins						
H11	H12	-	-	-	-				
		V <sub>CCO</sub> Ba	nk 3 Pins		•				
J11	J12	-	-	-	-				
V <sub>CCO</sub> Bank 4 Pins									
L9	M9	-	-	-	-				
V <sub>CCO</sub> Bank 5 Pins									
L8	M8	-	-	-	-				
		V <sub>CCO</sub> Ba	nk 6 Pins						
J5	J6	-	-	-	-				
		V <sub>CCO</sub> Ba	nk 7 Pins						
H5	H6	-	-	-	-				
		GND	Pins						
A1	A16	B2	B15	F6	F7				
F10	F11	G6	G7	G8	G9				
G10	G11	H7	H8	H9	H10				
J7	J8	J9	J10	K6	K7				
K8	K9	K10	K11	L6	L7				
L10	L11	R2	R15	T1	T16				
		Not Conn	ected Pins		,				
P4	R4	-	-	-	-				
11/02/00		•							



### **XC2S100 Device Pinouts**

XC2S100 Name	Pad					Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
GND	-	P143	P1	GND*	GND*	-
TMS	-	P142	P2	D3	D3	-
I/O	7	P141	P3	C2	B1	185
I/O	7	-	-	A2	F5	191
I/O	7	P140	P4	B1	D2	194
I/O	7	-	-	-	E3	197
I/O	7	-	-	E3	G5	200
I/O	7	-	P5	D2	F3	203
GND	-	-	-	GND*	GND*	-
V <sub>CCO</sub>	7	-	-	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
I/O, V <sub>REF</sub>	7	P139	P6	C1	E2	206
I/O	7	-	P7	F3	E1	209
I/O	7	-	-	E2	H5	215
I/O	7	P138	P8	E4	F2	218
I/O	7	-	-	-	F1	221
I/O, V <sub>REF</sub>	7	P137	P9	D1	H4	224
I/O	7	P136	P10	E1	G1	227
GND	-	P135	P11	GND*	GND*	-
V <sub>CCO</sub>	7	-	P12	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
V <sub>CCINT</sub>	-	-	P13	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	7	P134	P14	F2	НЗ	230
I/O	7	P133	P15	G3	H2	233
I/O	7	-	-	F1	J5	236
I/O	7	-	P16	F4	J2	239
I/O	7	-	P17	F5	K5	245
I/O	7	-	P18	G2	K1	248
GND	-	-	P19	GND*	GND*	-
I/O, V <sub>REF</sub>	7	P132	P20	НЗ	K3	251
I/O	7	P131	P21	G4	K4	254
I/O	7	-	-	H2	L6	257
I/O	7	P130	P22	G5	L1	260
I/O	7	-	P23	H4	L4	266
I/O, IRDY <sup>(1)</sup>	7	P129	P24	G1	L3	269
GND	-	P128	P25	GND*	GND*	-
V <sub>CCO</sub>	7	P127	P26	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
V <sub>CCO</sub>	6	P127	P26	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
I/O, TRDY <sup>(1)</sup>	6	P126	P27	J2	M1	272

XC2S100 Name	Pad					Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
V <sub>CCINT</sub>	-	P125	P28	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	6	P124	P29	H1	М3	281
I/O	6	-	-	J4	M4	284
I/O	6	P123	P30	J1	M5	287
I/O, V <sub>REF</sub>	6	P122	P31	J3	N2	290
GND	-	-	P32	GND*	GND*	-
I/O	6	-	P33	K5	N3	293
I/O	6	-	P34	K2	N4	296
I/O	6	-	P35	K1	P2	302
I/O	6	-	-	K3	P4	305
I/O	6	P121	P36	L1	P3	308
I/O	6	P120	P37	L2	R2	311
V <sub>CCINT</sub>	-	-	P38	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	6	-	P39	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	P119	P40	GND*	GND*	-
I/O	6	P118	P41	K4	T1	314
I/O, V <sub>REF</sub>	6	P117	P42	M1	R4	317
I/O	6	-	-	-	T2	320
I/O	6	P116	P43	L4	U1	323
I/O	6	-	-	M2	R5	326
I/O	6	-	P44	L3	U2	332
I/O, V <sub>REF</sub>	6	P115	P45	N1	T3	335
V <sub>CCO</sub>	6	-	-	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	-	-	GND*	GND*	-
I/O	6	-	P46	P1	T4	338
I/O	6	-	-	L5	W1	341
I/O	6	-	-	-	U4	344
I/O	6	P114	P47	N2	Y1	347
I/O	6	-	-	M4	W2	350
I/O	6	P113	P48	R1	Y2	356
I/O	6	P112	P49	МЗ	W3	359
M1	-	P111	P50	P2	U5	362
GND	-	P110	P51	GND*	GND*	-
MO	-	P109	P52	N3	AB2	363
V <sub>CCO</sub>	6	P108	P53	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
V <sub>CCO</sub>	5	P107	P53	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
M2	-	P106	P54	R3	Y4	364
I/O	5	-	-	N5	V7	374



XC2S100 Name						Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
I/O	5	P103	P57	T2	Y6	377
I/O	5	-	-	-	AA4	380
I/O	5	-	-	P5	W6	383
I/O	5	-	P58	Т3	Y7	386
GND	-	-	-	GND*	GND*	-
V <sub>CCO</sub>	5	-	-	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
I/O, V <sub>REF</sub>	5	P102	P59	T4	AA5	389
I/O	5	-	P60	M6	AB5	392
I/O	5	-	-	T5	AB6	398
I/O	5	P101	P61	N6	AA7	401
I/O	5	-	-	-	W7	404
I/O, V <sub>REF</sub>	5	P100	P62	R5	W8	407
I/O	5	P99	P63	P6	Y8	410
GND	-	P98	P64	GND*	GND*	-
V <sub>CCO</sub>	5	-	P65	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
V <sub>CCINT</sub>	-	P97	P66	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	5	P96	P67	R6	AA8	413
I/O	5	P95	P68	M7	V9	416
I/O	5	-	-	-	AB9	419
I/O	5	-	P69	N7	Y9	422
I/O	5	-	P70	T6	W10	428
I/O	5	-	P71	P7	AB10	431
GND	-	-	P72	GND*	GND*	-
I/O, V <sub>REF</sub>	5	P94	P73	P8	Y10	434
I/O	5	ı	P74	R7	V11	437
I/O	5	-	-	T7	W11	440
I/O	5	P93	P75	T8	AB11	443
$V_{CCINT}$	-	P92	P76	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I, GCK1	5	P91	P77	R8	Y11	455
V <sub>CCO</sub>	5	P90	P78	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	1
V <sub>CCO</sub>	4	P90	P78	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P89	P79	GND*	GND*	-
I, GCK0	4	P88	P80	N8	W12	456
I/O	4	P87	P81	N9	U12	460
I/O	4	P86	P82	R9	Y12	466
I/O	4	-	-	N10	AA12	469
I/O	4	-	P83	T9	AB13	472
I/O, V <sub>REF</sub>	4	P85	P84	P9	AA13	475

XC2S100 Name	Pad					Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
GND	-	-	P85	GND*	GND*	-
I/O	4	-	P86	M10	Y13	478
I/O	4	•	P87	R10	V13	481
I/O	4	•	P88	P10	AA14	487
I/O	4	-	-	-	V14	490
I/O	4	P84	P89	T10	AB15	493
I/O	4	P83	P90	R11	AA15	496
V <sub>CCINT</sub>	-	P82	P91	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	4	•	P92	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	•
GND	-	P81	P93	GND*	GND*	-
I/O	4	P80	P94	M11	Y15	499
I/O, V <sub>REF</sub>	4	P79	P95	T11	AB16	502
I/O	4	-	-	-	AB17	505
I/O	4	P78	P96	N11	V15	508
I/O	4	-	-	R12	Y16	511
I/O	4	-	P97	P11	AB18	517
I/O, V <sub>REF</sub>	4	P77	P98	T12	AB19	520
V <sub>CCO</sub>	4	-	-	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	-	-	GND*	GND*	•
I/O	4	-	P99	T13	Y17	523
I/O	4	-	-	N12	V16	526
I/O	4	-	-	-	W17	529
I/O	4	P76	P100	R13	AB20	532
I/O	4	-	-	P12	AA19	535
I/O	4	P75	P101	P13	AA20	541
I/O	4	P74	P102	T14	W18	544
GND	-	P73	P103	GND*	GND*	-
DONE	3	P72	P104	R14	Y19	547
V <sub>CCO</sub>	4	P71	P105	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
V <sub>CCO</sub>	3	P70	P105	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
PROGRAM	-	P69	P106	P15	W20	550
I/O (INIT)	3	P68	P107	N15	V19	551
I/O (D7)	3	P67	P108	N14	Y21	554
I/O	3	-	-	T15	W21	560
I/O	3	P66	P109	M13	U20	563
I/O	3	-	-	-	U19	566
I/O	3	-	-	R16	T18	569
I/O	3	-	P110	M14	W22	572



Function         Bank         TQ144         PQ208         FG456         FG456         Scan           GND         -         -         -         GND*         -         -           VCCO         3         -         -         VCCO         VCCO         -           I/O, VREF         3         P65         P111         L14         U21         575           I/O         3         -         P112         M15         T20         578           I/O         3         -         P112         M15         T20         578           I/O         3         P64         P113         P16         R18         587           I/O         3         P64         P113         P16         R18         587           I/O         3         P63         P114         L13         R19         593           I/O         106         3         P62         P115         N16         T22         596           GND         -         P61         P116         GND*         -         -         P118         VCCINT**         VCCIO         -         -           VCCINT         -         P61         P116	XC2S100 Name	Pad					Bndry
VCCO         3         -         VCCO Bank 3* Bank 3* Bank 3* Bank 3*         -         -         VCCO Bank 3* Bank 3* Bank 3* Bank 3*         -         -         VCCO Bank 3* Bank 3* Bank 3*         -         -         -         VCCO Bank 3* Bank 3*         - <th>Function</th> <th>Bank</th> <th>TQ144</th> <th>PQ208</th> <th>FG256</th> <th>FG456</th> <th>-</th>	Function	Bank	TQ144	PQ208	FG256	FG456	-
	GND	-	-	-	GND*	GND*	-
	V <sub>CCO</sub>	3	-	-			-
	I/O, V <sub>REF</sub>	3	P65	P111	L14	U21	575
	I/O	3	-	P112	M15	T20	578
	I/O	3	•	-	L12	T21	584
	I/O	3	P64	P113	P16	R18	587
	I/O	3	-	-	-	U22	590
GND - P61 P116 GND* GND* - VCCO Bank 3* Bank 3* P60 P119 M16 R21 599 P100 K14 P18 602 P100 S100 S100 S100 S100 S100 S100 S100	I/O, V <sub>REF</sub>	3	P63	P114	L13	R19	593
VCCO         3         -         P117         VCCO Bank 3* Bank 3*         -         -         P118 VCCINT* Dank 3*         -         -         -         P118 VCCINT* Dank 3*         -         -         -         P118 VCCINT* Dank 3*         - </td <td>I/O (D6)</td> <td>3</td> <td>P62</td> <td>P115</td> <td>N16</td> <td>T22</td> <td>596</td>	I/O (D6)	3	P62	P115	N16	T22	596
Bank 3*   Bank 3*	GND	-	P61	P116	GND*	GND*	-
	V <sub>CCO</sub>	3	-	P117			-
	V <sub>CCINT</sub>	-	-	P118	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	
	I/O (D5)	3	P60	P119	M16	R21	599
	I/O	3	P59	P120	K14	P18	602
	I/O	3	-	-	L16	P20	605
NO   3	I/O	3	-	P121	K13	P21	608
GND P124 GND* GND* - I/O, V <sub>REF</sub> 3 P58 P125 K16 N21 620 I/O (D4) 3 P57 P126 J16 N22 623 I/O 3 - J14 M19 626 I/O 3 P56 P127 K15 M20 629 V <sub>CCINT</sub> - P55 P128 E5 V <sub>CCINT</sub> * - I/O, TRDY(1) 3 P54 P129 J15 M22 638 V <sub>CCO</sub> 3 P53 P130 V <sub>CCO</sub> Bank 3* Bank 3* P54 P129 J15 M22 638 I/O (D4) P55 P131 GND* GND* - I/O, IRDY(1) 2 P51 P132 H16 L20 641 I/O 2 P50 P134 H15 L21 650 I/O 2 P49 P135 G16 K20 656 I/O, V <sub>REF</sub> 2 P48 P136 H13 K21 659 GND - P137 GND* - I/O, V <sub>REF</sub> 2 P48 P136 G14 K22 662 I/O 2 - P138 G14 K22 662	I/O	3	-	P122	L15	N18	614
NO, VREF   3	I/O	3	-	P123	K12	N20	617
	GND	-	-	P124	GND*	GND*	-
I/O   3	I/O, V <sub>REF</sub>	3	P58	P125	K16	N21	620
NO   3   P56   P127   K15   M20   629     V_{CCINT   -   P55   P128   E5   V_{CCINT   -   P17   E17   E17	I/O (D4)	3	P57	P126	J16	N22	623
VCCINT         -         P55         P128         E5         VCCINT*         -           I/O, TRDY(1)         3         P54         P129         J15         M22         638           VCCO         3         P53         P130         VCCO Bank 3*         -         -           VCCO         2         P53         P130         VCCO Bank 2*         VCCO Bank 2*         -           GND         -         P52         P131         GND*         GND*         -           I/O, IRDY(1)         2         P51         P132         H16         L20         641           I/O         2         -         P133         H14         L17         644           I/O         2         P50         P134         H15         L21         650           I/O         2         -         -         J13         L22         653           I/O (D3)         2         P49         P135         G16         K20         656           I/O, VREF         2         P48         P136         H13         K21         659           GND         -         -         P137         GND*         GND*         -	I/O	3	-	-	J14	M19	626
Voco   3	I/O	3	P56	P127	K15	M20	629
I/O, TRDY <sup>(1)</sup>   3	V <sub>CCINT</sub>	-	P55	P128	E5	V <sub>CCINT</sub> *	-
Bank 3*   Bank 3*   VCCO   P53   P130   VCCO   Bank 2*   CCO   CCO	I/O, TRDY <sup>(1)</sup>	3	P54	P129	J15	M22	638
Bank 2* Bank 2* Bank 2* GND - P52 P131 GND* GND* - I/O, IRDY <sup>(1)</sup> 2 P51 P132 H16 L20 641 I/O 2 - P133 H14 L17 644 I/O 2 P50 P134 H15 L21 650 I/O 2 - J13 L22 653 I/O (D3) 2 P49 P135 G16 K20 656 I/O, V <sub>REF</sub> 2 P48 P136 H13 K21 659 GND - P137 GND* GND* - I/O 2 - P138 G14 K22 662 I/O 2 - P139 G15 J21 665	V <sub>CCO</sub>	3	P53	P130	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
I/O, IRDY <sup>(1)</sup> 2       P51       P132       H16       L20       641         I/O       2       -       P133       H14       L17       644         I/O       2       P50       P134       H15       L21       650         I/O       2       -       -       J13       L22       653         I/O (D3)       2       P49       P135       G16       K20       656         I/O, V <sub>REF</sub> 2       P48       P136       H13       K21       659         GND       -       -       P137       GND*       GND*       -         I/O       2       -       P138       G14       K22       662         I/O       2       -       P139       G15       J21       665	V <sub>CCO</sub>	2	P53	P130	V <sub>CCO</sub> Bank 2*		-
I/O       2       -       P133       H14       L17       644         I/O       2       P50       P134       H15       L21       650         I/O       2       -       -       J13       L22       653         I/O (D3)       2       P49       P135       G16       K20       656         I/O, V <sub>REF</sub> 2       P48       P136       H13       K21       659         GND       -       -       P137       GND*       GND*       -         I/O       2       -       P138       G14       K22       662         I/O       2       -       P139       G15       J21       665	GND	-	P52	P131	GND*	GND*	-
I/O     2     P50     P134     H15     L21     650       I/O     2     -     -     J13     L22     653       I/O (D3)     2     P49     P135     G16     K20     656       I/O, V <sub>REF</sub> 2     P48     P136     H13     K21     659       GND     -     -     P137     GND*     GND*     -       I/O     2     -     P138     G14     K22     662       I/O     2     -     P139     G15     J21     665	I/O, IRDY <sup>(1)</sup>	2	P51	P132	H16	L20	641
I/O     2     -     -     J13     L22     653       I/O (D3)     2     P49     P135     G16     K20     656       I/O, V <sub>REF</sub> 2     P48     P136     H13     K21     659       GND     -     -     P137     GND*     GND*     -       I/O     2     -     P138     G14     K22     662       I/O     2     -     P139     G15     J21     665	I/O	2	-	P133	H14	L17	644
I/O (D3)     2     P49     P135     G16     K20     656       I/O, V <sub>REF</sub> 2     P48     P136     H13     K21     659       GND     -     -     P137     GND*     GND*     -       I/O     2     -     P138     G14     K22     662       I/O     2     -     P139     G15     J21     665	I/O	2	P50	P134	H15	L21	650
I/O, V <sub>REF</sub> 2     P48     P136     H13     K21     659       GND     -     -     P137     GND*     GND*     -       I/O     2     -     P138     G14     K22     662       I/O     2     -     P139     G15     J21     665	I/O	2	-	-	J13	L22	653
GND P137 GND* GND* - I/O 2 - P138 G14 K22 662 I/O 2 - P139 G15 J21 665	I/O (D3)	2	P49	P135	G16	K20	656
I/O     2     -     P138     G14     K22     662       I/O     2     -     P139     G15     J21     665	I/O, V <sub>REF</sub>	2	P48	P136	H13	K21	659
I/O 2 - P139 G15 J21 665	GND	-	-	P137	GND*	GND*	-
	I/O	2	-	P138	G14	K22	662
I/O 2 - P140 G12 J18 671	I/O	2	-	P139	G15	J21	665
	I/O	2	-	P140	G12	J18	671

XC2S100 Name			•			Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
I/O	2	-	-	F16	J22	674
I/O	2	P47	P141	G13	H19	677
I/O (D2)	2	P46	P142	F15	H20	680
V <sub>CCINT</sub>	-	-	P143	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	2	-	P144	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	P45	P145	GND*	GND*	-
I/O (D1)	2	P44	P146	E16	H22	683
$I/O, V_{REF}$	2	P43	P147	F14	H18	686
I/O	2	1	-	-	G21	689
I/O	2	P42	P148	D16	G18	692
I/O	2	-	-	F12	G20	695
I/O	2	-	P149	E15	F19	701
I/O, V <sub>REF</sub>	2	P41	P150	F13	F21	704
V <sub>CCO</sub>	2	-	-	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	-	-	GND*	GND*	-
I/O	2	-	P151	E14	F20	707
I/O	2	-	-	C16	F18	710
I/O	2	-	-	-	E21	713
I/O	2	P40	P152	E13	D22	716
I/O	2	-	-	B16	E20	719
I/O (DIN, D0)	2	P39	P153	D14	D20	725
I/O (DOUT, BUSY)	2	P38	P154	C15	C21	728
CCLK	2	P37	P155	D15	B22	731
V <sub>CCO</sub>	2	P36	P156	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
V <sub>CCO</sub>	1	P35	P156	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
TDO	2	P34	P157	B14	A21	-
GND	-	P33	P158	GND*	GND*	-
TDI	-	P32	P159	A15	B20	-
I/O (CS)	1	P31	P160	B13	C19	0
I/O (WRITE)	1	P30	P161	C13	A20	3
I/O	1	-	-	C12	D17	9
I/O	1	P29	P162	A14	A19	12
I/O	1	-	-	-	B18	15
I/O	1	-	-	D12	C17	18
I/O	1	-	P163	B12	D16	21
GND	-	-	-	GND*	GND*	-



	XC2S100 Pad Name					Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
V <sub>CCO</sub>	1	-	-	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
I/O, V <sub>REF</sub>	1	P28	P164	C11	A18	24
I/O	1	-	P165	A13	B17	27
I/O	1	-	-	D11	D15	33
I/O	1	-	P166	A12	C16	36
I/O	1	-	-	-	D14	39
I/O, V <sub>REF</sub>	1	P27	P167	E11	E14	42
I/O	1	P26	P168	B11	A16	45
GND	-	P25	P169	GND*	GND*	•
V <sub>CCO</sub>	1	-	P170	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
V <sub>CCINT</sub>	-	P24	P171	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	•
I/O	1	P23	P172	A11	C15	48
I/O	1	P22	P173	C10	B15	51
I/O	1	-	-	-	F12	54
I/O	1	-	P174	B10	C14	57
I/O	1	-	P175	D10	D13	63
I/O	1	-	P176	A10	C13	66
GND	-	-	P177	GND*	GND*	
I/O, V <sub>REF</sub>	1	P21	P178	В9	B13	69
I/O	1	-	P179	E10	E12	72
I/O	1	-	-	A9	B12	75
I/O	1	P20	P180	D9	D12	78
I/O	1	P19	P181	A8	D11	84
I, GCK2	1	P18	P182	C9	A11	90
GND	-	P17	P183	GND*	GND*	
V <sub>CCO</sub>	1	P16	P184	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
V <sub>CCO</sub>	0	P16	P184	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
I, GCK3	0	P15	P185	B8	C11	91
V <sub>CCINT</sub>	-	P14	P186	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	
I/O	0	P13	P187	A7	A10	101
I/O	0	-	-	D8	B10	104

### XC2S100 Device Pinouts (Continued)

XC2S100 Name	Pad					Bndry
Function	Bank	TQ144	PQ208	FG256	FG456	Scan
I/O	0	-	P188	A6	C10	107
I/O, V <sub>REF</sub>	0	P12	P189	B7	A9	110
GND	-	-	P190	GND*	GND*	-
I/O	0	-	P191	C8	B9	113
I/O	0	-	P192	D7	E10	116
I/O	0	-	P193	E7	A8	122
I/O	0	-	-	-	D9	125
I/O	0	P11	P194	C7	E9	128
I/O	0	P10	P195	B6	A7	131
V <sub>CCINT</sub>	-	P9	P196	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	0	-	P197	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	P8	P198	GND*	GND*	-
I/O	0	P7	P199	A5	B7	134
I/O, V <sub>REF</sub>	0	P6	P200	C6	E8	137
I/O	0	-	-	-	D8	140
I/O	0	-	P201	B5	C7	143
I/O	0	-	-	D6	D7	146
I/O	0	-	P202	A4	D6	152
I/O, V <sub>REF</sub>	0	P5	P203	B4	C6	155
V <sub>CCO</sub>	0	-	-	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	-	-	GND*	GND*	1
I/O	0	-	P204	E6	B5	158
I/O	0	-	-	D5	E7	161
I/O	0	-	-	-	E6	164
I/O	0	P4	P205	A3	B4	167
I/O	0	-	-	C5	A3	170
I/O	0	P3	P206	В3	C5	176
TCK	-	P2	P207	C4	C4	-
V <sub>CCO</sub>	0	P1	P208	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
V <sub>CCO</sub>	7	P144	P208	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-

04/18/01

#### Notes:

- IRDY and TRDY can only be accessed when using Xilinx PCI cores.
- 2. Pads labelled GND\*,  $V_{CCINT}^*$ ,  $V_{CCO}$  Bank 0\*,  $V_{CCO}$  Bank 1\*,  $V_{CCO}$  Bank 2\*,  $V_{CCO}$  Bank 3\*,  $V_{CCO}$  Bank 4\*,  $V_{CCO}$  Bank 5\*,  $V_{CCO}$  Bank 6\*,  $V_{CCO}$  Bank 7\* are internally bonded to independent ground or power planes within the package.



### **Additional XC2S100 Package Pins**

### TQ144

Not Connected Pins									
P104	P105	-	-	-	-				
11/02/00									

#### **PQ208**

	Not Connected Pins									
P55	P56	-	-	-	-					
11/02/00										

#### FG256

. 0.200											
V <sub>CCINT</sub> Pins											
C3	C14	D4	D13	E5	E12						
M5	M12	N4	N13	P3	P14						
	V <sub>CCO</sub> Bank 0 Pins										
E8	F8	-	-	-	-						
V <sub>CCO</sub> Bank 1 Pins											
E9	F9	-	-	-	-						
		V <sub>CCO</sub> Ba	nk 2 Pins								
H11	H12	-	-	-	-						
		V <sub>CCO</sub> Ba	nk 3 Pins								
J11	J12	-	-	-	-						
V <sub>CCO</sub> Bank 4 Pins											
L9	M9	-	-	-	-						
		V <sub>CCO</sub> Ba	nk 5 Pins								
L8	M8	-	-	-	-						
		V <sub>CCO</sub> Ba	nk 6 Pins								
J5	J6	-	-		-						
		V <sub>CCO</sub> Ba	nk 7 Pins								
H5	H6	-	-	-	-						
		GND	Pins								
A1	A16	B2	B15	F6	F7						
F10	F11	G6	G7	G8	G9						
G10	G11	H7	H8	H9	H10						
J7	J8	J9	J10	K6	K7						
K8	K9	K10	K11	L6	L7						
L10	L11	R2	R15	T1	T16						
		Not Conn	ected Pins		·						
P4	R4	-	-	-	-						
11/02/00	•		1		,						

### 11/02/00 **FG456**

V <sub>CCINT</sub> Pins									
E5	E18	F6	F17	G7	G8				
G9	G14	G15	G16	H7	H16				
J7	J16	P7	P16	R7	R16				
T7	T8	T9	T14	T15	T16				
U6	U17	V5	V18	-	-				
	V <sub>CCO</sub> Bank 0 Pins								
F10	F7	F8	F9	G10	G11				

### Additional XC2S100 Package Pins (Continued)

		Voca Bai	nk 1 Pins	•	
F13	F14	F15	F16	G12	G13
			nk 2 Pins		0.10
G17	H17	J17	K16	K17	L16
G17	1117	V <sub>CCO</sub> Baı		1317	
M16	N16	N17	P17	R17	T17
IVITO	1410		nk 4 Pins	1117	117
T12	T13	U13	U14	U15	U16
112	113		_	013	010
T10	T44	1	nk 5 Pins U7	1.10	U9
T10	T11	V <sub>CCO</sub> Baı	_	U8	09
N 4-7	NO			DO	TO
M7	N6	N7	P6	R6	T6
		V <sub>CCO</sub> Bai	,	1/7	
G6	H6	J6	K6	K7	L7
		GND			
A1	A22	B2	B21	C3	C20
J9	J10	J11	J12	J13	J14
K9	K10	K11	K12	K13	K14
L9	L10	L11	L12	L13	L14
M9	M10	M11	M12	M13	M14
N9	N10	N11	N12	N13	N14
P9	P10	P11	P12	P13	P14
Y3	Y20	AA2	AA21	AB1	AB22
		Not Conne	ected Pins		
A2	A4	A5	A6	A12	A13
A14	A15	A17	В3	В6	B8
B11	B14	B16	B19	C1	C2
C8	C9	C12	C18	C22	D1
D4	D5	D10	D18	D19	D21
E4	E11	E13	E15	E16	E17
E19	E22	F4			
G3		17	F11	F22	G2
	G4	G19	F11 G22	F22 H1	G2 H21
J1					
	G4	G19	G22	H1	H21
J1	G4 J3	G19 J4	G22 J19	H1 J20	H21 K2
J1 K18	G4 J3 K19	G19 J4 L2	G22 J19 L5	H1 J20 L18	H21 K2 L19
J1 K18 M2	G4 J3 K19 M6	G19 J4 L2 M17	G22 J19 L5 M18	H1 J20 L18 M21	H21 K2 L19 N1
J1 K18 M2 N5	G4 J3 K19 M6 N19	G19 J4 L2 M17 P1	G22 J19 L5 M18 P5	H1 J20 L18 M21 P19	H21 K2 L19 N1 P22
J1 K18 M2 N5 R1	G4 J3 K19 M6 N19	G19 J4 L2 M17 P1 R20	G22 J19 L5 M18 P5 R22	H1 J20 L18 M21 P19	H21 K2 L19 N1 P22 T19
J1 K18 M2 N5 R1 U3	G4  J3  K19  M6  N19  R3  U11	G19 J4 L2 M17 P1 R20 U18	G22 J19 L5 M18 P5 R22 V1	H1 J20 L18 M21 P19 T5 V2	H21 K2 L19 N1 P22 T19 V10
J1 K18 M2 N5 R1 U3 V12	G4  J3  K19  M6  N19  R3  U11  V17	G19  J4  L2  M17  P1  R20  U18  V3	G22 J19 L5 M18 P5 R22 V1	H1 J20 L18 M21 P19 T5 V2 V6	H21 K2 L19 N1 P22 T19 V10 V8
J1 K18 M2 N5 R1 U3 V12 V20	G4  J3  K19  M6  N19  R3  U11  V17  V21	G19 J4 L2 M17 P1 R20 U18 V3 V22	G22 J19 L5 M18 P5 R22 V1 V4	H1 J20 L18 M21 P19 T5 V2 V6 W5	H21 K2 L19 N1 P22 T19 V10 V8
J1 K18 M2 N5 R1 U3 V12 V20 W13	G4  J3  K19  M6  N19  R3  U11  V17  V21  W14	G19 J4 L2 M17 P1 R20 U18 V3 V22 W15	G22 J19 L5 M18 P5 R22 V1 V4 W4 W16	H1 J20 L18 M21 P19 T5 V2 V6 W5	H21 K2 L19 N1 P22 T19 V10 V8 W9 Y5
J1 K18 M2 N5 R1 U3 V12 V20 W13 Y14 AA9	G4  J3  K19  M6  N19  R3  U11  V17  V21  W14  Y18  AA10	G19 J4 L2 M17 P1 R20 U18 V3 V22 W15 Y22	G22 J19 L5 M18 P5 R22 V1 V4 W4 W16 AA1	H1 J20 L18 M21 P19 T5 V2 V6 W5 W19 AA3 AA17	H21 K2 L19 N1 P22 T19 V10 V8 W9 Y5 AA6
J1 K18 M2 N5 R1 U3 V12 V20 W13 Y14	G4  J3  K19  M6  N19  R3  U11  V17  V21  W14  Y18	G19 J4 L2 M17 P1 R20 U18 V3 V22 W15 Y22 AA11	G22 J19 L5 M18 P5 R22 V1 V4 W4 W16 AA1 AA16	H1 J20 L18 M21 P19 T5 V2 V6 W5 W19 AA3	H21 K2 L19 N1 P22 T19 V10 V8 W9 Y5 AA6 AA18

11/02/00



### **XC2S150 Device Pinouts**

XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
GND	-	P1	GND*	GND*	-
TMS	-	P2	D3	D3	-
I/O	7	P3	C2	B1	221
I/O	7	-	-	E4	224
I/O	7	-	-	C1	227
I/O	7	-	A2	F5	230
GND	-	-	GND*	GND*	-
I/O	7	P4	B1	D2	233
I/O	7	-	-	E3	236
I/O	7	-	-	F4	239
I/O	7	-	E3	G5	242
I/O	7	P5	D2	F3	245
GND	-	-	GND*	GND*	-
V <sub>CCO</sub>	7	-	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
I/O, V <sub>REF</sub>	7	P6	C1	E2	248
I/O	7	P7	F3	E1	251
I/O	7	-	-	G4	254
I/O	7	-	-	G3	257
I/O	7	-	E2	H5	260
I/O	7	P8	E4	F2	263
I/O	7	-	-	F1	266
I/O, V <sub>REF</sub>	7	P9	D1	H4	269
I/O	7	P10	E1	G1	272
GND	-	P11	GND*	GND*	-
V <sub>CCO</sub>	7	P12	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
V <sub>CCINT</sub>	-	P13	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	7	P14	F2	НЗ	275
I/O	7	P15	G3	H2	278
I/O	7	-	-	H1	284
I/O	7	-	F1	J5	287
I/O	7	P16	F4	J2	290
I/O	7	-	-	J3	293
I/O	7	P17	F5	K5	299
I/O	7	P18	G2	K1	302
GND	-	P19	GND*	GND*	-
V <sub>CCO</sub>	7	-	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
I/O, V <sub>REF</sub>	7	P20	НЗ	K3	305
I/O	7	P21	G4	K4	308
I/O	7	-	H2	L6	311

			I .		<b>Bndry</b>
Function	Bank	PQ208	FG256	FG456	Scan
I/O	7	P22	G5	L1	314
I/O	7	-	-	L5	317
I/O	7	P23	H4	L4	320
I/O, IRDY <sup>(1)</sup>	7	P24	G1	L3	323
GND	-	P25	GND*	GND*	-
V <sub>CCO</sub>	7	P26	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	
V <sub>CCO</sub>	6	P26	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	1
I/O, TRDY <sup>(1)</sup>	6	P27	J2	M1	326
V <sub>CCINT</sub>	-	P28	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	6	-	-	M6	332
I/O	6	P29	H1	МЗ	335
I/O	6	-	J4	M4	338
I/O	6	P30	J1	M5	341
I/O, V <sub>REF</sub>	6	P31	J3	N2	344
V <sub>CCO</sub>	6	-	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	P32	GND*	GND*	-
I/O	6	P33	K5	N3	347
I/O	6	P34	K2	N4	350
I/O	6	-	-	N5	356
I/O	6	P35	K1	P2	359
I/O	6	-	КЗ	P4	362
I/O	6	-	-	R1	365
I/O	6	P36	L1	P3	371
I/O	6	P37	L2	R2	374
V <sub>CCINT</sub>	-	P38	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	6	P39	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND		P40	GND*	GND*	-
I/O	6	P41	K4	T1	377
I/O, V <sub>REF</sub>	6	P42	M1	R4	380
I/O	6	-	-	T2	383
I/O	6	P43	L4	U1	386
I/O	6	-	M2	R5	389
I/O	6	-	-	V1	392
I/O	6	-	-	T5	395
I/O	6	P44	L3	U2	398
I/O, V <sub>REF</sub>	6	P45	N1	T3	401
V <sub>cco</sub>	6	-	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	-	GND*	GND*	-



XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	6	P46	P1	T4	404
I/O	6	-	L5	W1	407
I/O	6	-	-	V2	410
I/O	6	-	-	U4	413
I/O	6	P47	N2	Y1	416
GND	-	-	GND*	GND*	-
I/O	6	-	M4	W2	419
I/O	6	-	-	V3	422
I/O	6	-	-	V4	425
I/O	6	P48	R1	Y2	428
I/O	6	P49	МЗ	W3	431
M1	-	P50	P2	U5	434
GND	-	P51	GND*	GND*	-
MO	-	P52	N3	AB2	435
V <sub>CCO</sub>	6	P53	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
V <sub>CCO</sub>	5	P53	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
M2	-	P54	R3	Y4	436
I/O	5	-	-	W5	443
I/O	5	-	-	AB3	446
I/O	5	-	N5	V7	449
GND	-	-	GND*	GND*	-
I/O	5	P57	T2	Y6	452
I/O	5	-	-	AA4	455
I/O	5	-	-	AB4	458
I/O	5	-	P5	W6	461
I/O	5	P58	Т3	Y7	464
GND	-	-	GND*	GND*	-
V <sub>CCO</sub>	5	-	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
I/O, V <sub>REF</sub>	5	P59	T4	AA5	467
I/O	5	P60	M6	AB5	470
I/O	5	-	-	V8	473
I/O	5	-	-	AA6	476
I/O	5	-	T5	AB6	479
I/O	5	P61	N6	AA7	482
I/O	5	-	-	W7	485
I/O, V <sub>REF</sub>	5	P62	R5	W8	488
I/O	5	P63	P6	Y8	491
GND	-	P64	GND*	GND*	-

XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V <sub>CCO</sub>	5	P65	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
V <sub>CCINT</sub>	-	P66	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	5	P67	R6	AA8	494
I/O	5	P68	M7	V9	497
I/O	5	-	-	W9	503
I/O	5	-	-	AB9	506
I/O	5	P69	N7	Y9	509
I/O	5	-	-	V10	512
I/O	5	P70	T6	W10	518
I/O	5	P71	P7	AB10	521
GND	-	P72	GND*	GND*	-
V <sub>CCO</sub>	5	-	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
I/O, V <sub>REF</sub>	5	P73	P8	Y10	524
I/O	5	P74	R7	V11	527
I/O	5	-	T7	W11	530
I/O	5	P75	T8	AB11	533
I/O	5	-	-	U11	536
V <sub>CCINT</sub>	-	P76	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I, GCK1	5	P77	R8	Y11	545
V <sub>CCO</sub>	5	P78	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
V <sub>cco</sub>	4	P78	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P79	GND*	GND*	-
I, GCK0	4	P80	N8	W12	546
I/O	4	P81	N9	U12	550
I/O	4	-	-	V12	553
I/O	4	P82	R9	Y12	556
I/O	4	-	N10	AA12	559
I/O	4	P83	Т9	AB13	562
I/O, V <sub>REF</sub>	4	P84	P9	AA13	565
V <sub>CCO</sub>	4	-	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P85	GND*	GND*	-
I/O	4	P86	M10	Y13	568
I/O	4	P87	R10	V13	571
I/O	4	-	-	W14	577
I/O	4	P88	P10	AA14	580
I/O	4	-	-	V14	583
I/O	4	-	-	Y14	586
I/O	4	P89	T10	AB15	592



XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	4	P90	R11	AA15	595
V <sub>CCINT</sub>	-	P91	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	4	P92	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P93	GND*	GND*	-
I/O	4	P94	M11	Y15	598
I/O, V <sub>REF</sub>	4	P95	T11	AB16	601
I/O	4	-	-	AB17	604
I/O	4	P96	N11	V15	607
I/O	4	-	R12	Y16	610
I/O	4	-	-	AA17	613
I/O	4	-	-	W16	616
I/O	4	P97	P11	AB18	619
I/O, V <sub>REF</sub>	4	P98	T12	AB19	622
V <sub>CCO</sub>	4	-	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	-	GND*	GND*	-
I/O	4	P99	T13	Y17	625
I/O	4	-	N12	V16	628
I/O	4	-	-	AA18	631
I/O	4	-	-	W17	634
I/O	4	P100	R13	AB20	637
GND	-	-	GND*	GND*	-
I/O	4	-	P12	AA19	640
I/O	4	-	-	V17	643
I/O	4	-	-	Y18	646
I/O	4	P101	P13	AA20	649
I/O	4	P102	T14	W18	652
GND	-	P103	GND*	GND*	-
DONE	3	P104	R14	Y19	655
V <sub>CCO</sub>	4	P105	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
V <sub>CCO</sub>	3	P105	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
PROGRAM	-	P106	P15	W20	658
I/O (INIT)	3	P107	N15	V19	659
I/O (D7)	3	P108	N14	Y21	662
I/O	3	-	-	V20	665
I/O	3	-	-	AA22	668
I/O	3	-	T15	W21	671
GND	-	-	GND*	GND*	-
I/O	3	P109	M13	U20	674

XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	3	-	-	U19	677
I/O	3	-	-	V21	680
I/O	3	-	R16	T18	683
I/O	3	P110	M14	W22	686
GND	-	-	GND*	GND*	-
V <sub>CCO</sub>	3	-	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
I/O, V <sub>REF</sub>	3	P111	L14	U21	689
I/O	3	P112	M15	T20	692
I/O	3	-	-	T19	695
I/O	3	-	-	V22	698
I/O	3	-	L12	T21	701
I/O	3	P113	P16	R18	704
I/O	3	-	-	U22	707
I/O, V <sub>REF</sub>	3	P114	L13	R19	710
I/O (D6)	3	P115	N16	T22	713
GND	-	P116	GND*	GND*	-
V <sub>cco</sub>	3	P117	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
V <sub>CCINT</sub>	-	P118	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O (D5)	3	P119	M16	R21	716
I/O	3	P120	K14	P18	719
I/O	3	-	-	P19	725
I/O	3	-	L16	P20	728
I/O	3	P121	K13	P21	731
I/O	3	-	-	N19	734
I/O	3	P122	L15	N18	740
I/O	3	P123	K12	N20	743
GND	-	P124	GND*	GND*	-
V <sub>CCO</sub>	3	-	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
I/O, V <sub>REF</sub>	3	P125	K16	N21	746
I/O (D4)	3	P126	J16	N22	749
I/O	3	-	J14	M19	752
I/O	3	P127	K15	M20	755
I/O	3	-	-	M18	758
V <sub>CCINT</sub>	-	P128	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O, TRDY <sup>(1)</sup>	3	P129	J15	M22	764
V <sub>cco</sub>	3	P130	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
V <sub>cco</sub>	2	P130	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	1
GND	-	P131	GND*	GND*	-



	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O, IRDY <sup>(1)</sup>	2	P132	H16	L20	767
I/O	2	P133	H14	L17	770
I/O	2	-	-	L18	773
I/O	2	P134	H15	L21	776
I/O	2	-	J13	L22	779
I/O (D3)	2	P135	G16	K20	782
I/O, V <sub>REF</sub>	2	P136	H13	K21	785
V <sub>CCO</sub>	2	-	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	ı
GND	-	P137	GND*	GND*	ı
I/O	2	P138	G14	K22	788
I/O	2	P139	G15	J21	791
I/O	2	-	-	J20	797
I/O	2	P140	G12	J18	800
I/O	2	-	F16	J22	803
I/O	2	-	-	J19	806
I/O	2	P141	G13	H19	812
I/O (D2)	2	P142	F15	H20	815
V <sub>CCINT</sub>	-	P143	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	2	P144	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	P145	GND*	GND*	-
I/O (D1)	2	P146	E16	H22	818
I/O, V <sub>REF</sub>	2	P147	F14	H18	821
I/O	2	-	-	G21	824
I/O	2	P148	D16	G18	827
I/O	2	-	F12	G20	830
I/O	2	-	-	G19	833
I/O	2	-	-	F22	836
I/O	2	P149	E15	F19	839
I/O, V <sub>REF</sub>	2	P150	F13	F21	842
V <sub>CCO</sub>	2	-	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	-	GND*	GND*	-
I/O	2	P151	E14	F20	845
I/O	2	-	C16	F18	848
I/O	2	-	-	E22	851
I/O	2	-	-	E21	854
I/O	2	P152	E13	D22	857
GND	-	-	GND*	GND*	-
I/O	2	-	B16	E20	860
I/O	2	-	-	D21	863

Function         Bank         PQ208         FG256         FG456         Scan           I/O         2         -         -         C22         866           I/O (DIN, DO)         2         P153         D14         D20         869           I/O (DOUT, BUSY)         2         P155         D15         B22         875           VCCO         2         P156         VCCO Bank 2*         VCCO Bank 2*         C           VCCO         1         P156         VCCO Bank 1*         VCCO Bank 2*         C           VCCO         2         P157         B14         A21         -           GND         -         P158         GND*         GND*         -           GND         -         P158         GND*         GND*         -           I/O (CS)         1         P160         B13         C19         0           I/O (WRITE)         1         P161         C13         A20         3           I/O (WRITE)         1         P161         C13         A20         3           I/O (WRITE)         1         P161         C13         A20         3           I/O (WRITE)         1         P161	XC2S150 Pad	Name				Bndry
	Function	Bank	PQ208	FG256	FG456	
	I/O	2	-	-	C22	866
BUSY    CCLK   2	I/O (DIN, D0)	2	P153	D14	D20	869
VCCO         2         P156 Bank 2*         VCCO Bank 2*         VCCO Bank 2*         CCO Bank 2*         CCO Bank 1*         CCO Ban		2	P154	C15	C21	872
Vcco         1         P156         Vcco Bank 1* P156         Bank 2* P157         Bank 1* P150         Vcco Bank 1* P150         Vcco Bank 1* P150         Vcco Bank 1* P150         P158         Vcco Bank 1* P150         P158         P159         P159 <td>CCLK</td> <td>2</td> <td>P155</td> <td>D15</td> <td>B22</td> <td>875</td>	CCLK	2	P155	D15	B22	875
TDO 2 P157 B14 A21 - GND - P158 GND* GND* - TDI - P159 A15 B20 - I/O (\overline{\colored}{\scrt{CS}}) 1 P160 B13 C19 0 I/O (\overline{\colored}{\scrt{WRITE}}) 1 P161 C13 A20 3 I/O 1 - C18 9 I/O 1 - C12 D17 12 GND - GND* GND* - I/O 1 - C12 D17 12 GND - GND* GND* - I/O 1 P162 A14 A19 15 I/O 1 P163 B12 D16 21 I/O 1 P163 B12 D16 27 GND - GND* GND* - I/O 1 P163 B12 D16 27 GND - GND* GND* - I/O 1 P163 B12 D16 27 GND - GND* GND* - I/O 1 P163 B12 D16 27 GND - GND* GND* - I/O 1 P164 C11 A18 30 I/O 1 P165 A13 B17 33 I/O 1 P165 A13 B17 33 I/O 1 P166 A12 C16 45 I/O 1 P166 A12 C16 45 I/O 1 P166 A12 C16 45 I/O 1 P168 B11 A16 54 I/O 1 P168 B11 A16 54 GND - P169 GND* GND* - VCCO 1 P170 VCCO Bank 1* B11 I/O 1 P168 B11 A16 54 GND - P169 GND* GND* - VCCO 1 P170 VCCO Bank 1* B11 I/O 1 P168 B11 A16 54 GND - P169 GND* GND* - VCCO 1 P170 VCCO Bank 1* B11 I/O 1 P168 B11 A16 54 GND - P169 GND* GND* - VCCO 1 P170 VCCO Bank 1* B15 I/O 1 P169 GND* CCO Bank 1* B15 I/O 1 P170 CCO BANK 1* CCON BAN	V <sub>CCO</sub>	2	P156			-
GND         -         P158         GND*         GND*         -           TDI         -         P159         A15         B20         -           I/O (CS)         1         P160         B13         C19         0           I/O (WRITE)         1         P161         C13         A20         3           I/O         1         -         -         B19         6           I/O         1         -         -         C18         9           I/O         1         -         C12         D17         12           GND         -         -         GND*         -         -           I/O         1         -         D12         C17         24           I/O         1         P163	V <sub>CCO</sub>	1	P156		V <sub>CCO</sub> Bank 1*	-
TDI - P159 A15 B20 -  I/O (\overline{\text{CS}}) 1 P160 B13 C19 0  I/O (\overline{\text{WRITE}}) 1 P161 C13 A20 3  I/O 1 - B19 6  I/O 1 - C18 9  I/O 1 - C12 D17 12  GND - GND* GND* -  I/O 1 P162 A14 A19 15  I/O 1 - B18 18  I/O 1 - B16 21  I/O 1 - D12 C17 24  I/O 1 P163 B12 D16 27  GND - GND* GND* -  VCCO 1 P164 C11 A18 30  I/O 1 P165 A13 B17 33  I/O 1 P165 A13 B17 33  I/O 1 P166 A12 C16 45  I/O 1 P166 A12 C16 45  I/O 1 P168 B11 A16 54  GND - P169 GND* GND* -  VCCO 1 P170 VCCO Bank 1*  I/O 1 P168 B11 A16 54  GND - P169 GND* GND* -  VCCO 1 P170 VCCO Bank 1*  I/O 1 P168 B11 A16 54  GND - P169 GND* GND* -  VCCO BANK 1*  I/O 1 P170 CCOO BANK 1*  I/O 1 P170 CCOO BANK 1*  I/O I P170 CCOO BANK 1*  I/O	TDO	2	P157	B14	A21	-
	GND	-	P158	GND*	GND*	-
I/O (WRITE)	TDI	-	P159	A15	B20	-
I/O		1	P160	B13	C19	0
I/O	I/O (WRITE)	1	P161	C13	A20	3
I/O	I/O	1	-	-	B19	6
GND - GND* GND* - I/O 1 P162 A14 A19 15 I/O 1 - B18 18 I8 I/O 1 - B16 21 I/O 1 - E16 21 I/O 1 P163 B12 D16 27 GND - GND* GND* - VCCO Bank 1* B17 33 I/O 1 P165 A13 B17 33 I/O 1 P165 A13 B17 33 I/O 1 P166 A12 C16 45 I/O 1 P166 A12 C16 45 I/O 1 P168 B11 A16 54 GND - P169 GND* - VCCO Bank 1* C10	I/O	1	-	-	C18	9
I/O	I/O	1	-	C12	D17	12
I/O	GND	-	-	GND*	GND*	-
I/O	I/O	1	P162	A14	A19	15
I/O         1         -         D12         C17         24           I/O         1         P163         B12         D16         27           GND         -         -         GND*         GND*         -           VCCO         1         -         GND*         -         -           I/O, VREF         1         P164         C11         A18         30           I/O         1         P165         A13         B17         33           I/O         1         -         -         E15         36           I/O         1         -         -         A17         39           I/O         1         P166         A12         C16         45           I/O         1         P166         A12         C16         45           I/O         1         P167         E11         E14         51           I/O         1         P168	I/O	1	-	-	B18	18
I/O	I/O	1	-	-	E16	21
GND GND* GND* - VCCO Bank 1* P164 C11 A18 30 I/O	I/O	1	-	D12	C17	24
VCCO         1         -         VCCO Bank 1* PCCO Bank 1*         -	I/O	1	P163	B12	D16	27
Bank 1* Bank 1*	GND	-	-	GND*	GND*	-
I/O	V <sub>CCO</sub>	1	-	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
I/O     1     -     -     E15     36       I/O     1     -     -     A17     39       I/O     1     -     D11     D15     42       I/O     1     P166     A12     C16     45       I/O     1     -     -     D14     48       I/O     1     P167     E11     E14     51       I/O     1     P168     B11     A16     54       GND     -     P169     GND*     -       VCCO     1     P170     VCCO Bank 1*     VCCO Bank 1*       VCCINT     -     P171     VCCINT*     VCCINT*     -       I/O     1     P172     A11     C15     57       I/O     1     P173     C10     B15     60       I/O     1     -     -     A15     66	I/O, V <sub>REF</sub>	1	P164	C11	A18	30
I/O       1       -       -       A17       39         I/O       1       -       D11       D15       42         I/O       1       P166       A12       C16       45         I/O       1       -       -       D14       48         I/O, VREF       1       P167       E11       E14       51         I/O       1       P168       B11       A16       54         GND       -       P169       GND*       GND*       -         VCCO       1       P170       VCCO Bank 1*       VCCO Bank 1*       -         VCCINT       -       P171       VCCINT*       VCCINT*       -         I/O       1       P172       A11       C15       57         I/O       1       P173       C10       B15       60         I/O       1       -       -       A15       66	I/O	1	P165	A13	B17	33
I/O         1         -         D11         D15         42           I/O         1         P166         A12         C16         45           I/O         1         -         -         D14         48           I/O, V <sub>REF</sub> 1         P167         E11         E14         51           I/O         1         P168         B11         A16         54           GND         -         P169         GND*         -           V <sub>CCO</sub> 1         P170         V <sub>CCO</sub> Bank*         -           Bank 1*         -         P171         V <sub>CCINT</sub> *         V <sub>CCINT</sub> *         -           I/O         1         P172         A11         C15         57           I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	I/O	1	-	-	E15	36
I/O         1         P166         A12         C16         45           I/O         1         -         -         D14         48           I/O, V <sub>REF</sub> 1         P167         E11         E14         51           I/O         1         P168         B11         A16         54           GND         -         P169         GND*         GND*         -           V <sub>CCO</sub> 1         P170         V <sub>CCO</sub> Bank 1*         V <sub>CCO</sub> Bank 1*         -           V <sub>CCINT</sub> -         P171         V <sub>CCINT</sub> *         V <sub>CCINT</sub> *         -           I/O         1         P172         A11         C15         57           I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	I/O	1	-	-	A17	39
I/O     1     -     -     D14     48       I/O, V <sub>REF</sub> 1     P167     E11     E14     51       I/O     1     P168     B11     A16     54       GND     -     P169     GND*     -       V <sub>CCO</sub> 1     P170     V <sub>CCO</sub> Bank 1*     V <sub>CCO</sub> Bank 1*       V <sub>CCINT</sub> -     P171     V <sub>CCINT</sub> *     V <sub>CCINT</sub> *     -       I/O     1     P172     A11     C15     57       I/O     1     P173     C10     B15     60       I/O     1     -     -     A15     66	I/O	1	-	D11	D15	42
I/O, V <sub>REF</sub> 1     P167     E11     E14     51       I/O     1     P168     B11     A16     54       GND     -     P169     GND*     GND*     -       V <sub>CCO</sub> 1     P170     V <sub>CCO</sub> Bank 1*     V <sub>CCO</sub> Bank 1*     -       V <sub>CCINT</sub> -     P171     V <sub>CCINT</sub> *     V <sub>CCINT</sub> *     -       I/O     1     P172     A11     C15     57       I/O     1     P173     C10     B15     60       I/O     1     -     -     A15     66	I/O	1	P166	A12	C16	45
I/O         1         P168         B11         A16         54           GND         -         P169         GND*         GND*         -           V <sub>CCO</sub> 1         P170         V <sub>CCO</sub> Bank 1*         V <sub>CCO</sub> Bank 1*         -           V <sub>CCINT</sub> -         P171         V <sub>CCINT</sub> *         V <sub>CCINT</sub> *         -           I/O         1         P172         A11         C15         57           I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	I/O	1	-	-	D14	48
GND - P169 GND* GND* - VCCO 1 P170 VCCO Bank 1* P170 VCCO Bank 1* P170 VCCINT* - P171 VCCINT* VCCINT* - I/O 1 P172 A11 C15 57 I/O 1 P173 C10 B15 60 I/O 1 - A15 66	I/O, V <sub>REF</sub>	1	P167	E11	E14	51
VCCO         1         P170         VCCO Bank 1*         VCCO Bank 1*         -           VCCINT         -         P171         VCCINT*         VCCINT*         -           I/O         1         P172         A11         C15         57           I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	I/O	1	P168	B11	A16	54
Bank 1* Bank 1*   VCCINT   - P171   VCCINT*   VCCINT*   -	GND	-	P169	GND*	GND*	-
I/O         1         P172         A11         C15         57           I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	V <sub>CCO</sub>	1	P170	V <sub>CCO</sub> Bank 1*		
I/O         1         P173         C10         B15         60           I/O         1         -         -         A15         66	V <sub>CCINT</sub>	-	P171	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O 1 A15 66	I/O	1	P172	A11	C15	57
	I/O	1	P173	C10	B15	60
I/O 1 F12 69	I/O	1	-	-	A15	66
	I/O	1	-	-	F12	69



XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	1	P174	B10	C14	72
I/O	1	-	-	B14	75
I/O	1	P175	D10	D13	81
I/O	1	P176	A10	C13	84
GND	-	P177	GND*	GND*	-
V <sub>CCO</sub>	1	-	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
I/O, V <sub>REF</sub>	1	P178	В9	B13	87
I/O	1	P179	E10	E12	90
I/O	1	-	A9	B12	93
I/O	1	P180	D9	D12	96
I/O	1	-	-	C12	99
I/O	1	P181	A8	D11	102
I, GCK2	1	P182	C9	A11	108
GND	-	P183	GND*	GND*	-
V <sub>CCO</sub>	1	P184	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
V <sub>CCO</sub>	0	P184	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
I, GCK3	0	P185	B8	C11	109
V <sub>CCINT</sub>	-	P186	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	0	-	-	E11	116
I/O	0	P187	A7	A10	119
I/O	0	-	D8	B10	122
I/O	0	P188	A6	C10	125
I/O, V <sub>REF</sub>	0	P189	B7	A9	128
V <sub>CCO</sub>	0	-	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	P190	GND*	GND*	-
I/O	0	P191	C8	В9	131
I/O	0	P192	D7	E10	134
I/O	0	-	-	D10	140
I/O	0	P193	E7	A8	143
I/O	0	-	-	D9	146
I/O	0	-	-	B8	149
I/O	0	P194	C7	E9	155
I/O	0	P195	B6	A7	158

### XC2S150 Device Pinouts (Continued)

XC2S150 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V <sub>CCINT</sub>	-	P196	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	0	P197	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	P198	GND*	GND*	-
I/O	0	P199	A5	B7	161
I/O, V <sub>REF</sub>	0	P200	C6	E8	164
I/O	0	-	-	D8	167
I/O	0	P201	B5	C7	170
I/O	0	-	D6	D7	173
I/O	0	-	-	В6	176
I/O	0	-	-	A5	179
I/O	0	P202	A4	D6	182
I/O, V <sub>REF</sub>	0	P203	B4	C6	185
V <sub>CCO</sub>	0	-	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	-	GND*	GND*	-
I/O	0	P204	E6	B5	188
I/O	0	-	D5	E7	191
I/O	0	-	-	A4	194
I/O	0	-	-	E6	197
I/O	0	P205	A3	B4	200
GND	-	-	GND*	GND*	-
I/O	0	-	C5	A3	203
I/O	0	-	-	В3	206
I/O	0	-	-	D5	209
I/O	0	P206	В3	C5	212
TCK	-	P207	C4	C4	-
V <sub>CCO</sub>	0	P208	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
V <sub>CCO</sub>	7	P208	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-

04/18/01

### Notes:

- IRDY and TRDY can only be accessed when using Xilinx PCI cores.
- Pads labelled GND\*, V<sub>CCINT</sub>\*, V<sub>CCO</sub> Bank 0\*, V<sub>CCO</sub> Bank 1\*, V<sub>CCO</sub> Bank 2\*, V<sub>CCO</sub> Bank 3\*, V<sub>CCO</sub> Bank 4\*, V<sub>CCO</sub> Bank 5\*, V<sub>CCO</sub> Bank 6\*, V<sub>CCO</sub> Bank 7\* are internally bonded to independent ground or power planes within the package.



# **Additional XC2S150 Package Pins**

### **PQ208**

Not Connected Pins								
P55	P56	-	-	-	-			
11/02/00								

#### FG256

C3         C14         D4         D13         E5         E12           M5         M12         N4         N13         P3         P14           V <sub>CCO</sub> Bank 0 Pins           E8         F8         -         -         -         -           V <sub>CCO</sub> Bank 1 Pins           E9         F9         -         -         -         -           V <sub>CCO</sub> Bank 2 Pins           H11         H12         -         -         -         -           V <sub>CCO</sub> Bank 3 Pins           J11         J12         -         -         -         -           V <sub>CCO</sub> Bank 4 Pins           L9         M9         -         -         -         -           V <sub>CCO</sub> Bank 5 Pins           L8         M8         -         -         -         -           V <sub>CCO</sub> Bank 6 Pins
V <sub>CCO</sub> Bank 0 Pins           E8         F8         -         <
E8         F8         -
V <sub>CCO</sub> Bank 1 Pins           E9         F9         -         <
E9         F9         -
V <sub>CCO</sub> Bank 2 Pins         H11       H12       -       -       -       -         V <sub>CCO</sub> Bank 3 Pins         J11       J12       -       -       -       -         V <sub>CCO</sub> Bank 4 Pins         L9       M9       -       -       -       -         V <sub>CCO</sub> Bank 5 Pins         L8       M8       -       -       -       -
H11
V <sub>CCO</sub> Bank 3 Pins           J11         J12         -
J11         J12         -         -         -           V <sub>CCO</sub> Bank 4 Pins           L9         M9         -         -         -           V <sub>CCO</sub> Bank 5 Pins           L8         M8         -         -         -
V <sub>CCO</sub> Bank 4 Pins           L9         M9         -         -         -         -           V <sub>CCO</sub> Bank 5 Pins           L8         M8         -         -         -         -         -
L9         M9         -         -         -         -         -           V <sub>CCO</sub> Bank 5 Pins           L8         M8         -         -         -         -         -
V <sub>CCO</sub> Bank 5 Pins           L8         M8         -         -         -         -         -
L8 M8
V <sub>CCO</sub> Bank 6 Pins
J5 J6
V <sub>CCO</sub> Bank 7 Pins
H5 H6
GND Pins
A1 A16 B2 B15 F6 F7
F10 F11 G6 G7 G8 G9
G10 G11 H7 H8 H9 H10
J7 J8 J9 J10 K6 K7
K8 K9 K10 K11 L6 L7
L10 L11 R2 R15 T1 T16
Not Connected Pins
P4 R4

11/02/00

### Additional XC2S150 Package Pins (Continued)

#### FG456

FG456									
		V <sub>CCIN</sub>	<sub>T</sub> Pins						
E5	E18	F6	F17	G7	G8				
G9	G14	G15	G16	H7	H16				
J7	J16	P7	P16	R7	R16				
T7	T8	T9	T14	T15	T16				
U6	U17	V5	V18	-	-				
V <sub>CCO</sub> BANK 0 Pins									
F7	F8	F9	F10	G10	G11				
		V <sub>CCO</sub> Ba	nk 1 Pins						
F13	F14	F15	F16	G12	G13				
		V <sub>CCO</sub> Ba	nk 2 Pins	•	•				
G17	H17	J17	K16	K17	L16				
	•	V <sub>CCO</sub> Ba	nk 3 Pins						
M16	N16	N17	P17	R17	T17				
	II.	V <sub>CCO</sub> Ba	nk 4 Pins	I.	1				
T12	T13	U13	U14	U15	U16				
		V <sub>CCO</sub> Ba	nk 5 Pins	I.	I.				
T10	T11	U7	U8	U9	U10				
V <sub>CCO</sub> Bank 6 Pins									
M7	N6	N7	P6	R6	T6				
V <sub>CCO</sub> Bank 7 Pins									
G6	H6	J6	K6	K7	L7				
	I.	GND	Pins						
A1	A22	B2	B21	СЗ	C20				
J9	J10	J11	J12	J13	J14				
K9	K10	K11	K12	K13	K14				
L9	L10	L11	L12	L13	L14				
M9	M10	M11	M12	M13	M14				
N9	N10	N11	N12	N13	N14				
P9	P10	P11	P12	P13	P14				
Y3	Y20	AA2	AA21	AB1	AB22				
	I.	Not Conn	ected Pins						
A2	A6	A12	A13	A14	B11				
B16	C2	C8	C9	D1	D4				
D18	D19	E13	E17	E19	F11				
G2	G22	H21	J1	J4	K2				
K18	K19	L2	L19	M2	M17				
M21	N1	P1	P5	P22	R3				
R20	R22	U3	U18	V6	W4				
W13	W15	W19	Y5	Y22	AA1				
AA3	AA9	AA10	AA11	AA16	AB7				
AB8	AB12	AB14	AB21	-	-				
11/02/00	1	1	l	l	L				

11/02/00



### **XC2S200 Device Pinouts**

XC2S200 Pad	Name				Dl
Function	Bank	PQ208	FG256	FG456	Bndry Scan
GND	-	P1	GND*	GND*	-
TMS	-	P2	D3	D3	-
I/O	7	P3	C2	B1	257
I/O	7	-	-	E4	263
I/O	7	-	-	C1	266
I/O	7	-	A2	F5	269
GND	-	-	GND*	GND*	-
I/O, V <sub>REF</sub>	7	P4	B1	D2	272
I/O	7	-	-	E3	275
I/O	7	-	-	F4	281
GND	-	-	GND*	GND*	-
I/O	7	-	E3	G5	284
I/O	7	P5	D2	F3	287
GND	-	-	GND*	GND*	-
V <sub>CCO</sub>	7	-	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
I/O, V <sub>REF</sub>	7	P6	C1	E2	290
I/O	7	P7	F3	E1	293
I/O	7	-	-	G4	296
I/O	7	-	-	G3	299
I/O	7	-	E2	H5	302
GND	-	-	GND*	GND*	-
I/O	7	P8	E4	F2	305
I/O	7	-	-	F1	308
I/O, V <sub>REF</sub>	7	P9	D1	H4	314
I/O	7	P10	E1	G1	317
GND	-	P11	GND*	GND*	-
V <sub>cco</sub>	7	P12	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
V <sub>CCINT</sub>	-	P13	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	7	P14	F2	НЗ	320
I/O	7	P15	G3	H2	323
I/O	7	-	-	J4	326
I/O	7	-	-	H1	329
I/O	7	-	F1	J5	332
GND	-	-	GND*	GND*	-
I/O	7	P16	F4	J2	335
I/O	7	-	-	J3	338
I/O	7	-	-	J1	341
I/O	7	P17	F5	K5	344
I/O	7	P18	G2	K1	347
GND	-	P19	GND*	GND*	-

XC2S200 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V <sub>CCO</sub>	7	-	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
I/O, V <sub>REF</sub>	7	P20	Н3	K3	350
I/O	7	P21	G4	K4	353
I/O	7	-	-	K2	359
I/O	7	-	H2	L6	362
I/O	7	P22	G5	L1	365
I/O	7	-	-	L5	368
I/O	7	P23	H4	L4	374
I/O, IRDY <sup>(1)</sup>	7	P24	G1	L3	377
GND	ı	P25	GND*	GND*	-
V <sub>CCO</sub>	7	P26	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-
V <sub>cco</sub>	6	P26	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
I/O, TRDY <sup>(1)</sup>	6	P27	J2	M1	380
V <sub>CCINT</sub>	-	P28	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	6	-	-	M6	389
I/O	6	P29	H1	МЗ	392
I/O	6	-	J4	M4	395
I/O	6	-	-	N1	398
I/O	6	P30	J1	M5	404
I/O, V <sub>REF</sub>	6	P31	J3	N2	407
$V_{CCO}$	6	-	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	P32	GND*	GND*	-
I/O	6	P33	K5	N3	410
I/O	6	P34	K2	N4	413
I/O	6	-	-	P1	416
I/O	6	-	-	N5	419
I/O	6	P35	K1	P2	422
GND	-	-	GND*	GND*	-
I/O	6	-	K3	P4	425
I/O	6	-	-	R1	428
I/O	6	-	-	P5	431
I/O	6	P36	L1	P3	434
I/O	6	P37	L2	R2	437
V <sub>CCINT</sub>	-	P38	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	6	P39	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	•	P40	GND*	GND*	-
I/O	6	P41	K4	T1	440
I/O, V <sub>REF</sub>	6	P42	M1	R4	443



XC2S200 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	6	-	-	T2	449
I/O	6	P43	L4	U1	452
GND	-	-	GND*	GND*	-
I/O	6	-	M2	R5	455
I/O	6	-	-	V1	458
I/O	6	-	-	T5	461
I/O	6	P44	L3	U2	464
I/O, V <sub>REF</sub>	6	P45	N1	Т3	467
V <sub>CCO</sub>	6	-	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
GND	-	-	GND*	GND*	-
I/O	6	P46	P1	T4	470
I/O	6	-	L5	W1	473
GND	-	-	GND*	GND*	-
I/O	6	-	-	V2	476
I/O	6	-	-	U4	482
I/O, V <sub>REF</sub>	6	P47	N2	Y1	485
GND	-	-	GND*	GND*	-
I/O	6	-	M4	W2	488
I/O	6	-	-	V3	491
I/O	6	-	-	V4	494
I/O	6	P48	R1	Y2	500
I/O	6	P49	МЗ	W3	503
M1	-	P50	P2	U5	506
GND	-	P51	GND*	GND*	-
MO	-	P52	N3	AB2	507
V <sub>CCO</sub>	6	P53	V <sub>CCO</sub> Bank 6*	V <sub>CCO</sub> Bank 6*	-
V <sub>CCO</sub>	5	P53	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
M2	-	P54	R3	Y4	508
I/O	5	-	-	W5	518
I/O	5	-	-	AB3	521
I/O	5	-	N5	V7	524
GND	-	-	GND*	GND*	-
I/O, V <sub>REF</sub>	5	P57	T2	Y6	527
I/O	5	-	-	AA4	530
I/O	5	-	-	AB4	536
I/O	5	-	P5	W6	539
I/O	5	P58	Т3	Y7	542
GND	-	-	GND*	GND*	-

XC2S200 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V <sub>CCO</sub>	5	-	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
I/O, V <sub>REF</sub>	5	P59	T4	AA5	545
I/O	5	P60	M6	AB5	548
I/O	5	-	-	V8	551
I/O	5	-	-	AA6	554
I/O	5	-	T5	AB6	557
GND	-	-	GND*	GND*	-
I/O	5	P61	N6	AA7	560
I/O	5	-	-	W7	563
I/O, V <sub>REF</sub>	5	P62	R5	W8	569
I/O	5	P63	P6	Y8	572
GND	ı	P64	GND*	GND*	-
V <sub>CCO</sub>	5	P65	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
V <sub>CCINT</sub>	-	P66	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	5	P67	R6	AA8	575
I/O	5	P68	M7	V9	578
I/O	5	-	-	AB8	581
I/O	5	-	-	W9	584
I/O	5	-	-	AB9	587
GND	-	-	GND*	GND*	-
I/O	5	P69	N7	Y9	590
I/O	5	-	-	V10	593
I/O	5	-	-	AA9	596
I/O	5	P70	T6	W10	599
I/O	5	P71	P7	AB10	602
GND	ı	P72	GND*	GND*	-
V <sub>CCO</sub>	5	-	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
I/O, V <sub>REF</sub>	5	P73	P8	Y10	605
I/O	5	P74	R7	V11	608
I/O	5	-	-	AA10	614
I/O	5	-	T7	W11	617
I/O	5	P75	T8	AB11	620
I/O	5	-	-	U11	623
V <sub>CCINT</sub>	-	P76	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I, GCK1	5	P77	R8	Y11	635
V <sub>CCO</sub>	5	P78	V <sub>CCO</sub> Bank 5*	V <sub>CCO</sub> Bank 5*	-
V <sub>cco</sub>	4	P78	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P79	GND*	GND*	-



XC2S200 Pad	Name				
Function	Bank	PQ208	FG256	FG456	Bndry Scan
I, GCK0	4	P80	N8	W12	636
I/O	4	P81	N9	U12	640
I/O	4	-	-	V12	646
I/O	4	P82	R9	Y12	649
I/O	4	-	N10	AA12	652
I/O	4	-	-	W13	655
I/O	4	P83	Т9	AB13	661
I/O, V <sub>REF</sub>	4	P84	P9	AA13	664
V <sub>cco</sub>	4	-	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P85	GND*	GND*	-
I/O	4	P86	M10	Y13	667
I/O	4	P87	R10	V13	670
I/O	4	-	-	AB14	673
I/O	4	-	-	W14	676
I/O	4	P88	P10	AA14	679
GND	-	-	GND*	GND*	-
I/O	4	-	-	V14	682
I/O	4	-	-	Y14	685
I/O	4	-	-	W15	688
I/O	4	P89	T10	AB15	691
I/O	4	P90	R11	AA15	694
V <sub>CCINT</sub>	-	P91	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	4	P92	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-	P93	GND*	GND*	-
I/O	4	P94	M11	Y15	697
I/O, V <sub>REF</sub>	4	P95	T11	AB16	700
I/O	4	-	-	AB17	706
I/O	4	P96	N11	V15	709
GND	-	-	GND*	GND*	-
I/O	4	-	R12	Y16	712
I/O	4	-	-	AA17	715
I/O	4	-	-	W16	718
I/O	4	P97	P11	AB18	721
I/O, V <sub>REF</sub>	4	P98	T12	AB19	724
V <sub>CCO</sub>	4	-	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
GND	-		GND*	GND*	-
I/O	4	P99	T13	Y17	727
I/O	4	-	N12	V16	730
I/O	4	-	-	AA18	733

XC2S200 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	4	-	-	W17	739
I/O, V <sub>REF</sub>	4	P100	R13	AB20	742
GND	-	-	GND*	GND*	-
I/O	4	-	P12	AA19	745
I/O	4	-	-	V17	748
I/O	4	-	-	Y18	751
I/O	4	P101	P13	AA20	757
I/O	4	P102	T14	W18	760
GND	-	P103	GND*	GND*	-
DONE	3	P104	R14	Y19	763
V <sub>cco</sub>	4	P105	V <sub>CCO</sub> Bank 4*	V <sub>CCO</sub> Bank 4*	-
V <sub>cco</sub>	3	P105	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
PROGRAM	-	P106	P15	W20	766
I/O (INIT)	3	P107	N15	V19	767
I/O (D7)	3	P108	N14	Y21	770
I/O	3	-	-	V20	776
I/O	3	-	-	AA22	779
I/O	3	-	T15	W21	782
GND	-	-	GND*	GND*	-
I/O, V <sub>REF</sub>	3	P109	M13	U20	785
I/O	3	-	-	U19	788
I/O	3	-	-	V21	794
GND	-	-	GND*	GND*	-
I/O	3	-	R16	T18	797
I/O	3	P110	M14	W22	800
GND	-	-	GND*	GND*	-
V <sub>cco</sub>	3	-	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
I/O, V <sub>REF</sub>	3	P111	L14	U21	803
I/O	3	P112	M15	T20	806
I/O	3	-	-	T19	809
I/O	3	-	-	V22	812
I/O	3	-	L12	T21	815
GND	-	-	GND*	GND*	-
I/O	3	P113	P16	R18	818
I/O	3	-	-	U22	821
I/O, V <sub>REF</sub>	3	P114	L13	R19	827
I/O (D6)	3	P115	N16	T22	830
GND	-	P116	GND*	GND*	-



XC2S200 Pad	XC2S200 Pad Name			-	Bndry
Function	Bank	PQ208	FG256	FG456	Scan
V <sub>CCO</sub>	3	P117	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
V <sub>CCINT</sub>	-	P118	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O (D5)	3	P119	M16	R21	833
I/O	3	P120	K14	P18	836
I/O	3	-	-	R22	839
I/O	3	-	-	P19	842
I/O	3	-	L16	P20	845
GND	-	-	GND*	GND*	-
I/O	3	P121	K13	P21	848
I/O	3	-	-	N19	851
I/O	3	-	-	P22	854
I/O	3	P122	L15	N18	857
I/O	3	P123	K12	N20	860
GND	-	P124	GND*	GND*	-
V <sub>cco</sub>	3	-	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
I/O, V <sub>REF</sub>	3	P125	K16	N21	863
I/O (D4)	3	P126	J16	N22	866
I/O	3	-	-	M17	872
I/O	3	-	J14	M19	875
I/O	3	P127	K15	M20	878
I/O	3	-	-	M18	881
V <sub>CCINT</sub>	-	P128	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O, TRDY <sup>(1)</sup>	3	P129	J15	M22	890
V <sub>CCO</sub>	3	P130	V <sub>CCO</sub> Bank 3*	V <sub>CCO</sub> Bank 3*	-
V <sub>CCO</sub>	2	P130	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	P131	GND*	GND*	-
I/O, IRDY <sup>(1)</sup>	2	P132	H16	L20	893
I/O	2	P133	H14	L17	896
I/O	2	-	-	L18	902
I/O	2	P134	H15	L21	905
I/O	2	-	J13	L22	908
I/O	2	-	-	K19	911
I/O (D3)	2	P135	G16	K20	917
I/O, V <sub>REF</sub>	2	P136	H13	K21	920
V <sub>CCO</sub>	2	-	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	P137	GND*	GND*	-
I/O	2	P138	G14	K22	923
I/O	2	P139	G15	J21	926

XC2S200 Pad Name					D
Function	Bank	PQ208	FG256	FG456	Bndry Scan
I/O	2	-	-	K18	929
I/O	2	-	-	J20	932
I/O	2	P140	G12	J18	935
GND	-	-	GND*	GND*	-
I/O	2	-	F16	J22	938
I/O	2	-	-	J19	941
I/O	2	-	-	H21	944
I/O	2	P141	G13	H19	947
I/O (D2)	2	P142	F15	H20	950
V <sub>CCINT</sub>	-	P143	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>CCO</sub>	2	P144	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	P145	GND*	GND*	-
I/O (D1)	2	P146	E16	H22	953
I/O, V <sub>REF</sub>	2	P147	F14	H18	956
I/O	2	-	-	G21	962
I/O	2	P148	D16	G18	965
GND	-	-	GND*	GND*	-
I/O	2	-	F12	G20	968
I/O	2	-	-	G19	971
I/O	2	-	-	F22	974
I/O	2	P149	E15	F19	977
I/O, V <sub>REF</sub>	2	P150	F13	F21	980
V <sub>CCO</sub>	2	-	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-
GND	-	-	GND*	GND*	-
I/O	2	P151	E14	F20	983
I/O	2	-	C16	F18	986
GND	-	-	GND*	GND*	-
I/O	2	-	-	E22	989
I/O	2	-	-	E21	995
I/O, V <sub>REF</sub>	2	P152	E13	D22	998
GND	-	-	GND*	GND*	-
I/O	2	-	B16	E20	1001
I/O	2	-	-	D21	1004
I/O	2	-	-	C22	1007
I/O (DIN, D0)	2	P153	D14	D20	1013
I/O (DOUT, BUSY)	2	P154	C15	C21	1016
CCLK	2	P155	D15	B22	1019
V <sub>CCO</sub>	2	P156	V <sub>CCO</sub> Bank 2*	V <sub>CCO</sub> Bank 2*	-



XC2S200 Pad Name					
Function	Bank	PQ208	FG256	FG456	Bndry Scan
V <sub>CCO</sub>	1	P156	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
TDO	2	P157	B14	A21	-
GND	-	P158	GND*	GND*	-
TDI	-	P159	A15	B20	-
I/O (CS)	1	P160	B13	C19	0
I/O (WRITE)	1	P161	C13	A20	3
I/O	1	-	-	B19	9
I/O	1	-	-	C18	12
I/O	1	-	C12	D17	15
GND	-	-	GND*	GND*	-
I/O, V <sub>REF</sub>	1	P162	A14	A19	18
I/O	1	-	-	B18	21
I/O	1	-	-	E16	27
I/O	1	-	D12	C17	30
I/O	1	P163	B12	D16	33
GND	-	-	GND*	GND*	-
V <sub>CCO</sub>	1	-	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
I/O, V <sub>REF</sub>	1	P164	C11	A18	36
I/O	1	P165	A13	B17	39
I/O	1	-	-	E15	42
I/O	1	-	-	A17	45
I/O	1	-	D11	D15	48
GND	-	-	GND*	GND*	-
I/O	1	P166	A12	C16	51
I/O	1	-	-	D14	54
I/O, V <sub>REF</sub>	1	P167	E11	E14	60
I/O	1	P168	B11	A16	63
GND	-	P169	GND*	GND*	-
V <sub>CCO</sub>	1	P170	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
V <sub>CCINT</sub>	-	P171	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	1	P172	A11	C15	66
I/O	1	P173	C10	B15	69
I/O	1	-	-	E13	72
I/O	1	-	-	A15	75
I/O	1	-	-	F12	78
GND	-	-	GND*	GND*	_
I/O	1	P174	B10	C14	81
I/O	1	-	-	B14	84
I/O	1	-	-	A14	87

XC2S200 Pad Name					Bndry
Function	Bank	PQ208	FG256	FG456	Scan
I/O	1	P175	D10	D13	90
I/O	1	P176	A10	C13	93
GND	-	P177	GND*	GND*	-
V <sub>CCO</sub>	1	-	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
$I/O, V_{REF}$	1	P178	B9	B13	96
I/O	1	P179	E10	E12	99
I/O	1	ı	-	A13	105
I/O	1	1	A9	B12	108
I/O	1	P180	D9	D12	111
I/O	1	-	-	C12	114
I/O	1	P181	A8	D11	120
I, GCK2	1	P182	C9	A11	126
GND	-	P183	GND*	GND*	-
V <sub>CCO</sub>	1	P184	V <sub>CCO</sub> Bank 1*	V <sub>CCO</sub> Bank 1*	-
V <sub>CCO</sub>	0	P184	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
I, GCK3	0	P185	B8	C11	127
V <sub>CCINT</sub>	-	P186	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
I/O	0	-	-	E11	137
I/O	0	P187	A7	A10	140
I/O	0	-	D8	B10	143
I/O	0	-	-	F11	146
I/O	0	P188	A6	C10	152
I/O, V <sub>REF</sub>	0	P189	B7	A9	155
V <sub>CCO</sub>	0	-	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	P190	GND*	GND*	ı
I/O	0	P191	C8	B9	158
I/O	0	P192	D7	E10	161
I/O	0	-	-	C9	164
I/O	0	-	-	D10	167
I/O	0	P193	E7	A8	170
GND	-	-	GND*	GND*	-
I/O	0	-	-	D9	173
I/O	0	-	-	B8	176
I/O	0	-	-	C8	179
I/O	0	P194	C7	E9	182
I/O	0	P195	B6	A7	185
V <sub>CCINT</sub>	-	P196	V <sub>CCINT</sub> *	V <sub>CCINT</sub> *	-
V <sub>cco</sub>	0	P197	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-



XC2S200 Pad	Name				Bndry
Function	Bank	PQ208	FG256	FG456	Scan
GND	-	P198	GND*	GND*	-
I/O	0	P199	A5	B7	188
I/O, V <sub>REF</sub>	0	P200	C6	E8	191
I/O	0	-	-	D8	197
I/O	0	P201	B5	C7	200
GND	-	-	GND*	GND*	-
I/O	0	-	D6	D7	203
I/O	0	-	-	B6	206
I/O	0	-	-	A5	209
I/O	0	P202	A4	D6	212
I/O, V <sub>REF</sub>	0	P203	B4	C6	215
V <sub>cco</sub>	0	-	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
GND	-	-	GND*	GND*	-
I/O	0	P204	E6	B5	218
I/O	0	-	D5	E7	221
I/O	0	-	-	A4	224
I/O	0	-	-	E6	230
I/O, V <sub>REF</sub>	0	P205	A3	B4	233
GND	-	-	GND*	GND*	-
I/O	0	-	C5	A3	236
I/O	0	-	-	В3	239
I/O	0	-	-	D5	242
I/O	0	P206	В3	C5	248
TCK	-	P207	C4	C4	-
V <sub>CCO</sub>	0	P208	V <sub>CCO</sub> Bank 0*	V <sub>CCO</sub> Bank 0*	-
V <sub>CCO</sub>	7	P208	V <sub>CCO</sub> Bank 7*	V <sub>CCO</sub> Bank 7*	-

04/18/01

#### Notes:

- IRDY and TRDY can only be accessed when using Xilinx PCI cores.
- Pads labelled GND\*, V<sub>CCINT</sub>\*, V<sub>CCO</sub> Bank 0\*, V<sub>CCO</sub> Bank 1\*, V<sub>CCO</sub> Bank 2\*, V<sub>CCO</sub> Bank 3\*, V<sub>CCO</sub> Bank 4\*, V<sub>CCO</sub> Bank 5\*, V<sub>CCO</sub> Bank 6\*, V<sub>CCO</sub> Bank 7\* are internally bonded to independent ground or power planes within the package.

### **Additional XC2S200 Package Pins**

#### **PQ208**

		Not Conne	ected Pins		
P55	P56	-	-	-	-
11/02/00	•		•		

#### FG256

FG256					
		V <sub>CCIN</sub>	<sub>T</sub> Pins		
C3	C14	D4	D13	E5	E12
M5	M12	N4	N13	P3	P14
	l	V <sub>CCO</sub> Ba	nk 0 Pins		1
E8	F8	-	-	-	-
		V <sub>CCO</sub> Ba	nk 1 Pins		
E9	F9	-	-	-	-
		V <sub>CCO</sub> Ba	nk 2 Pins		
H11	H12	-	-	-	-
		V <sub>CCO</sub> Ba	nk 3 Pins		
J11	J12	-	-	-	-
	V <sub>CCO</sub> Bank 4 Pins				
L9	M9	-	-	-	-
	V <sub>CCO</sub> Bank 5 Pins				
L8	M8	-	-	-	-
	V <sub>CCO</sub> Bank 6 Pins				
J5	J6	-	-	-	-
		V <sub>CCO</sub> Ba	nk 7 Pins		
H5	H6	-	-	-	-
		GND	Pins		
A1	A16	B2	B15	F6	F7
F10	F11	G6	G7	G8	G9
G10	G11	H7	H8	H9	H10
J7	J8	J9	J10	K6	K7
K8	K9	K10	K11	L6	L7
L10	L11	R2	R15	T1	T16
		Not Conn	ected Pins		
P4	R4	-	-	-	-
11/02/00					

11/02/00



### Additional XC2S200 Package Pins (Continued)

#### FG456

1 4400					
		V <sub>CCIN</sub>	<sub>T</sub> Pins		
E5	E18	F6	F17	G7	G8
G9	G14	G15	G16	H7	H16
J7	J16	P7	P16	R7	R16
T7	T8	Т9	T14	T15	T16
U6	U17	V5	V18	-	-
		V <sub>CCO</sub> BAI	NK 0 Pins		
F7	F8	F9	F10	G10	G11
	V <sub>CCO</sub> Bank 1 Pins				
F13	F14	F15	F16	G12	G13
V <sub>CCO</sub> Bank 2 Pins					
G17	H17	J17	K16	K17	L16
		V <sub>CCO</sub> Ba	nk 3 Pins		
M16	N16	N17	P17	R17	T17
		V <sub>CCO</sub> Ba	nk 4 Pins		
T12	T13	U13	U14	U15	U16
		V <sub>CCO</sub> Ba	nk 5 Pins		
T10	T11	U7	U8	U9	U10
	V <sub>CCO</sub> Bank 6 Pins				
M7	N6	N7	P6	R6	T6
		V <sub>CCO</sub> Ba	nk 7 Pins		

### Additional XC2S200 Package Pins (Continued)

			•	•	•
G6	H6	J6	K6	K7	L7
	•	GND	Pins	•	•
A1	A22	B2	B21	СЗ	C20
J9	J10	J11	J12	J13	J14
K9	K10	K11	K12	K13	K14
L9	L10	L11	L12	L13	L14
M9	M10	M11	M12	M13	M14
N9	N10	N11	N12	N13	N14
P9	P10	P11	P12	P13	P14
Y3	Y20	AA2	AA21	AB1	AB22
		Not Conne	ected Pins		
A2	A6	A12	B11	B16	C2
D1	D4	D18	D19	E17	E19
G2	G22	L2	L19	M2	M21
R3	R20	U3	U18	V6	W4
W19	Y5	Y22	AA1	AA3	AA11
AA16	AB7	AB12	AB21	-	-
11/02/00					•

11/02/00

# **Revision History**

Version		
No.	Date	Description
2.0	09/18/00	Sectioned the Spartan-II Family data sheet into four modules. Corrected all known errors in the pinout tables.
2.1	10/04/00	Added notes requiring PWDN to be tied to V <sub>CCINT</sub> when unused.
2.2	11/02/00	Removed the Power Down feature.
2.3	03/05/01	Added notes on pinout tables for IRDY and TRDY.
2.4	04/30/01	Reinstated XC2S50 V <sub>CCO</sub> Bank 7, GND, and "not connected" pins missing in version 2.3.
2.5	09/03/03	Added caution about Not Connected Pins to XC2S30 pinout tables on page 6.

# The Spartan-II Family Data Sheet

DS001-1, Spartan-II 2.5V FPGA Family: Introduction and Ordering Information (Module 1)

DS001-2, Spartan-II 2.5V FPGA Family: Functional Description (Module 2)

DS001-3, Spartan-II 2.5V FPGA Family: DC and Switching Characteristics (Module 3)

DS001-4, Spartan-II 2.5V FPGA Family: Pinout Tables (Module 4)